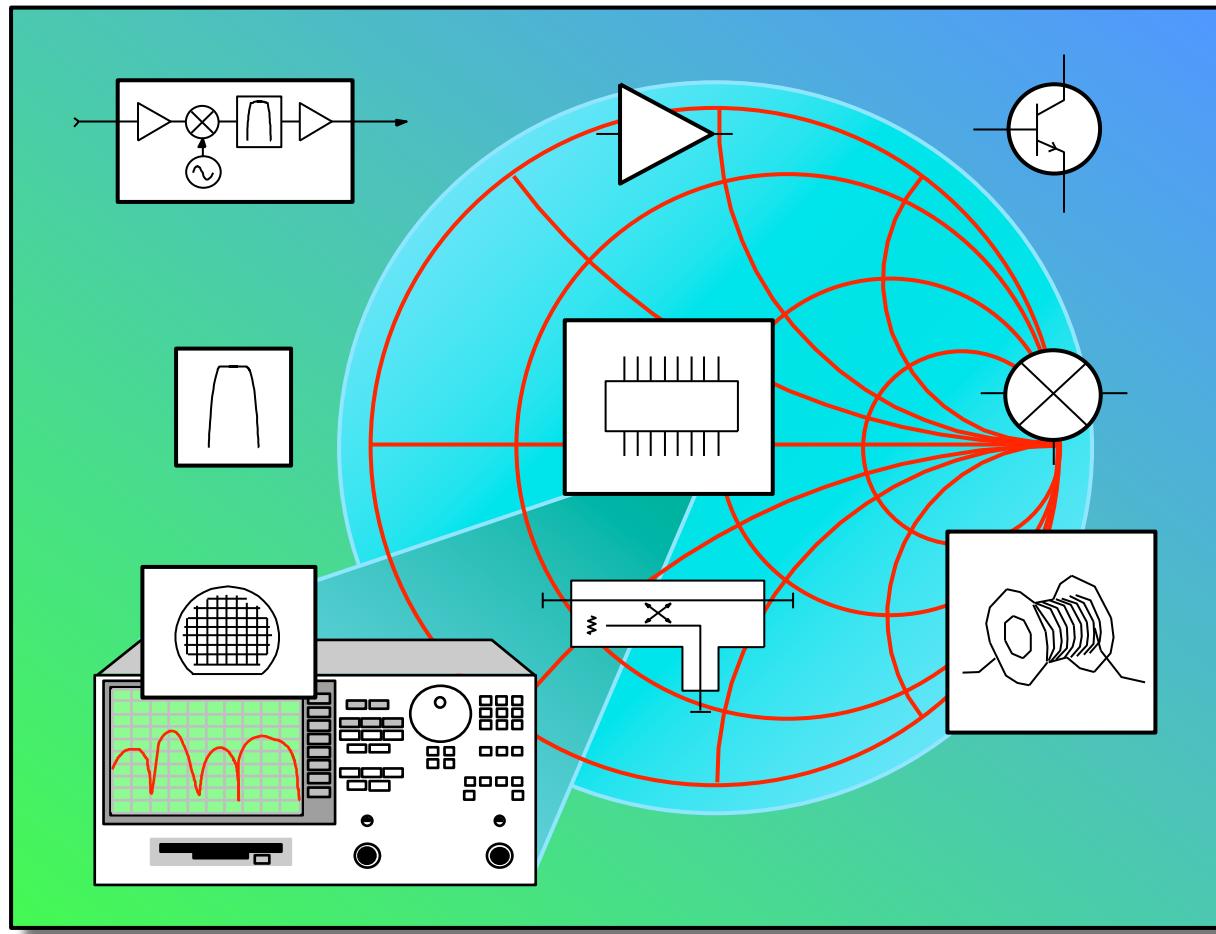
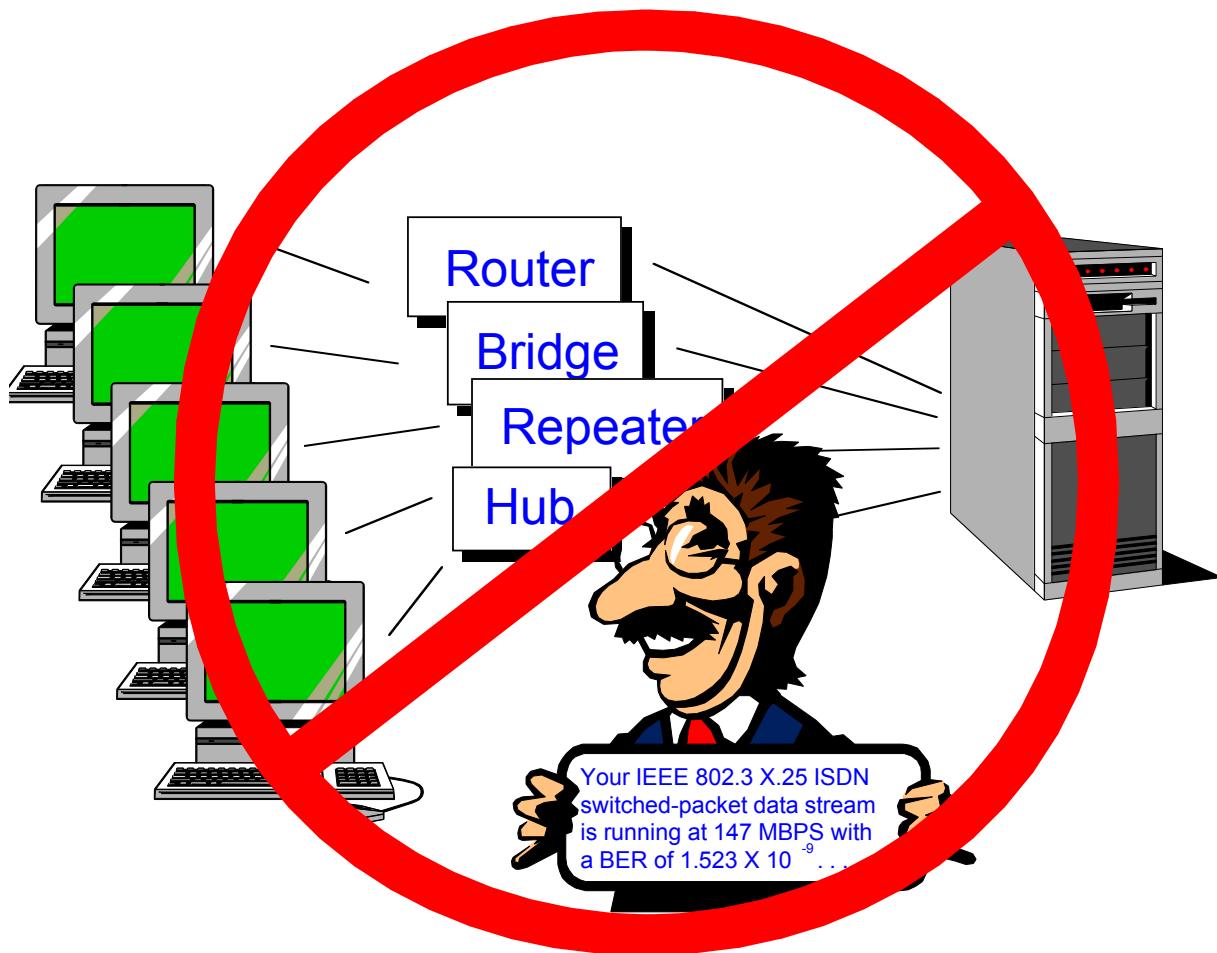


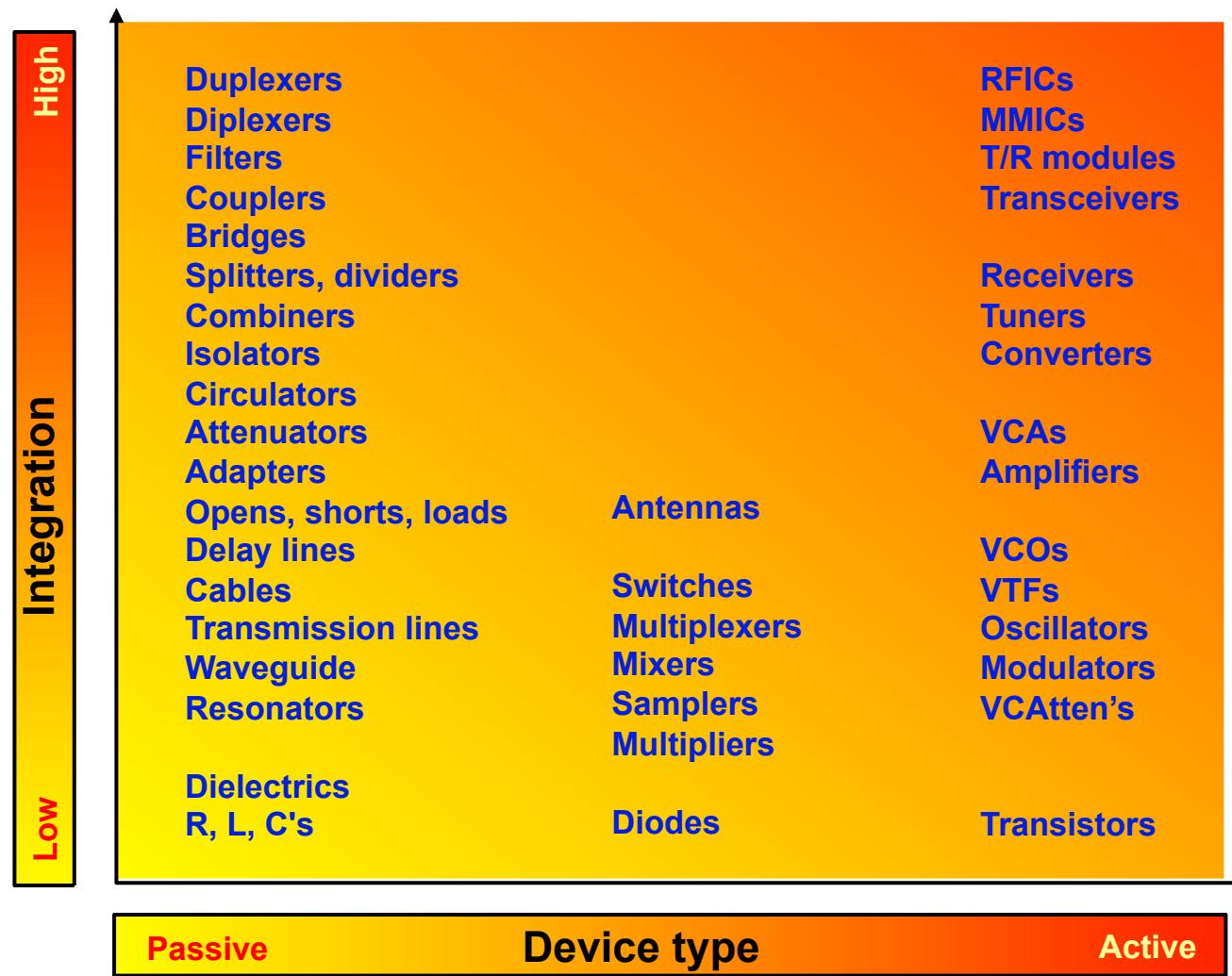
# Network Analyzer Basics



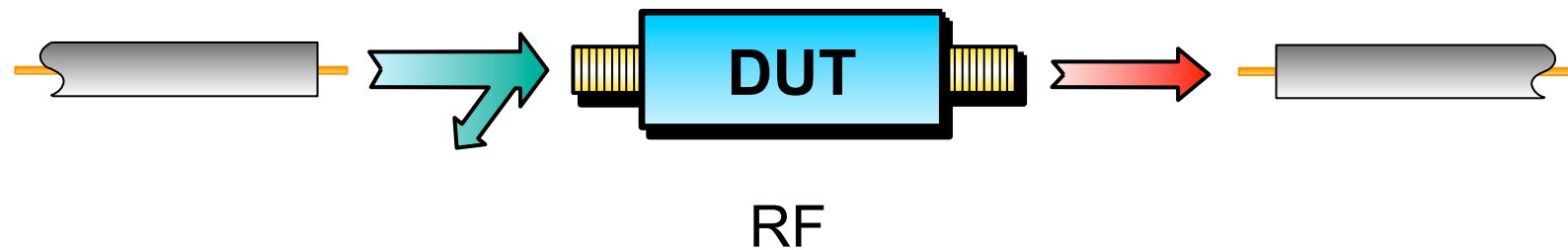
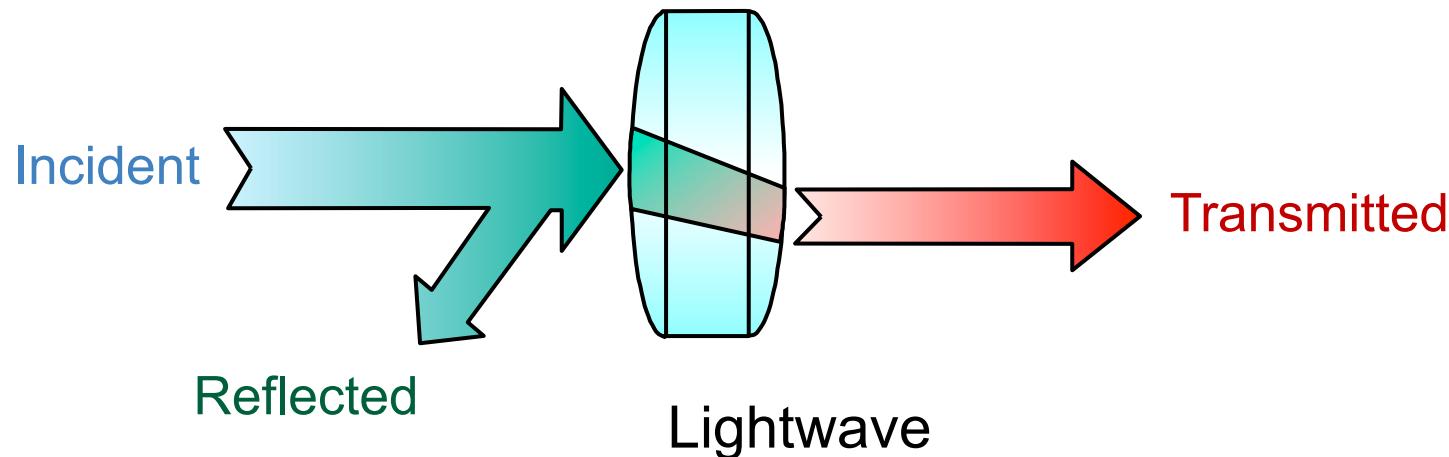
# Network Analysis is NOT....



# What Types of Devices are Tested?

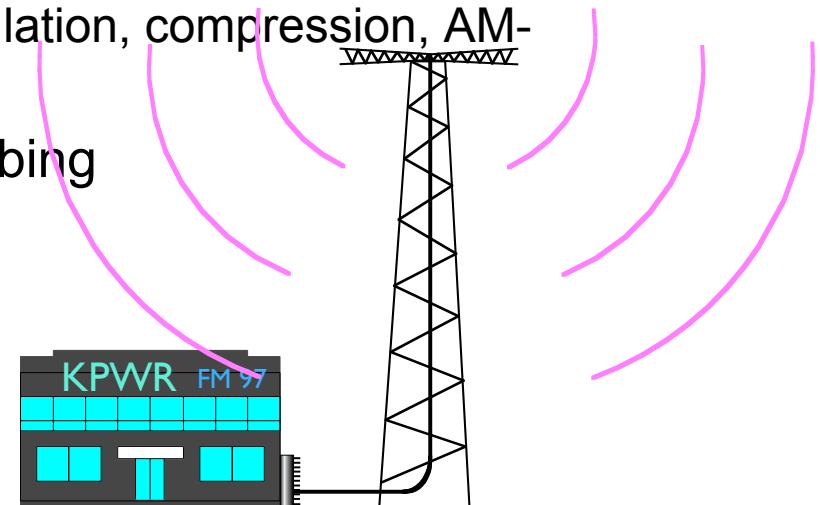


# Lightwave Analogy to RF Energy



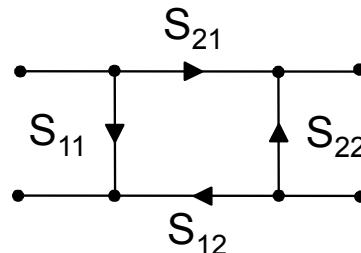
# Why Do We Need to Test Components?

- Verify specifications of “building blocks” for more complex RF systems
- Ensure distortionless transmission of communications signals
  - linear: constant amplitude, linear phase / constant group delay
  - nonlinear: harmonics, intermodulation, compression, AM-to-PM conversion
- Ensure good match when absorbing power (e.g., an antenna)

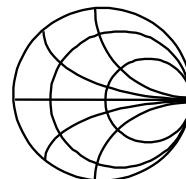


# The Need for Both Magnitude and Phase

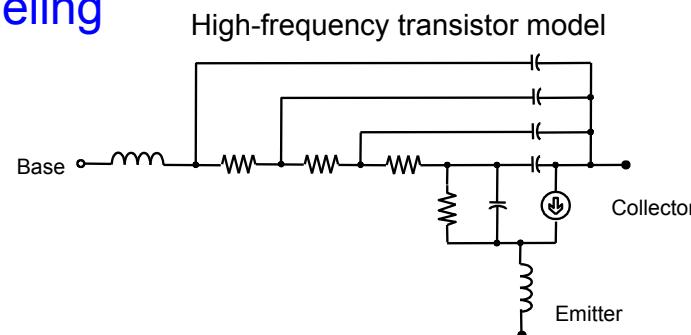
1. Complete characterization of linear networks



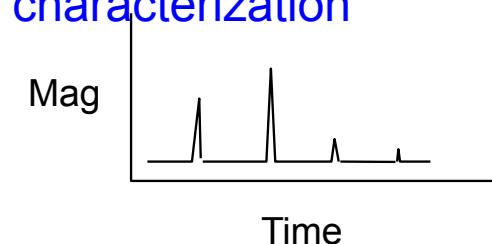
2. Complex impedance needed to design matching circuits



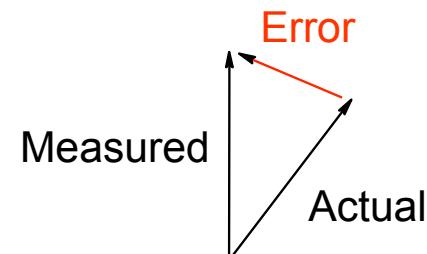
3. Complex values needed for device modeling



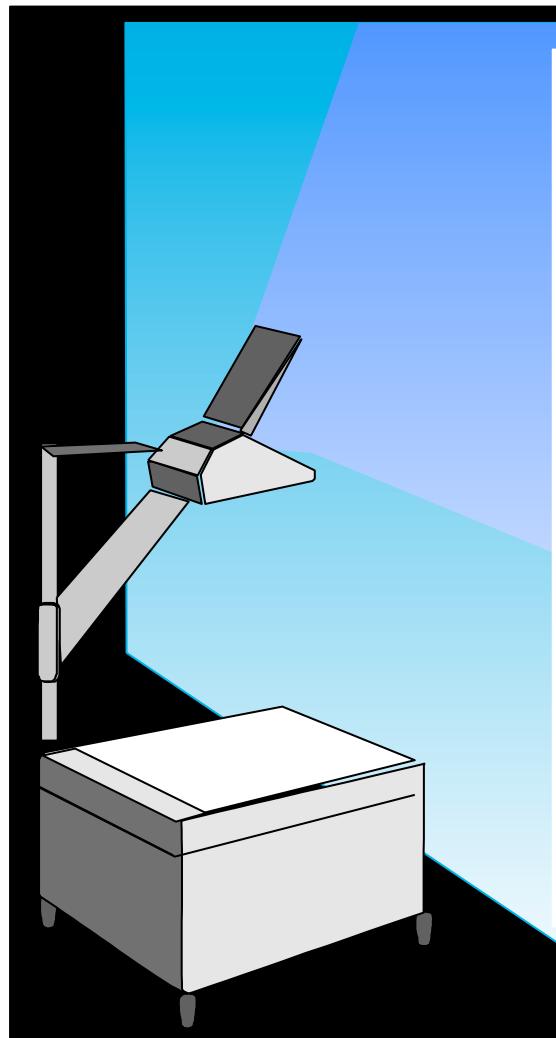
4. Time-domain characterization



5. Vector-error correction



# Agenda



- **What measurements do we make?**
  - Transmission-line basics
  - Reflection and transmission parameters
  - S-parameter definition
- **Network analyzer hardware**
  - Signal separation devices
  - Detection types
  - Dynamic range
  - T/R versus S-parameter test sets
- **Error models and calibration**
  - Types of measurement error
  - One- and two-port models
  - Error-correction choices
  - Basic uncertainty calculations
- **Example measurements**
- **Appendix**



# Transmission Line Basics

## ***Low frequencies***

- wavelengths  $\gg$  wire length
- current ( $I$ ) travels down wires easily for efficient power transmission
- measured voltage and current not dependent on position along wire



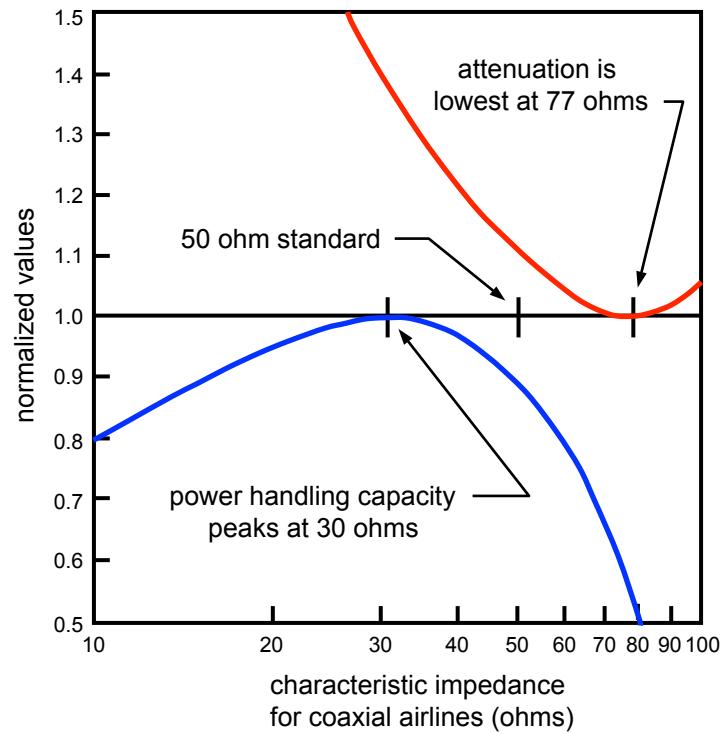
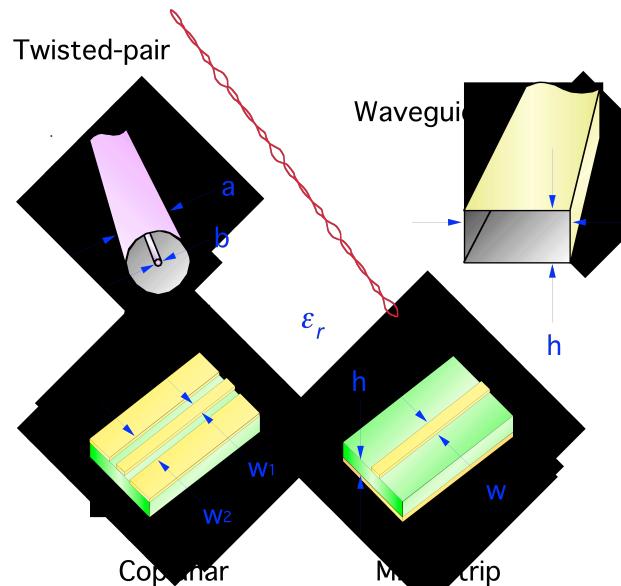
## ***High frequencies***

- wavelength  $\approx$  or  $\ll$  length of transmission medium
- need transmission lines for efficient power transmission
- matching to characteristic impedance ( $Z_0$ ) is very important for low reflection and maximum power transfer
- measured envelope voltage dependent on position along line

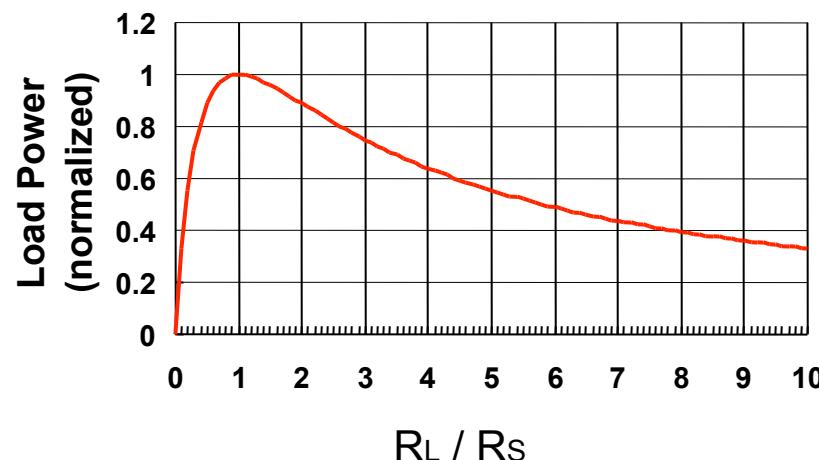
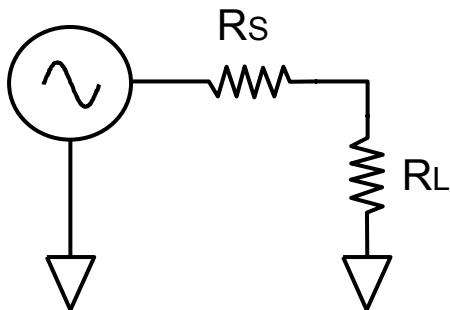


# Transmission line $Z_0$

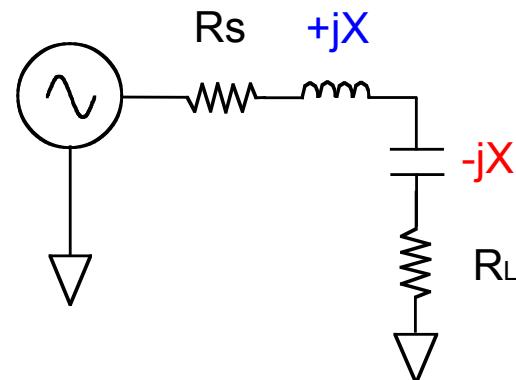
- $Z_0$  determines relationship between voltage and current waves
- $Z_0$  is a function of physical dimensions and  $\epsilon_r$
- $Z_0$  is usually a real impedance (e.g. 50 or 75 ohms)



# Power Transfer Efficiency

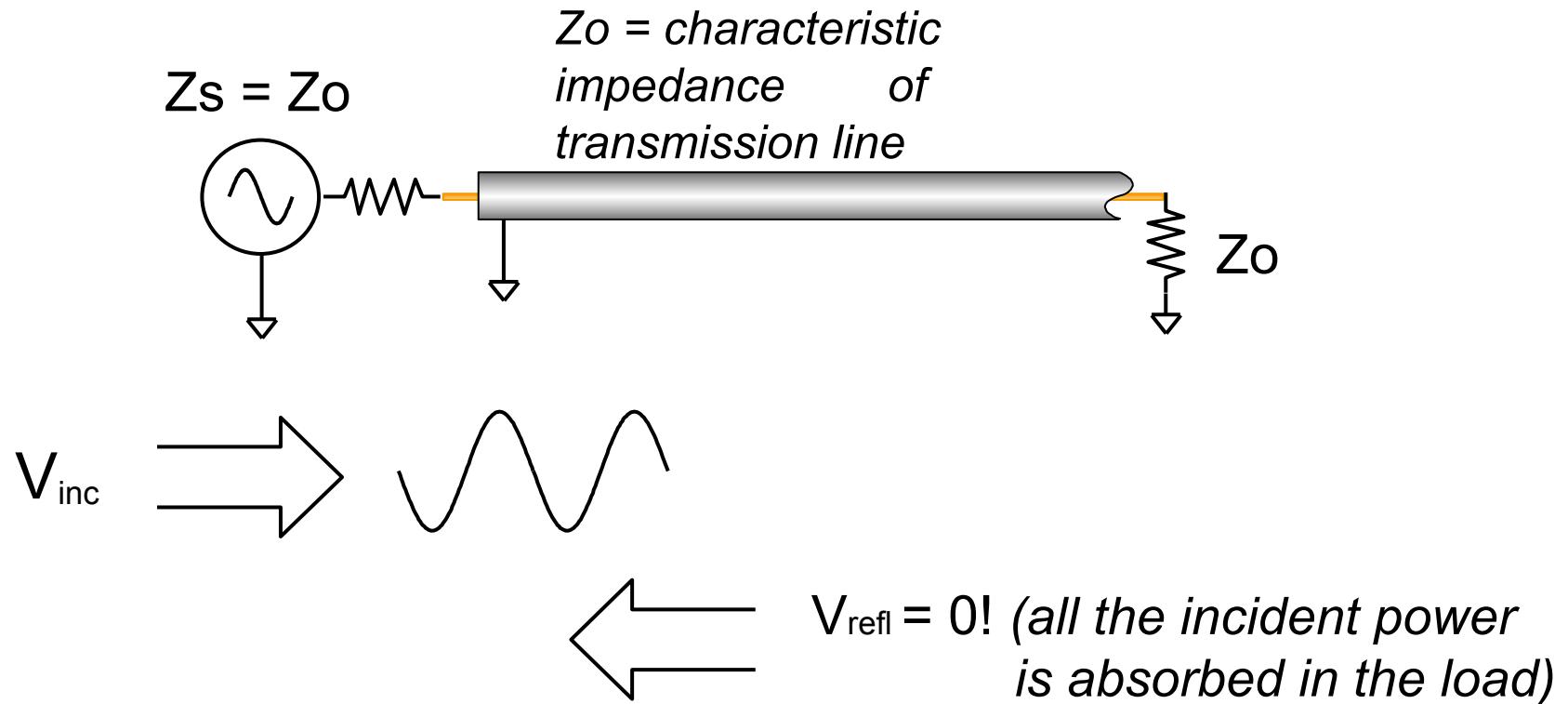


For complex impedances, maximum power transfer occurs when  $Z_L = Z_s^*$  (conjugate match)



**Maximum power is transferred when  $R_L = R_s$**

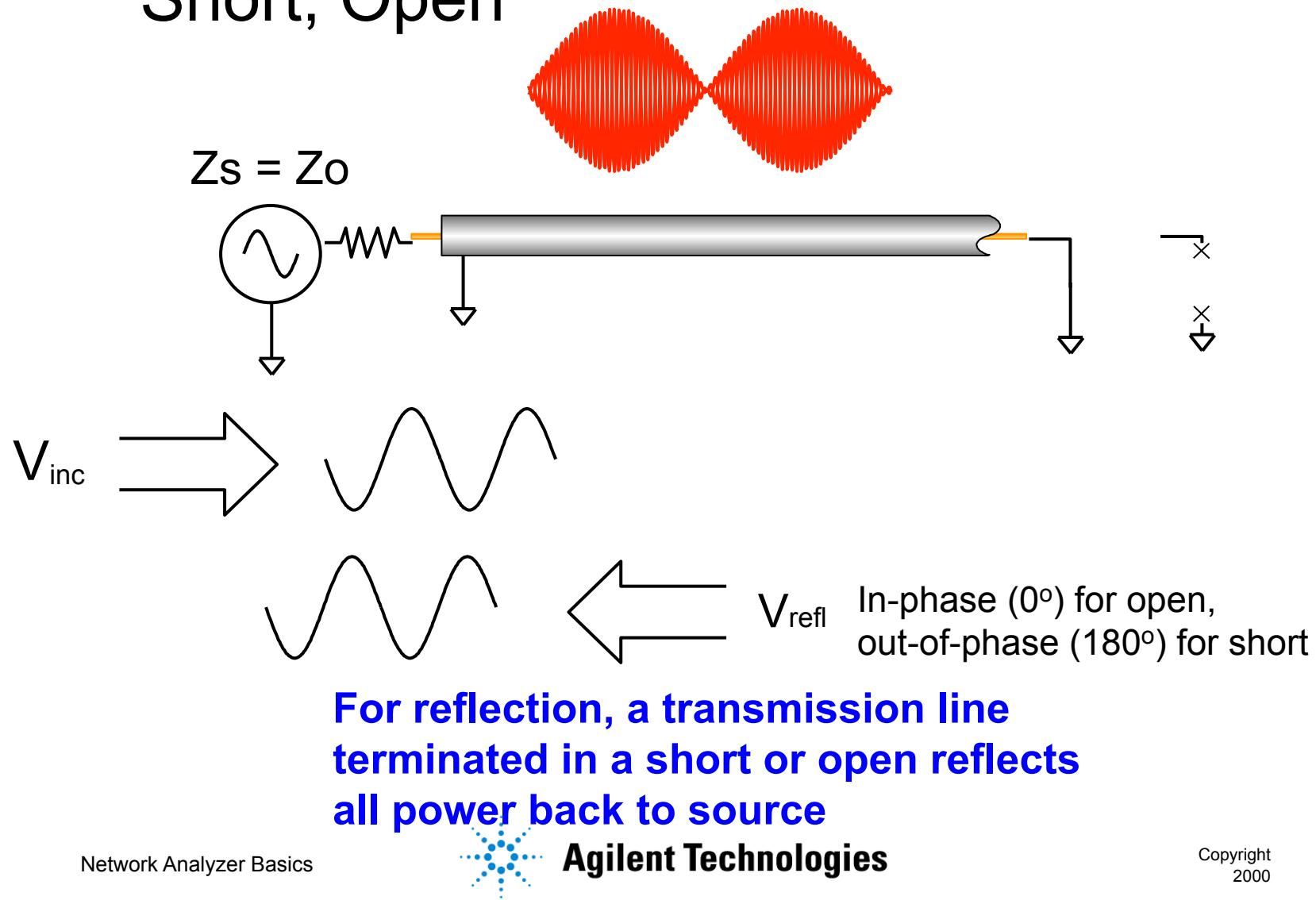
# Transmission Line Terminated with $Z_0$



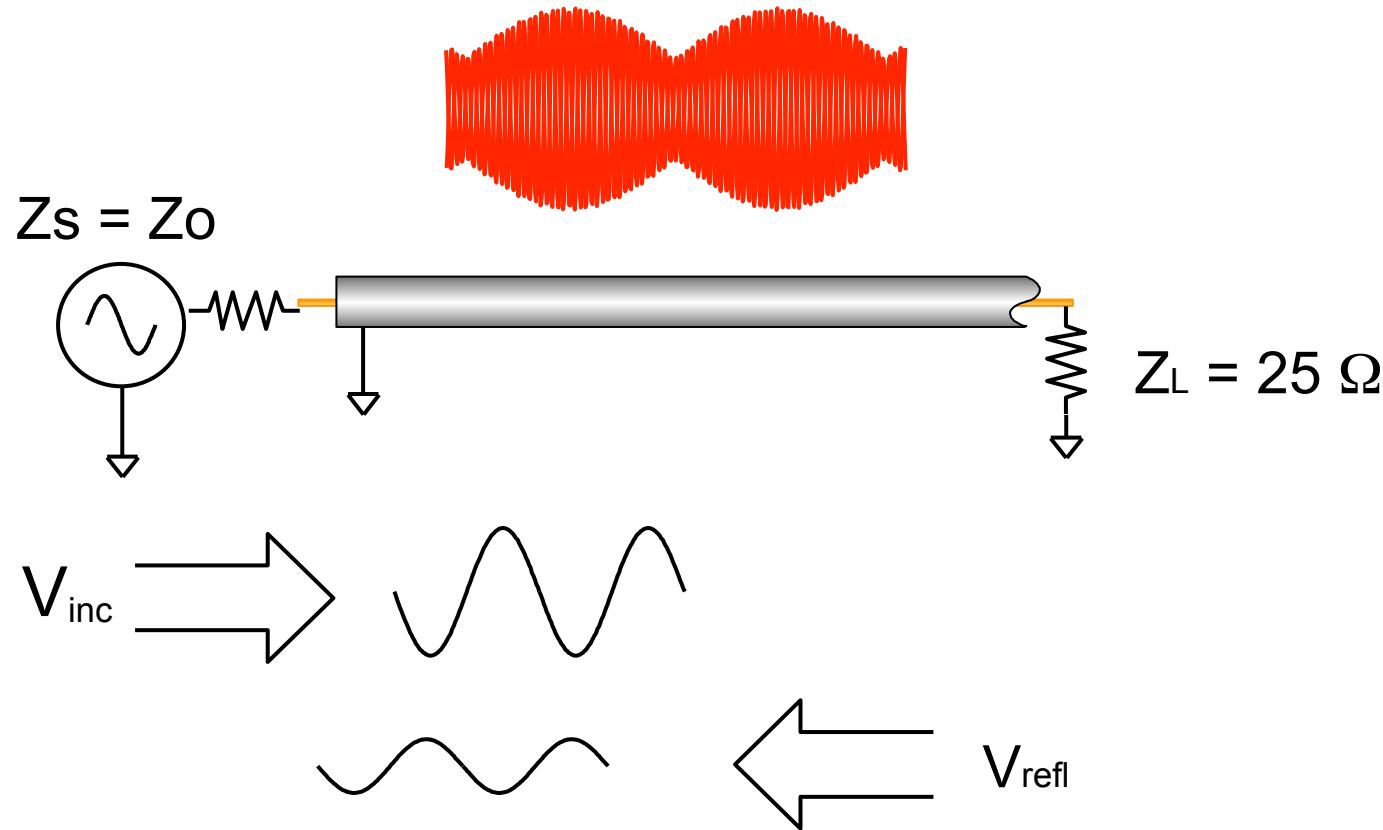
**For reflection, a transmission line terminated in  $Z_0$  behaves like an infinitely long transmission line**



# Transmission Line Terminated with Short, Open



# Transmission Line Terminated with $25 \Omega$

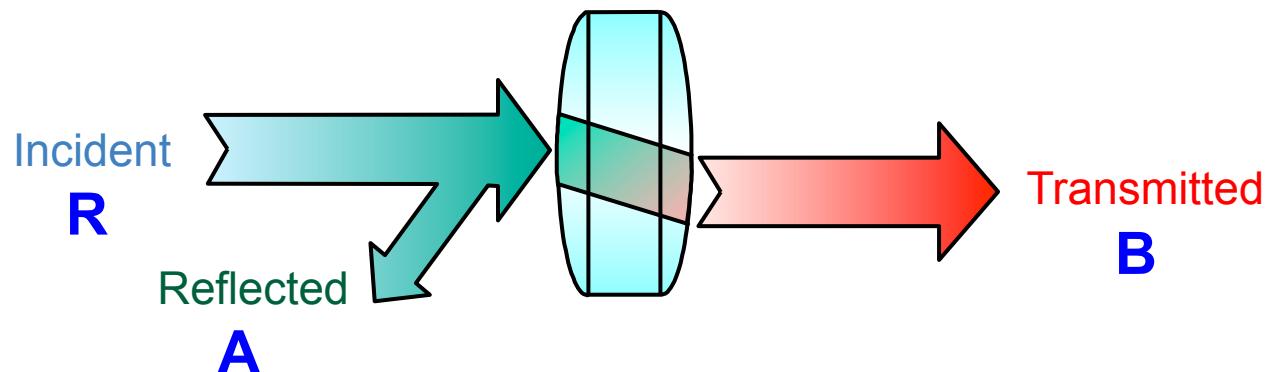


**Standing wave pattern  
does not go to zero as  
with short or open**



**Agilent Technologies**

# High-Frequency Device Characterization



## REFLECTION

$$\frac{\text{Reflected}}{\text{Incident}} = \frac{A}{R}$$

SWR  
S-Parameters  
 $S_{11}, S_{22}$   
Reflection Coefficient  
 $\Gamma, \rho$   
Return Loss  
Impedance, Admittance  
 $R+jX, G+jB$

## TRANSMISSION

$$\frac{\text{Transmitted}}{\text{Incident}} = \frac{B}{R}$$

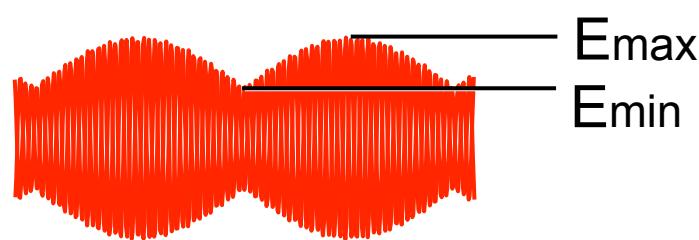
Gain / Loss  
S-Parameters  
 $S_{21}, S_{12}$   
Transmission Coefficient  
 $T, \tau$   
Insertion Phase  
Group Delay



# Reflection Parameters

**Reflection Coefficient**  $\Gamma = \frac{V_{\text{reflected}}}{V_{\text{incident}}} = \rho \angle \Phi = \frac{Z_L - Z_0}{Z_L + Z_0}$

**Return loss** =  $-20 \log(\rho)$ ,  $\rho = |\Gamma|$



**Voltage Standing Wave Ratio**

$$\text{VSWR} = \frac{E_{\text{max}}}{E_{\text{min}}} = \frac{1 + \rho}{1 - \rho}$$

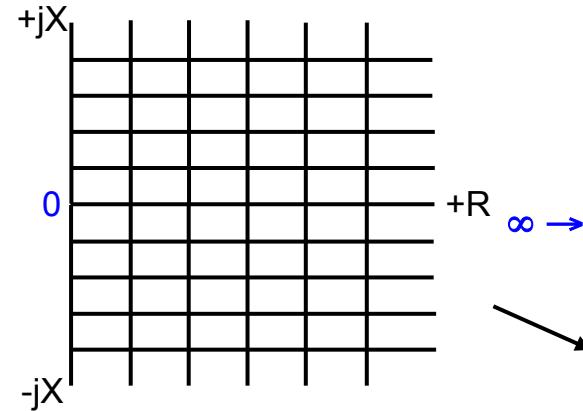
**No reflection**  
 $(Z_L = Z_0)$

0	$\rho$	1
$\infty$ dB	RL	0 dB
1	VSWR	$\infty$

**Full reflection**  
 $(Z_L = \text{open, short})$

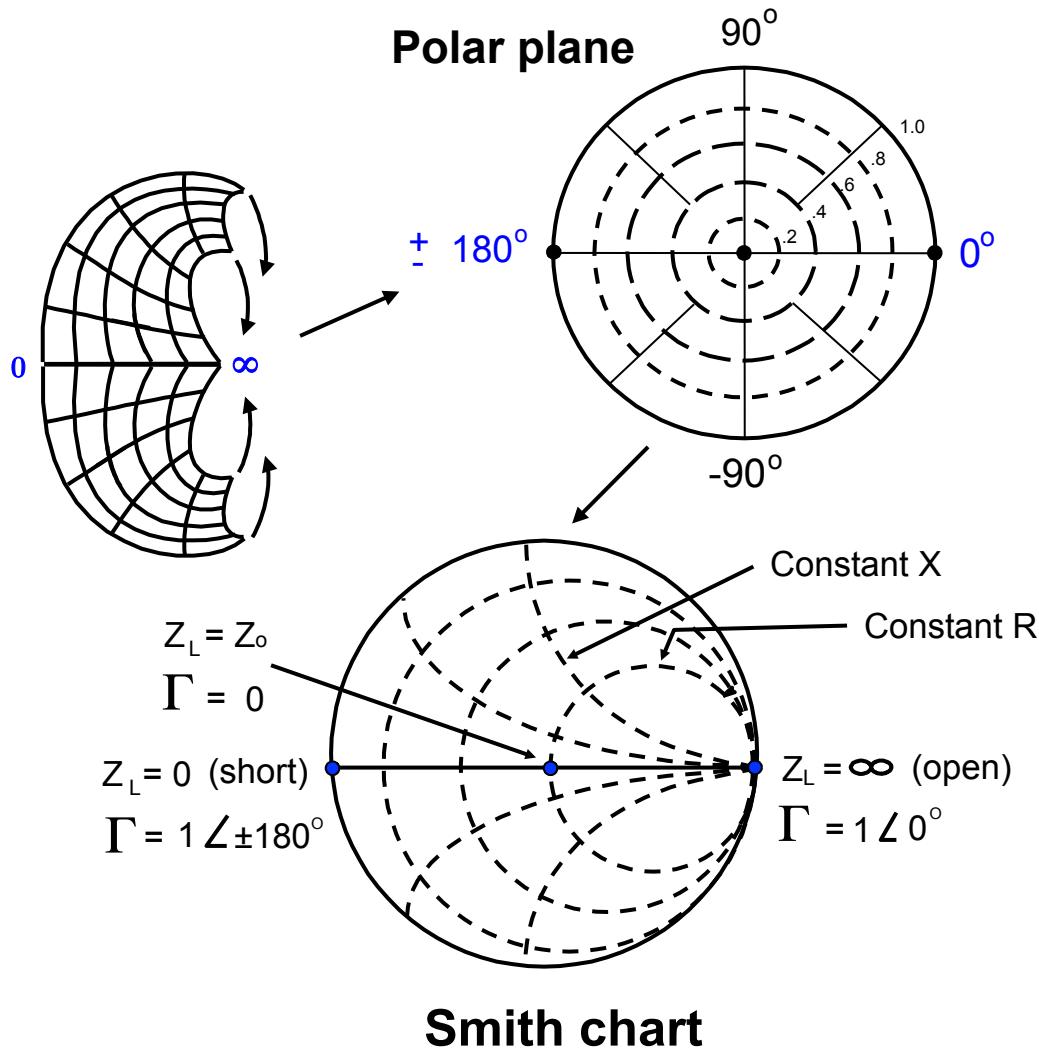


# Smith Chart Review



Rectilinear impedance plane

**Smith Chart maps  
rectilinear  
impedance  
plane onto polar  
plane**



Smith chart



# Transmission Parameters



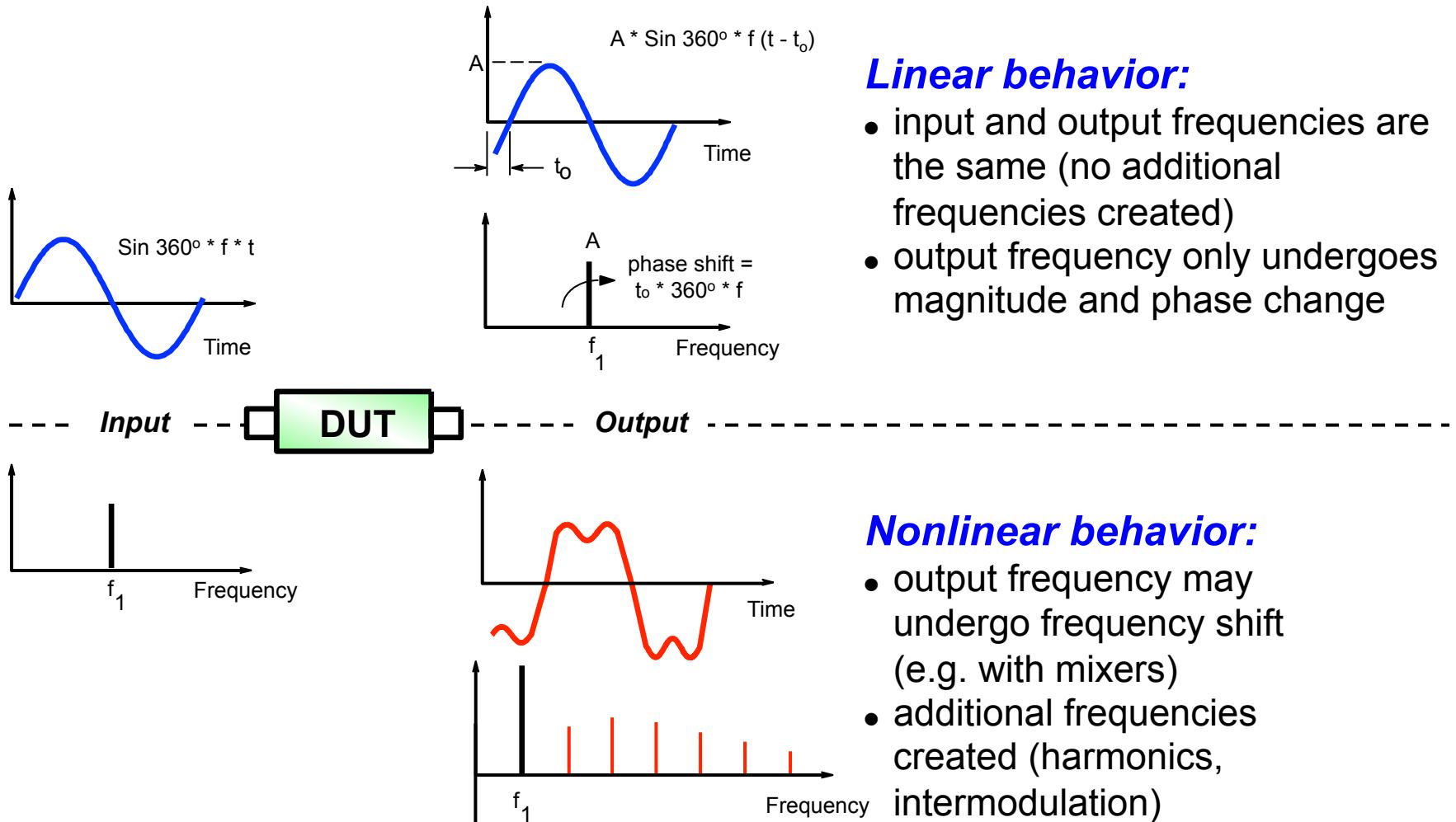
$$\text{Transmission Coefficient} = T = \frac{V_{\text{Transmitted}}}{V_{\text{Incident}}} = \tau \angle \phi$$

$$\text{Insertion Loss (dB)} = -20 \log \left| \frac{V_{\text{Trans}}}{V_{\text{Inc}}} \right| = -20 \log \tau$$

$$\text{Gain (dB)} = 20 \log \left| \frac{V_{\text{Trans}}}{V_{\text{Inc}}} \right| = 20 \log \tau$$



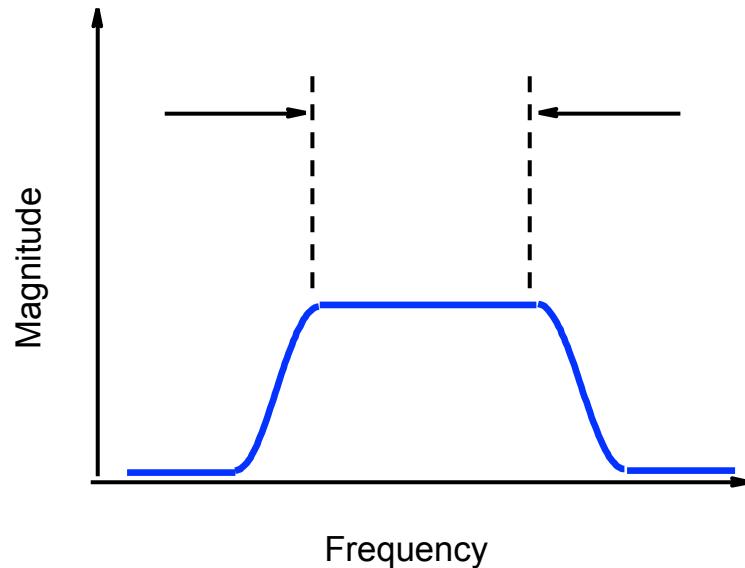
# Linear Versus Nonlinear Behavior



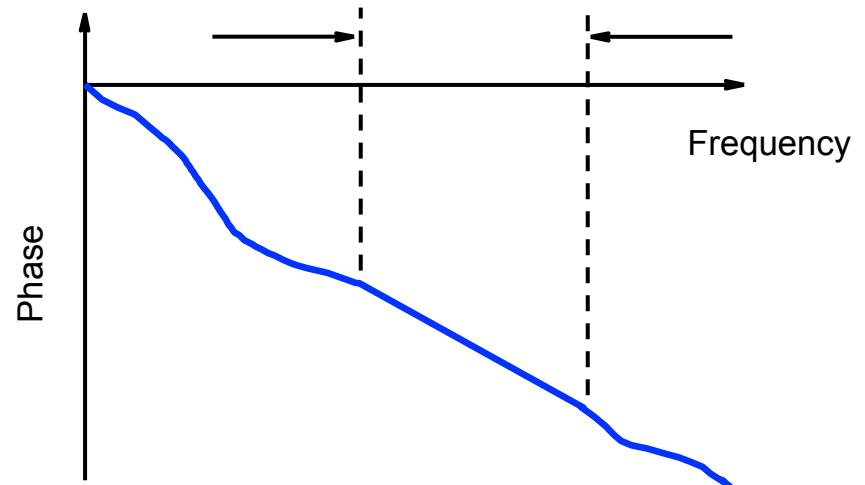
# Criteria for Distortionless Transmission

## ***Linear Networks***

**Constant amplitude** over  
bandwidth of interest

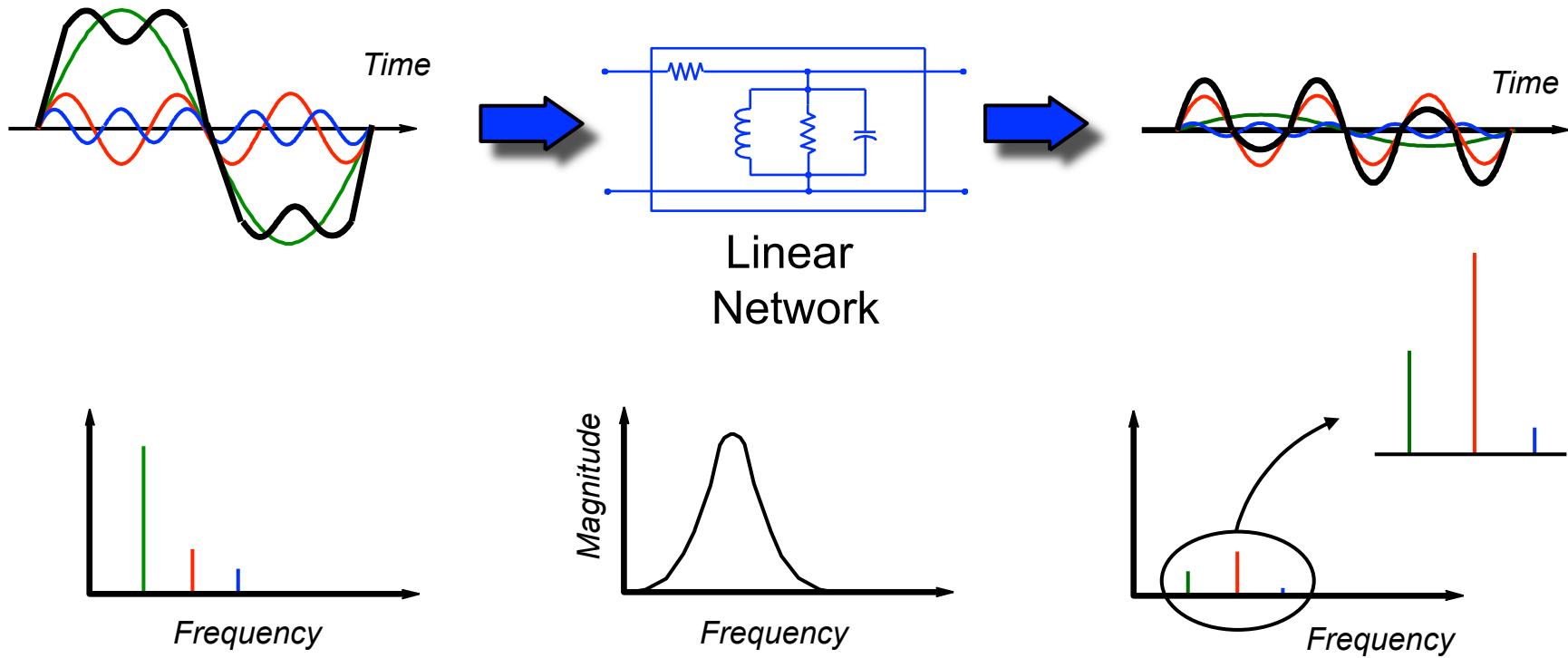


**Linear phase** over  
bandwidth of interest



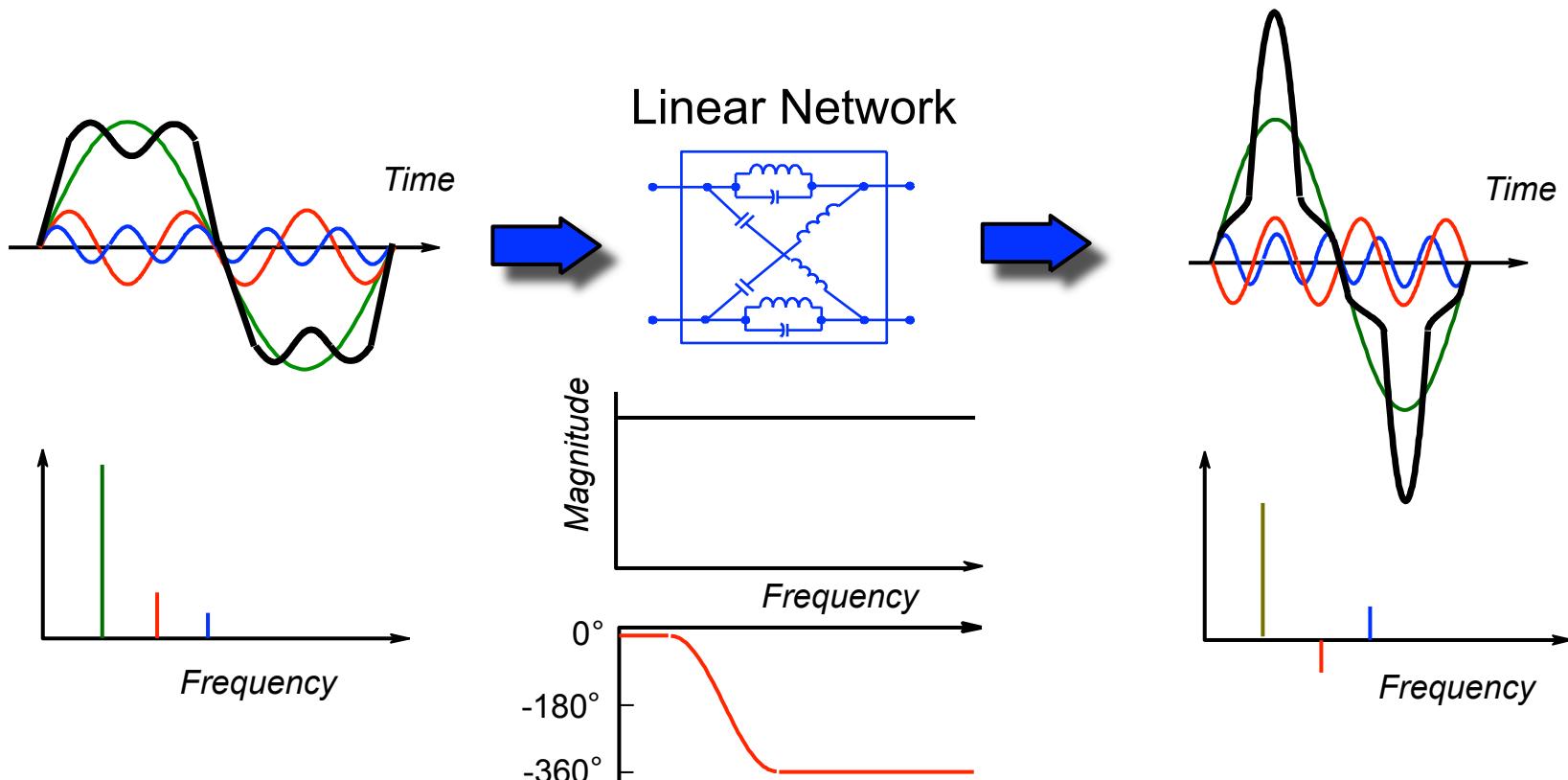
# Magnitude Variation with Frequency

$$F(t) = \sin \omega t + \frac{1}{3} \sin 3\omega t + \frac{1}{5} \sin 5\omega t$$



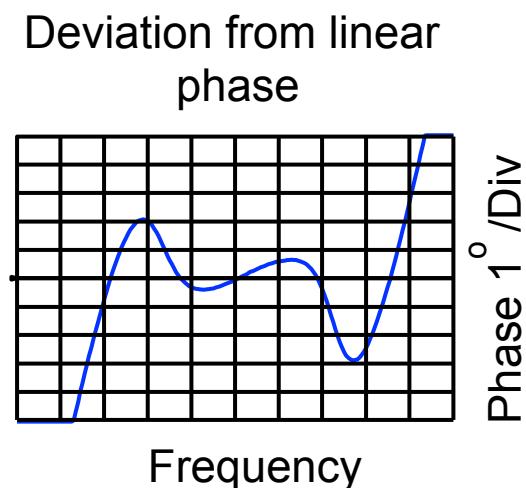
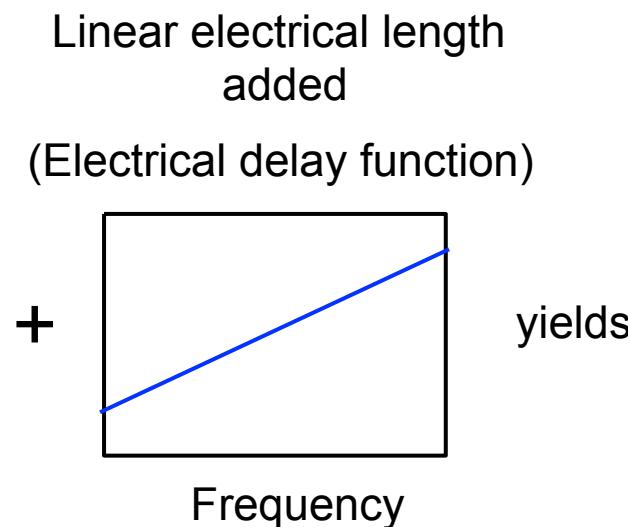
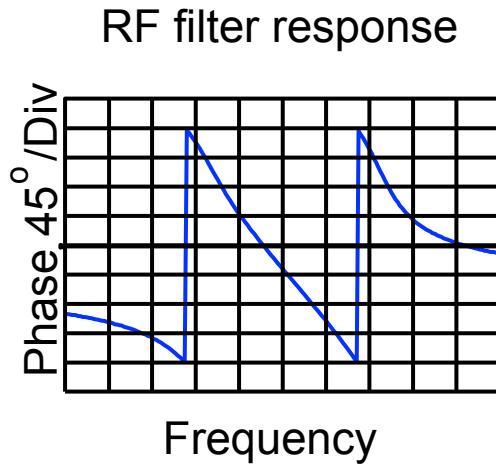
# Phase Variation with Frequency

$$F(t) = \sin \omega t + \frac{1}{3} \sin 3\omega t + \frac{1}{5} \sin 5\omega t$$



# Deviation from Linear Phase

*Use electrical delay to  
remove linear portion of  
phase response*

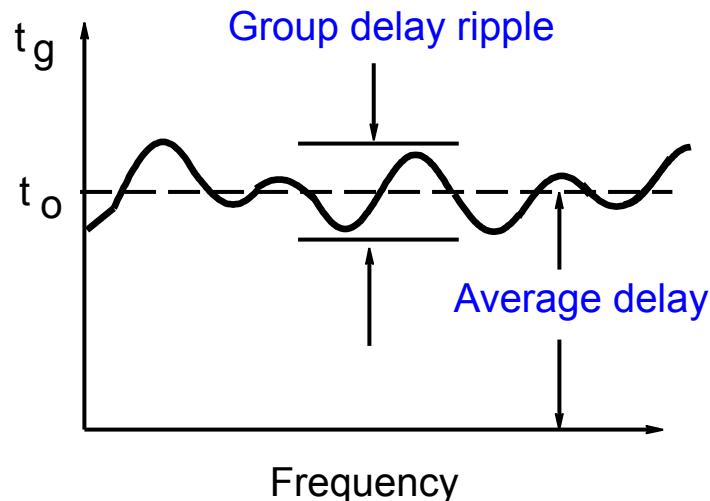
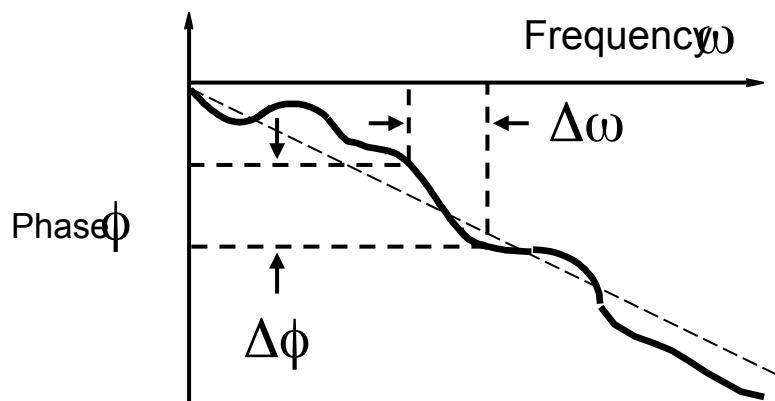


Low resolution

High resolution



# Group Delay



Group Delay ( $t_g$ ) =

$$\frac{-d\phi}{d\omega} = \frac{-1}{360^\circ} * \frac{d\phi}{df}$$

$\phi$  in radians

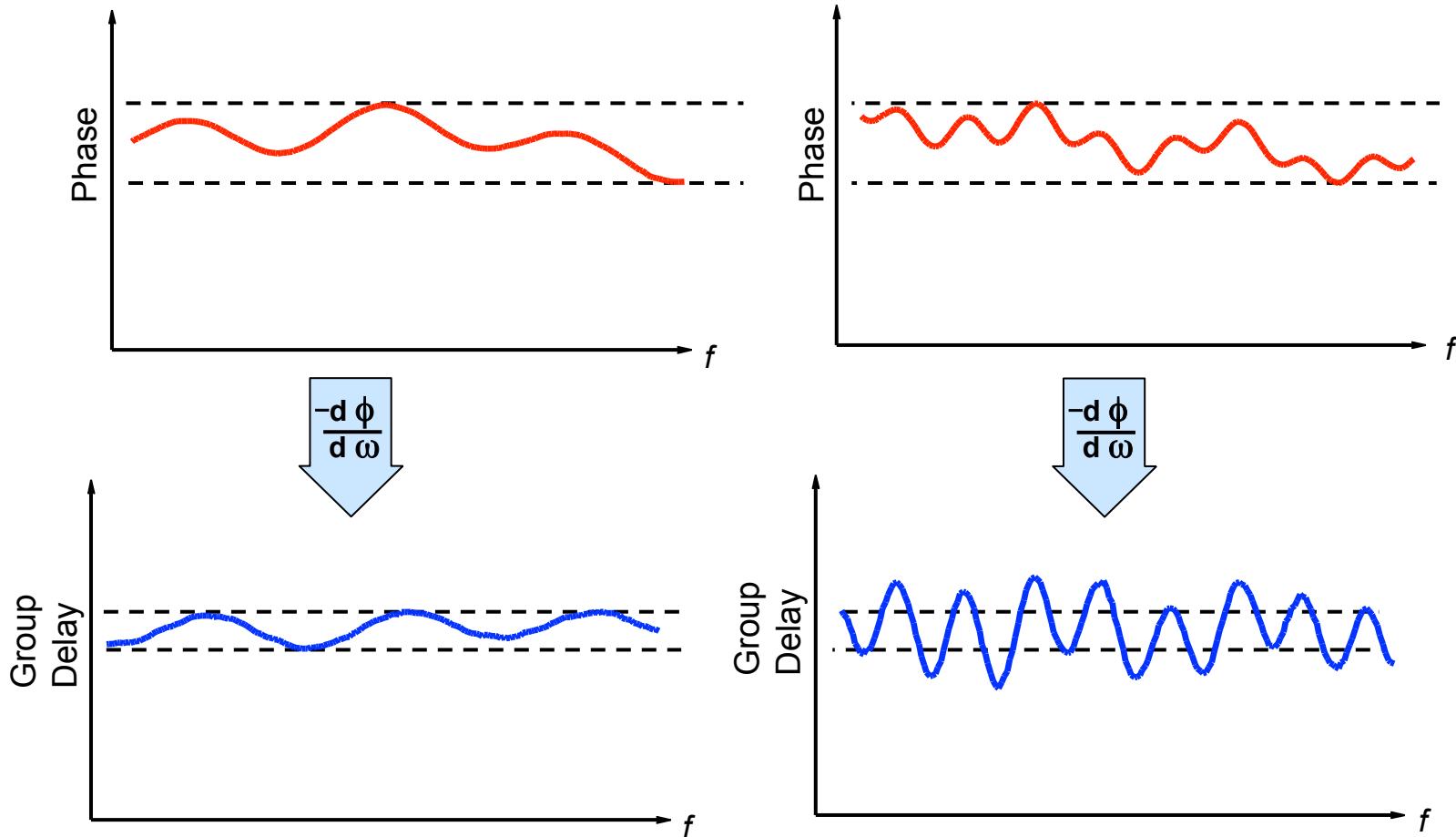
$\omega$  in radians/sec

$\phi$  in degrees

f in Hertz ( $\omega = 2\pi f$ )

- group-delay ripple indicates phase distortion
- average delay indicates electrical length of DUT
- aperture of measurement is very important

# Why Measure Group Delay?



Same p-p phase ripple can result in different group delay



# Characterizing Unknown Devices

## ***Using parameters ( $H$ , $Y$ , $Z$ , $S$ ) to characterize devices:***

- gives linear behavioral model of our device
- measure parameters (e.g. voltage and current) versus frequency under various source and load conditions (e.g. short and open circuits)
- compute device parameters from measured data
- predict circuit performance under any source and load conditions

### **$H$ -parameters**

$$V_1 = h_{11}I_1 + h_{12}V_2$$

$$I_2 = h_{21}I_1 + h_{22}V_2$$

### **$Y$ -parameters**

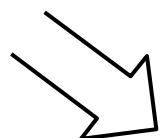
$$I_1 = y_{11}V_1 + y_{12}V_2$$

$$I_2 = y_{21}V_1 + y_{22}V_2$$

### **$Z$ -parameters**

$$V_1 = z_{11}I_1 + z_{12}I_2$$

$$V_2 = z_{21}I_1 + z_{22}I_2$$

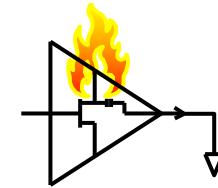


$$h_{11} = \left. \frac{V_1}{I_1} \right|_{V_2=0} \quad (\text{requires } \mathbf{short\ circuit})$$

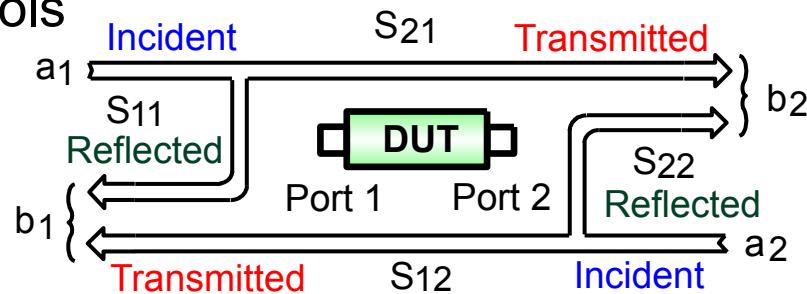
$$h_{12} = \left. \frac{V_1}{V_2} \right|_{I_1=0} \quad (\text{requires } \mathbf{open\ circuit})$$



# Why Use S-Parameters?



- relatively easy to **obtain** at high frequencies
  - measure voltage traveling waves with a vector network analyzer
  - don't need shorts/opens which can cause active devices to oscillate or self-destruct
- relate to **familiar** measurements (gain, loss, reflection coefficient ...)
- can **cascade** S-parameters of multiple devices to predict system performance
- can **compute** H, Y, or Z parameters from S-parameters if desired
- can easily import and use S-parameter files in our **electronic-simulation** tools

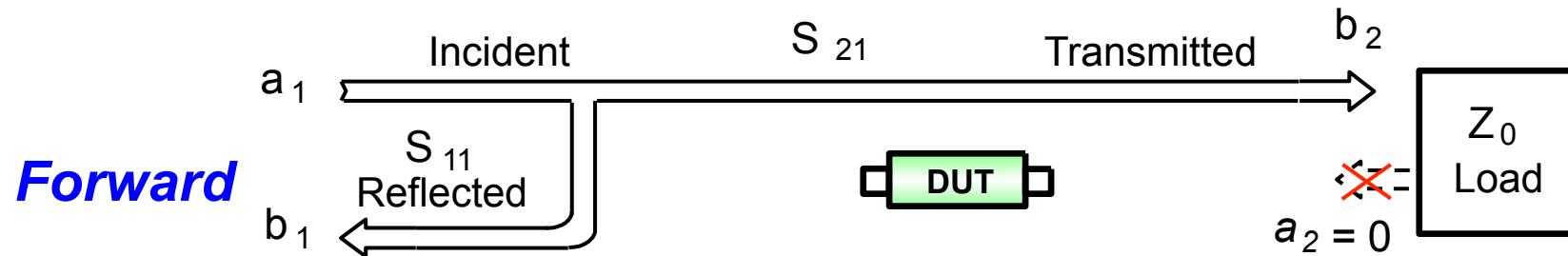


$$b_1 = S_{11}a_1 + S_{12}a_2$$

$$b_2 = S_{21}a_1 + S_{22}a_2$$



# Measuring S-Parameters

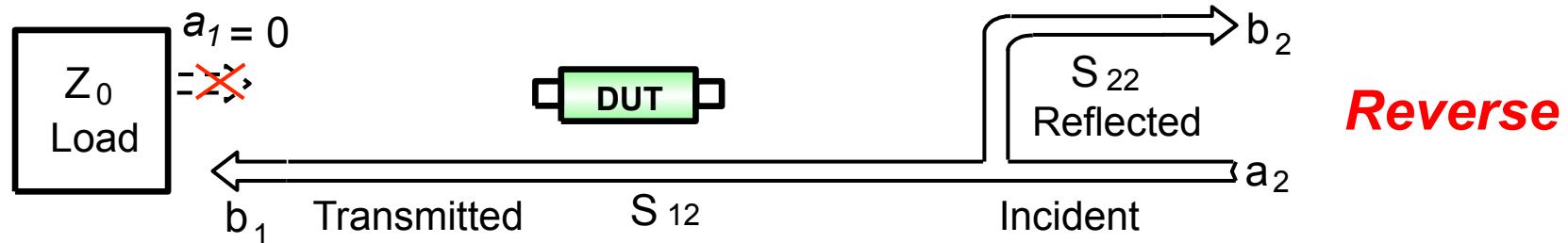


$$S_{11} = \frac{\text{Reflected}}{\text{Incident}} = \frac{b_1}{a_1} \quad | \quad a_2 = 0$$

$$S_{21} = \frac{\text{Transmitted}}{\text{Incident}} = \frac{b_2}{a_1} \quad | \quad a_2 = 0$$

$$S_{22} = \frac{\text{Reflected}}{\text{Incident}} = \frac{b_2}{a_2} \quad | \quad a_1 = 0$$

$$S_{12} = \frac{\text{Transmitted}}{\text{Incident}} = \frac{b_1}{a_2} \quad | \quad a_1 = 0$$



# Equating S-Parameters with Common Measurement Terms

S11 = forward reflection coefficient (***input match***)

S22 = reverse reflection coefficient (***output match***)

S21 = forward transmission coefficient (***gain or loss***)

S12 = reverse transmission coefficient (***isolation***)

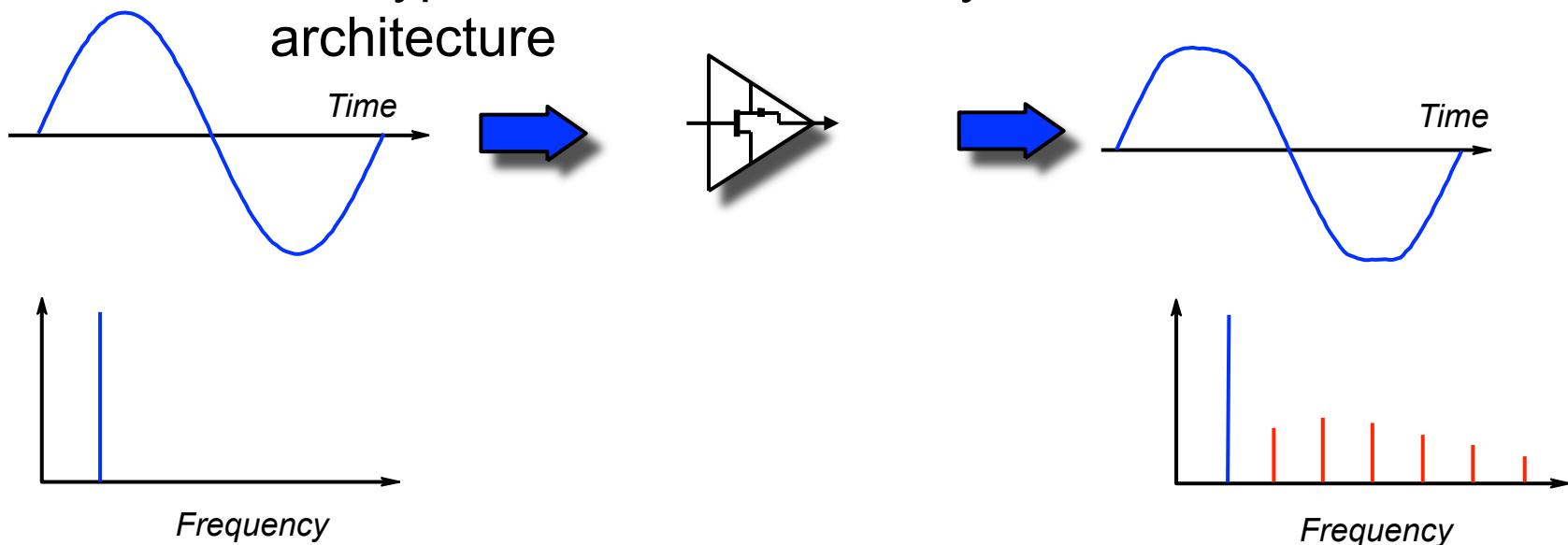
***Remember, S-parameters are inherently complex, linear quantities -- however, we often express them in a log-magnitude format***



# Criteria for Distortionless Transmission

## **Nonlinear Networks**

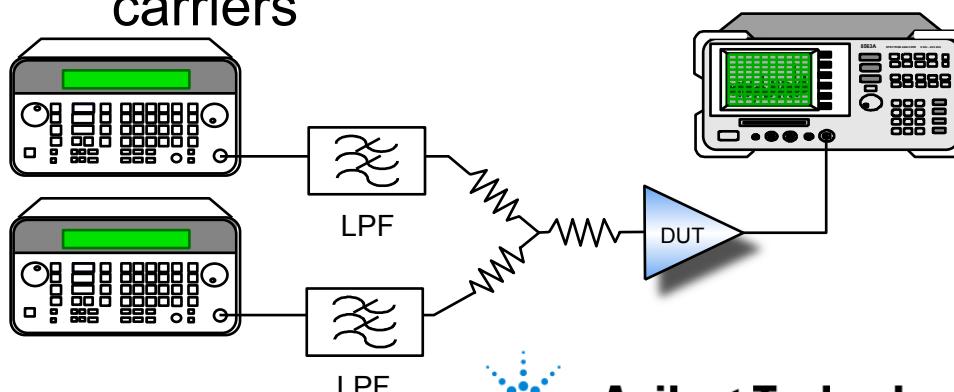
- Saturation, crossover, intermodulation, and other nonlinear effects can cause signal distortion
- Effect on system depends on amount and type of distortion and system architecture



# Measuring Nonlinear Behavior

Most common measurements:

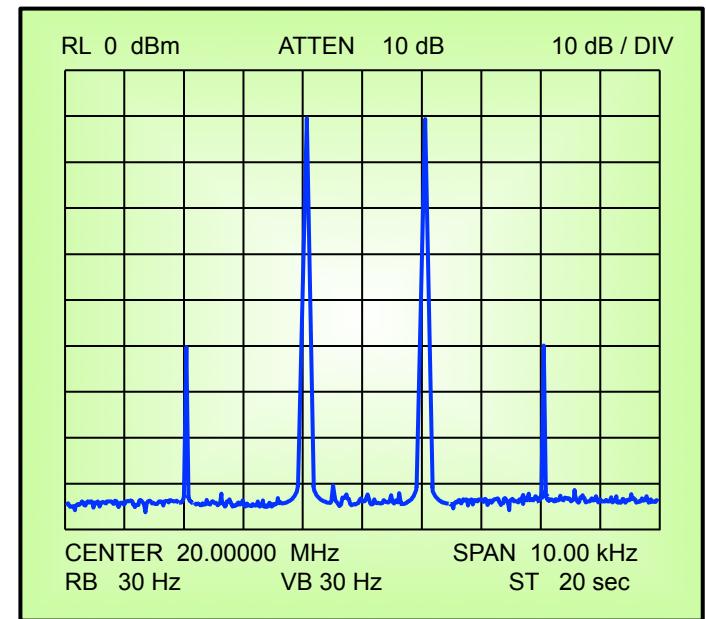
- using a ***network analyzer*** and power sweeps
  - gain compression
  - AM to PM conversion
- using a ***spectrum analyzer*** + source(s)
  - harmonics, particularly second and third
  - intermodulation products resulting from two or more RF carriers



Network Analyzer Basics

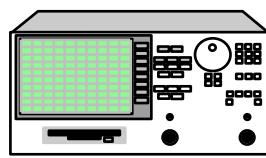
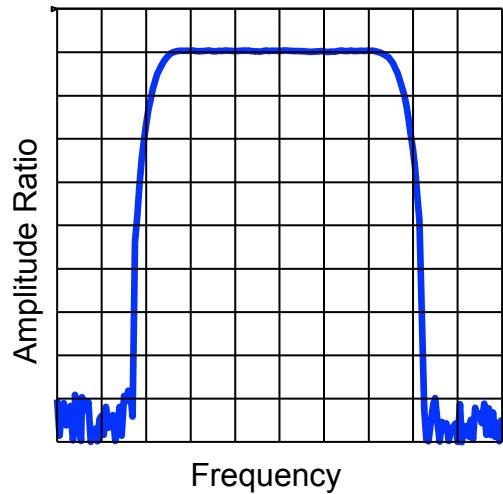


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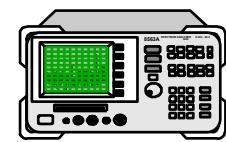
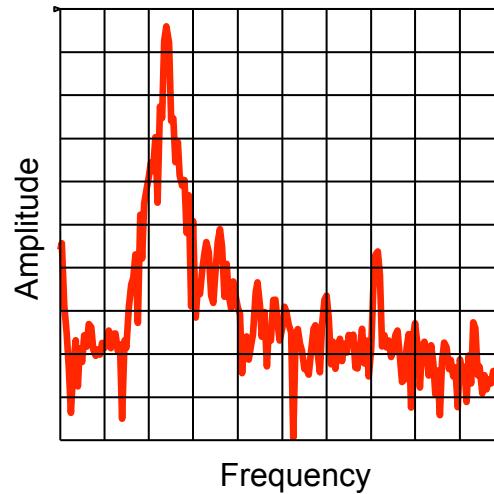


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2000

# What is the Difference Between *Network* and *Spectrum* Analyzers?



Measures  
known  
signal



Measures  
unknown  
signals

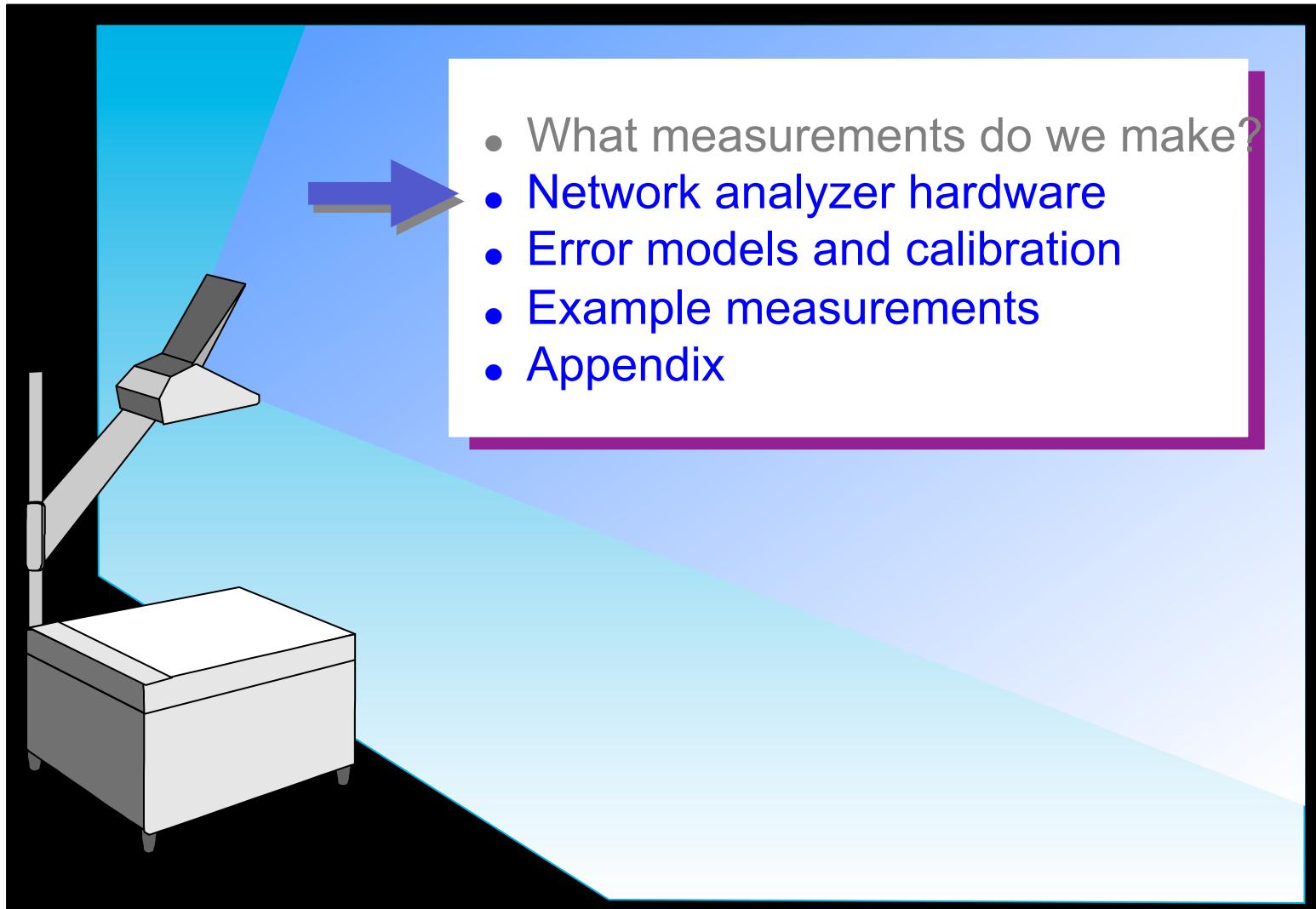
## Network analyzers:

- measure components, devices, circuits, sub-assemblies
- contain source and receiver
- display ratioed amplitude and phase (frequency or power sweeps)
- offer advanced error correction

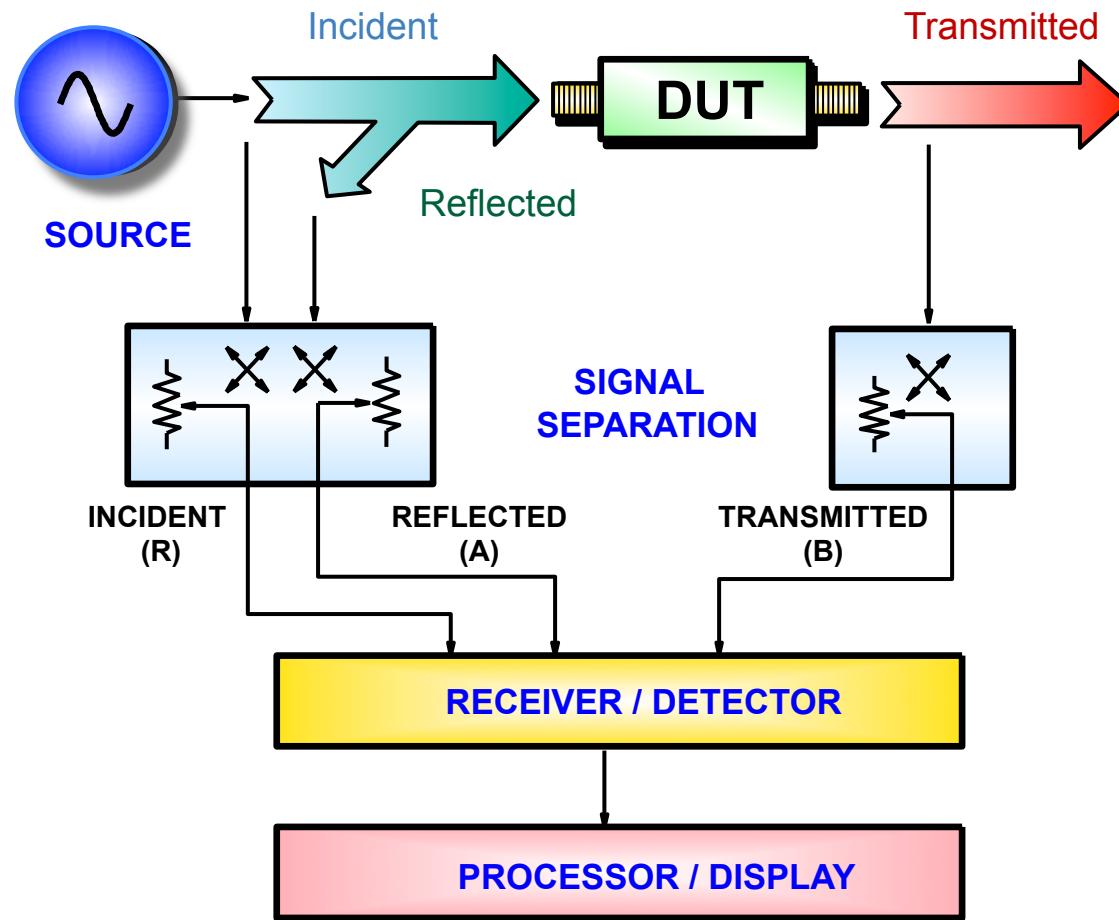
## Spectrum analyzers:

- measure signal amplitude characteristics (carrier level, sidebands, harmonics...)
- can demodulate (& measure) complex signals
- are receivers only (single channel)
- can be used for scalar component test (*no phase*) with tracking gen. or ext. source(s)

# Agenda

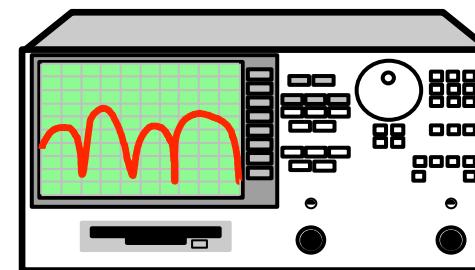
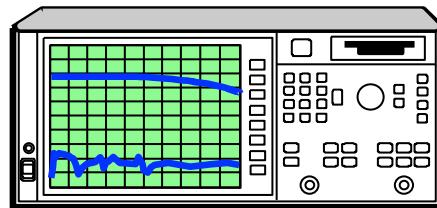
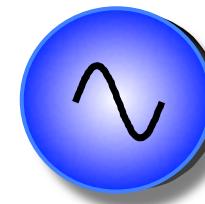


# Generalized Network Analyzer Block Diagram



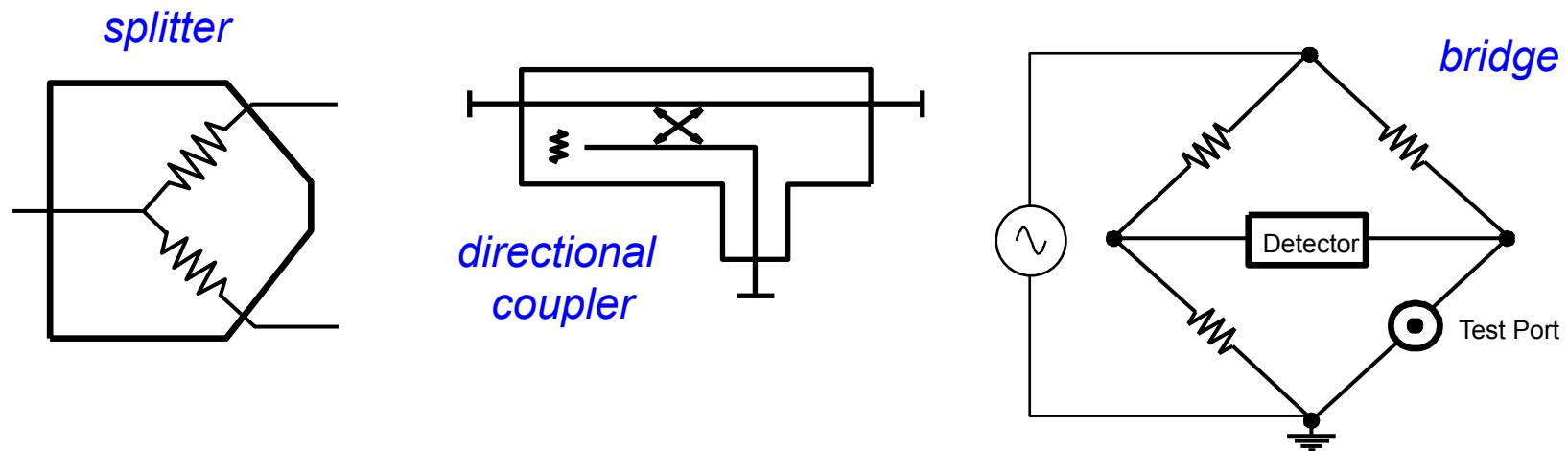
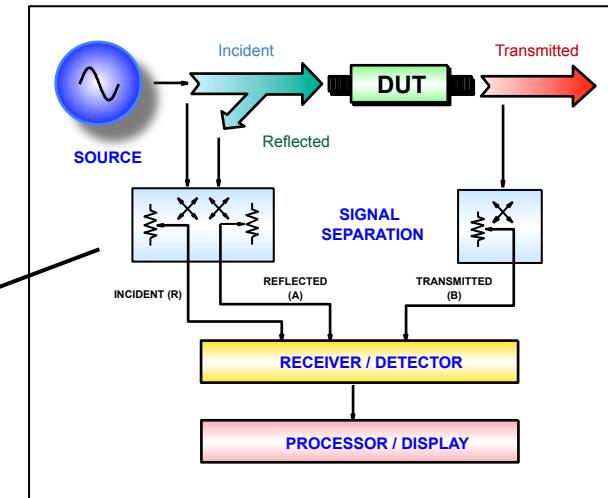
# Source

- Supplies stimulus for system
- Swept frequency or power
- Traditionally NAs used separate source
- Most Agilent analyzers sold today have **integrated, synthesized** sources



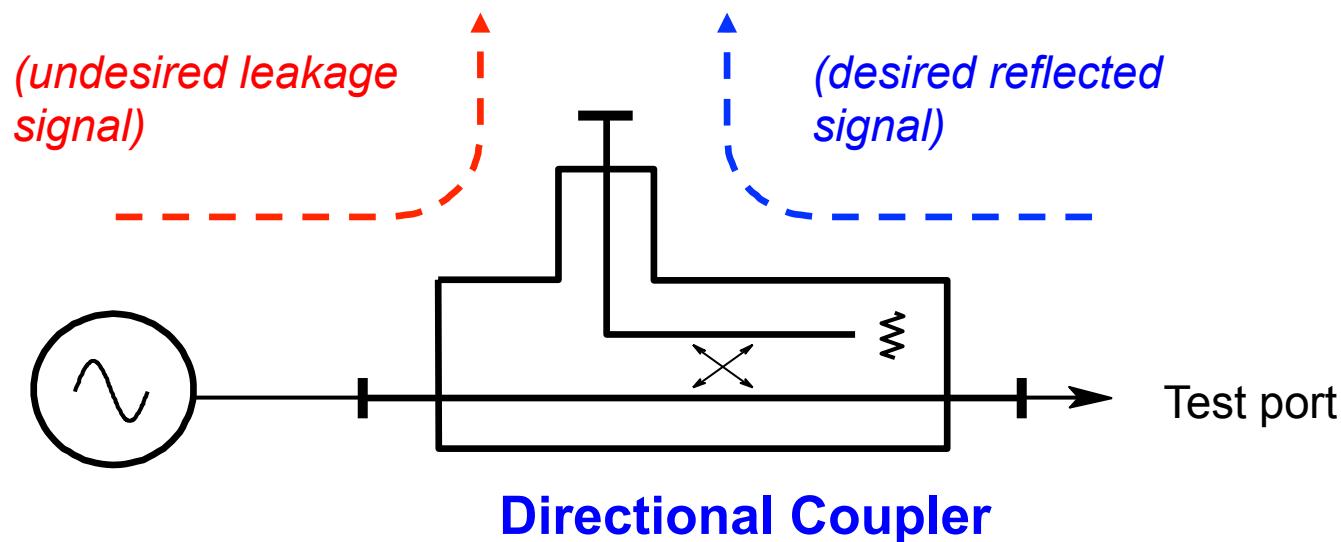
# Signal Separation

- measure incident signal for reference
- separate incident and reflected signals

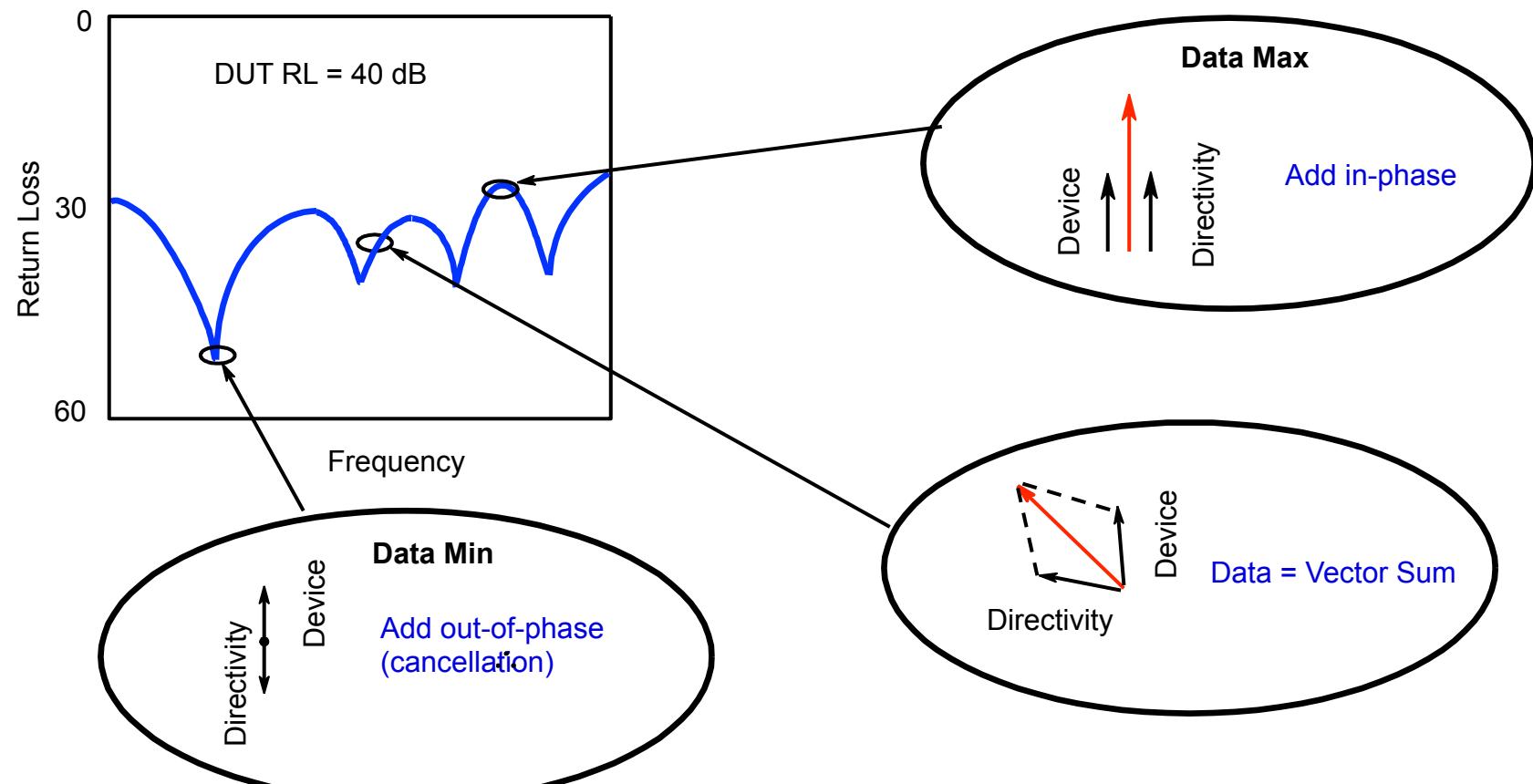


# Directivity

**Directivity** is a measure of how well a coupler can separate signals moving in opposite directions



# Interaction of Directivity with the DUT (Without Error Correction)



# Detector Types

**Scalar broadband**  
(no phase information)

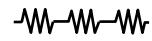
**Diode**



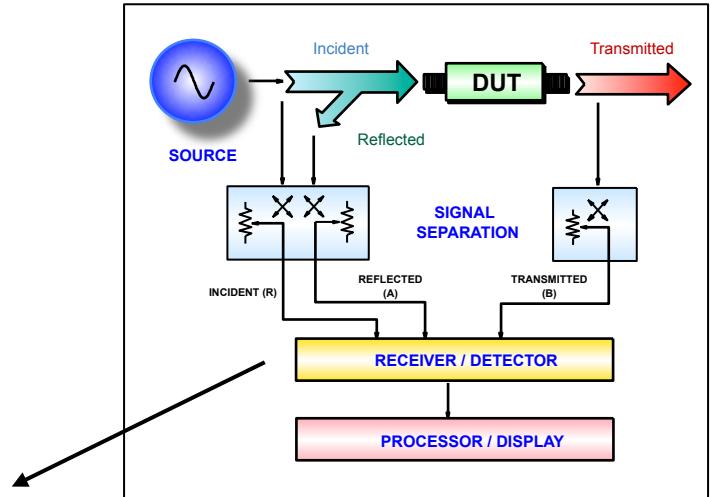
RF



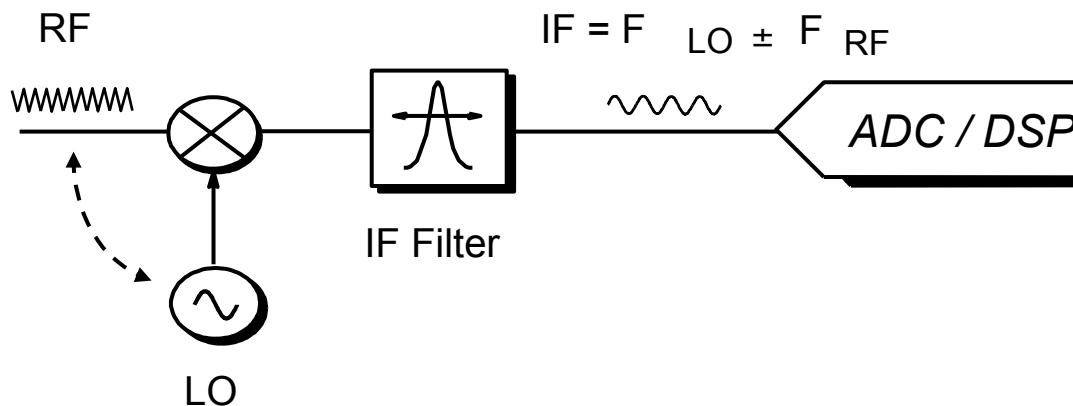
DC



AC

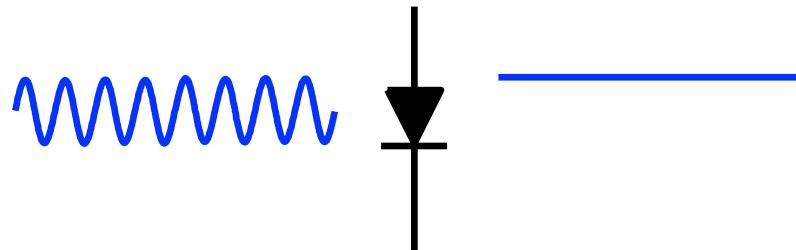


## Tuned Receiver

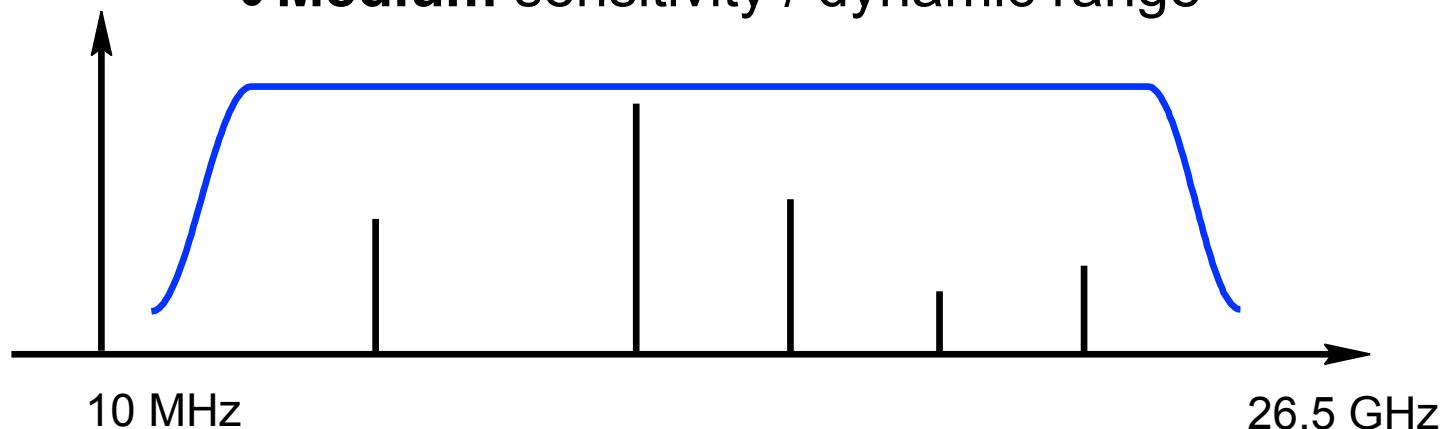


**Vector**  
(magnitude and phase)

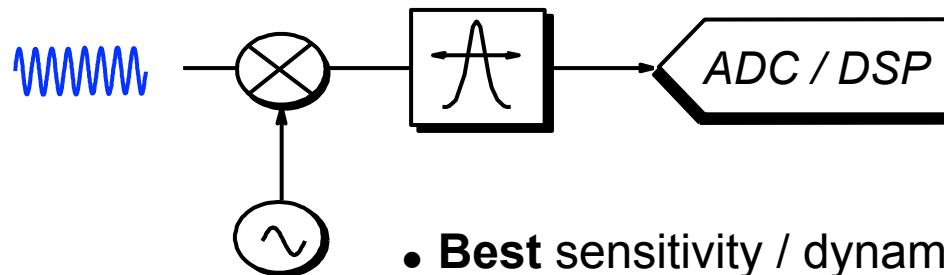
# Broadband Diode Detection



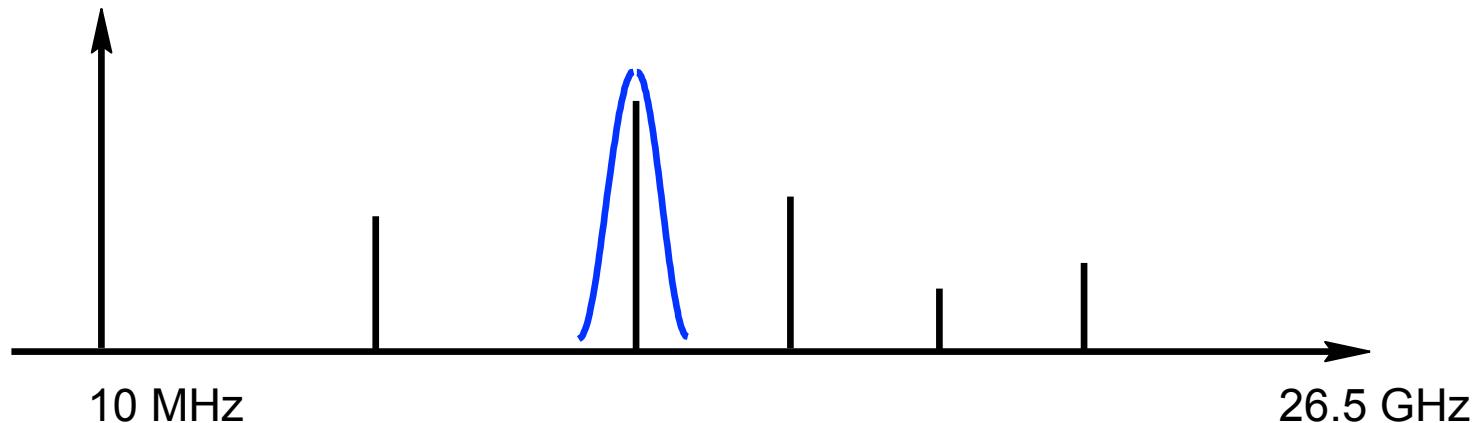
- Easy to make **broadband**
- **Inexpensive** compared to tuned receiver
- Good for measuring frequency-translating devices
- Improve dynamic range by increasing power
- **Medium** sensitivity / dynamic range



# Narrowband Detection - Tuned Receiver

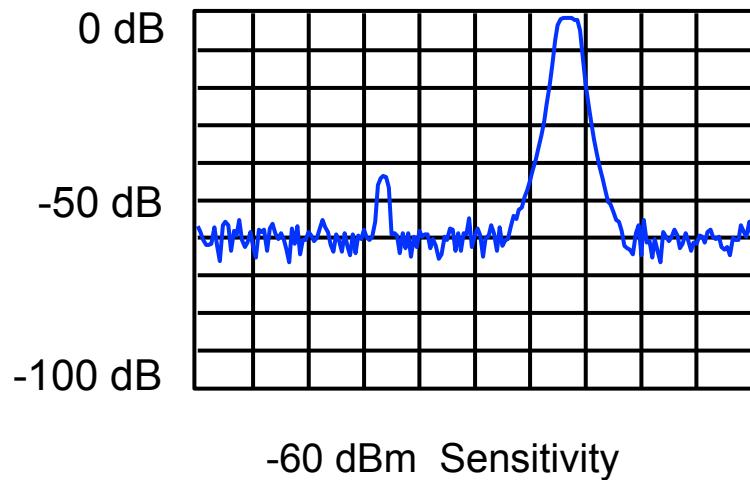


- **Best** sensitivity / dynamic range
- Provides harmonic / spurious signal **rejection**
- Improve dynamic range by increasing **power**, decreasing IF **bandwidth**, or **averaging**
- Trade off noise floor and measurement speed



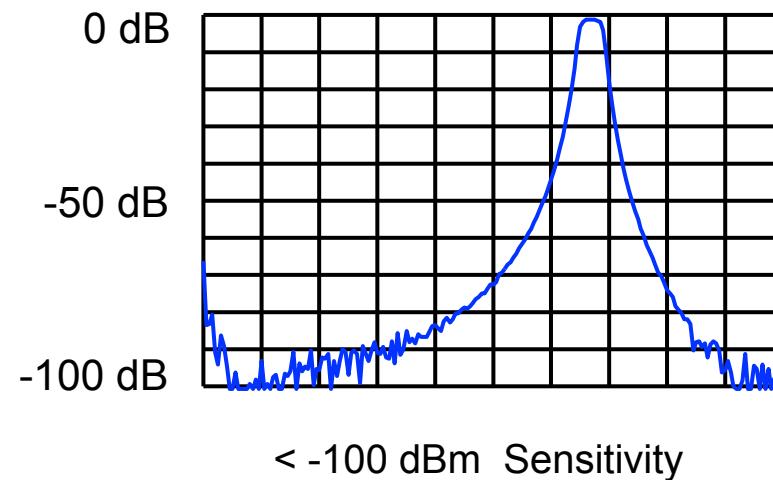
# Comparison of Receiver Techniques

## *Broadband (diode) detection*



- higher noise floor
- false responses

## *Narrowband (tuned-receiver) detection*

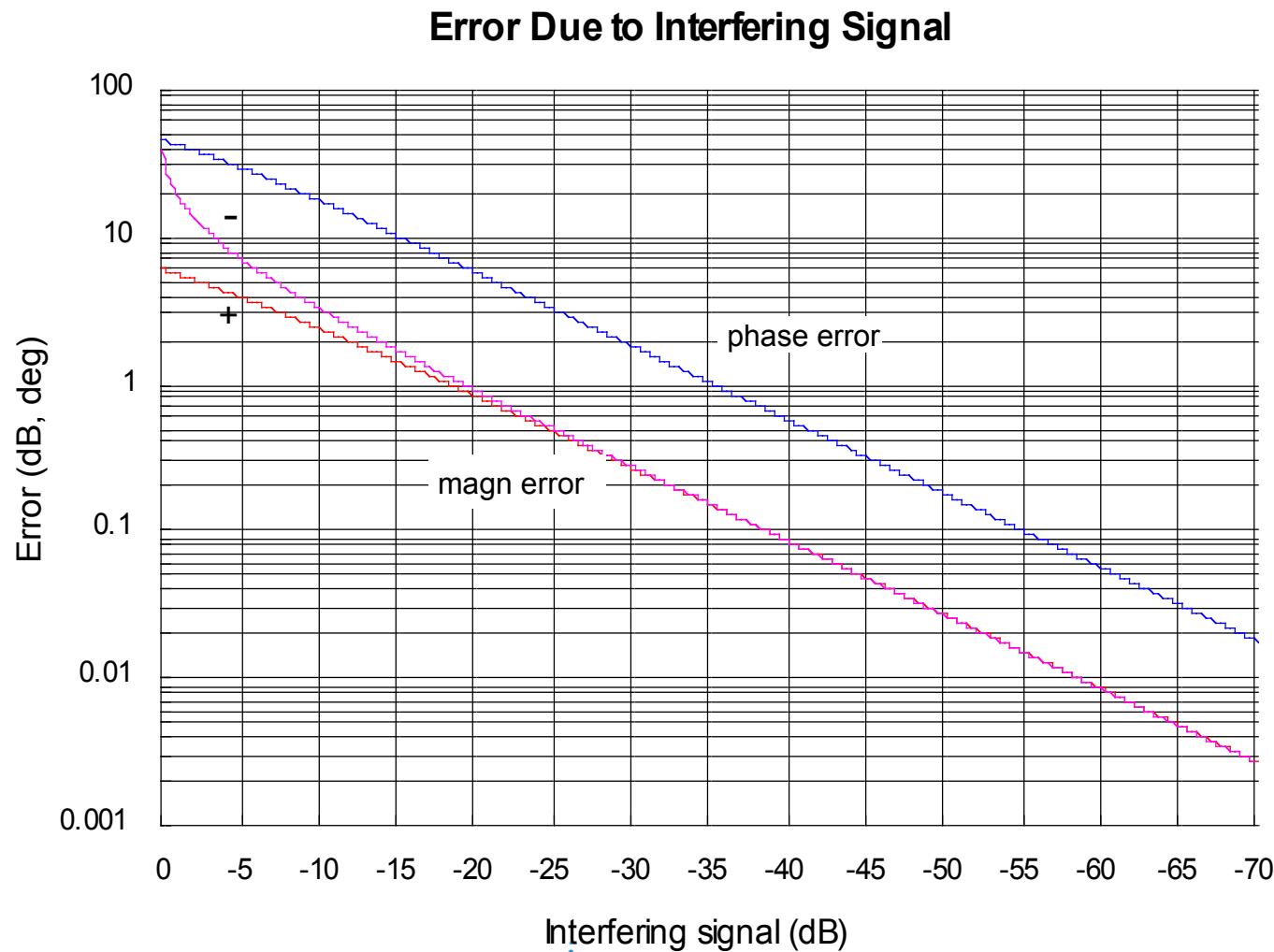


- high dynamic range
- harmonic immunity

***Dynamic range = maximum receiver power -  
receiver noise floor***



# Dynamic Range and Accuracy

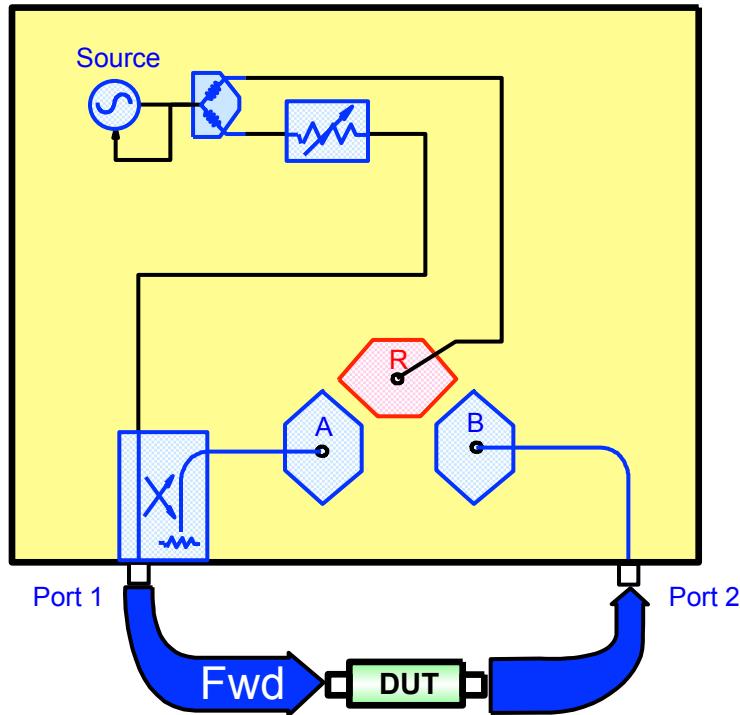


*Dynamic range  
is very important  
for measurement  
accuracy!*



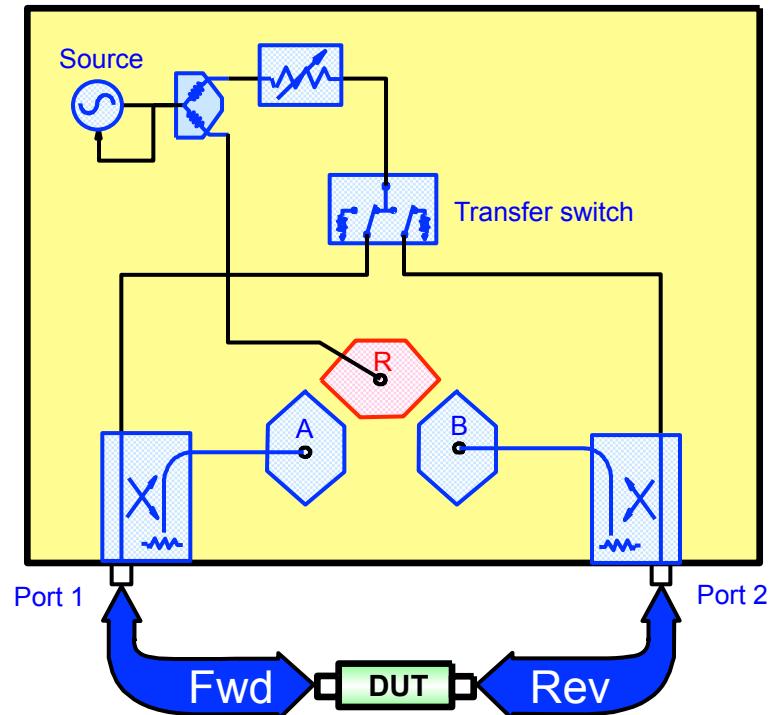
# T/R Versus S-Parameter Test Sets

## Transmission/Reflection Test Set



- RF always comes out port 1
- port 2 is always receiver
- **response, one-port cal** available

## S-Parameter Test Set

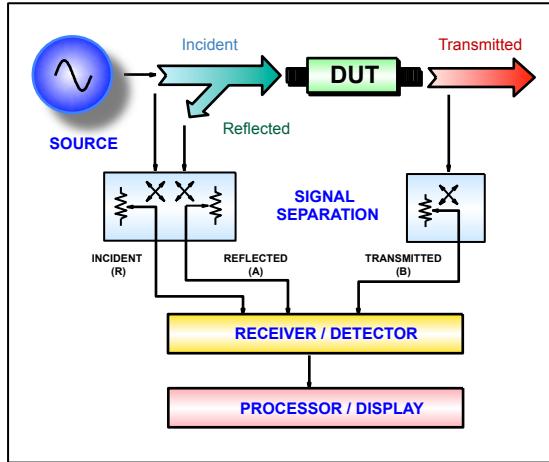


- RF comes out port 1 or port 2
- forward and reverse measurements
- **two-port** calibration possible

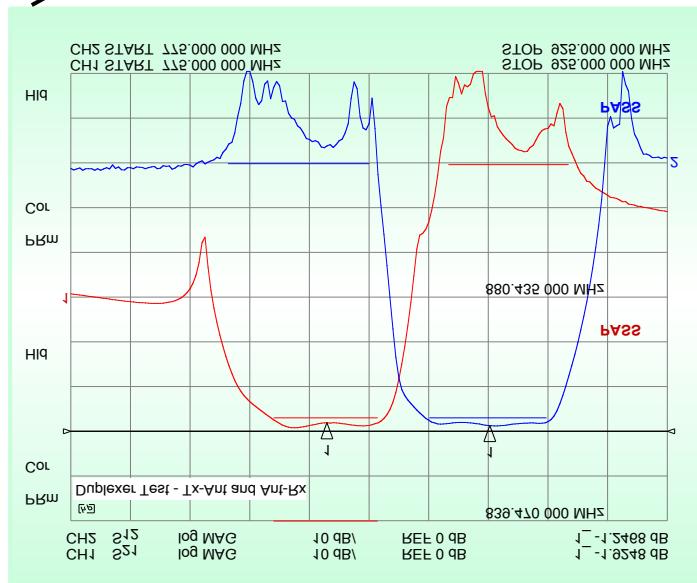
Copyright  
2000



# Processor / Display

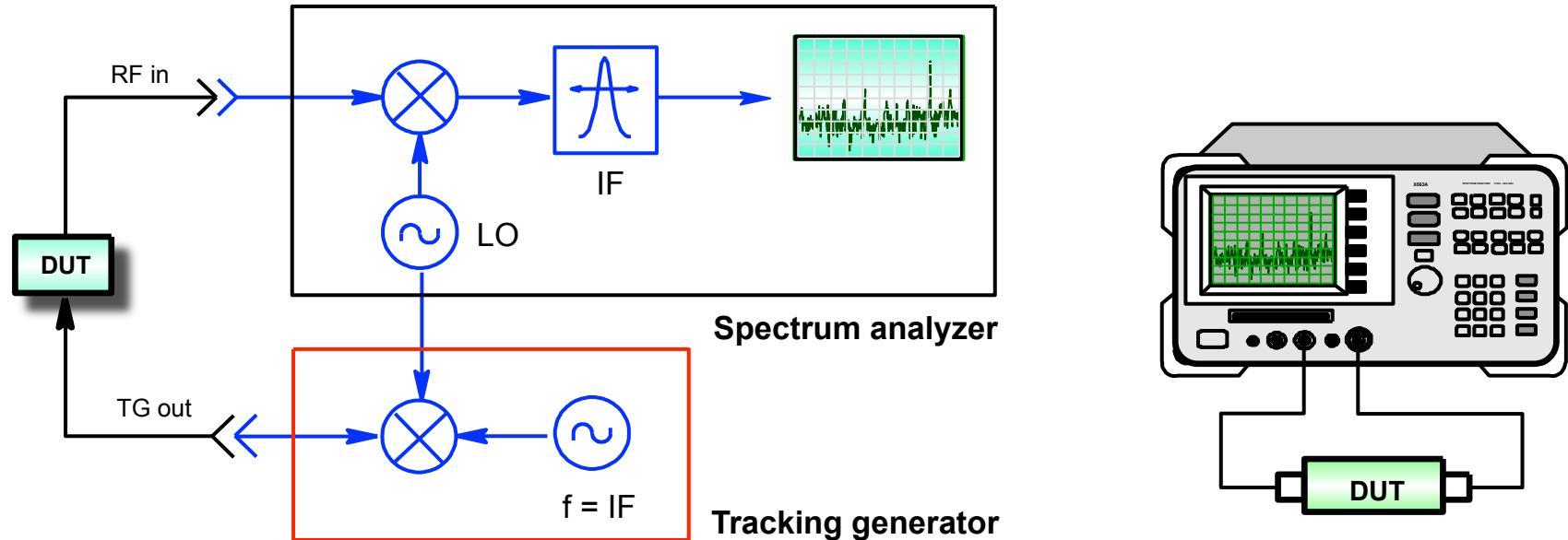


- markers
  - limit lines
  - pass/fail indicators
  - linear/log formats
  - grid/polar/Smith charts



**Agilent Technologies**

# Spectrum Analyzer / Tracking Generator



## ***Key differences from network analyzer:***

- **one channel** -- no ratioed or phase measurements
- More **expensive** than scalar NA (but better dynamic range)
- Only error correction available is **normalization** (and possibly open-short averaging)
- Poorer **accuracy**
- Small **incremental cost** if SA is required for other measurements



# Agenda

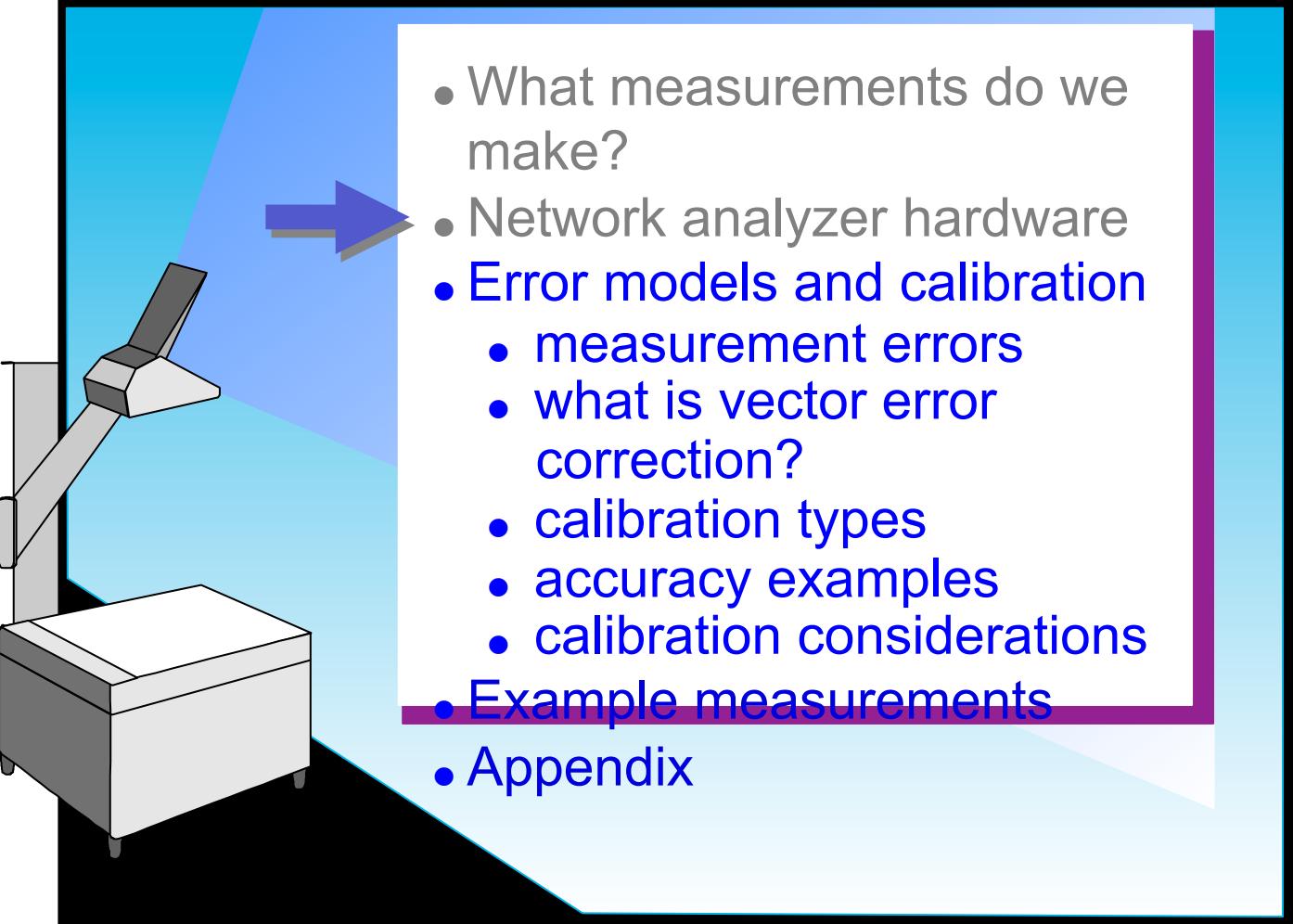
- What measurements do we make?
- Network analyzer hardware
- Error models and calibration
- Example measurements
- Appendix

**Why do we even need error-correction and calibration?**

- It is impossible to make perfect hardware
- It would be extremely expensive to make hardware good enough to eliminate the need for error correction



# Calibration Topics



The diagram shows a network analyzer setup. A white rectangular unit sits on a black base, connected by a grey cable to a grey horn-like probe. The probe is mounted on a grey articulated arm, which is attached to a black frame. A blue arrow points from the right side of the probe towards a list of topics on the right.

- What measurements do we make?
- Network analyzer hardware
- **Error models and calibration**
  - measurement errors
  - what is vector error correction?
  - calibration types
  - accuracy examples
  - calibration considerations
- **Example measurements**
- **Appendix**



# Measurement Error Modeling

## *Systematic errors*

- due to **imperfections** in the analyzer and test setup
- assumed to be **time invariant** (predictable)



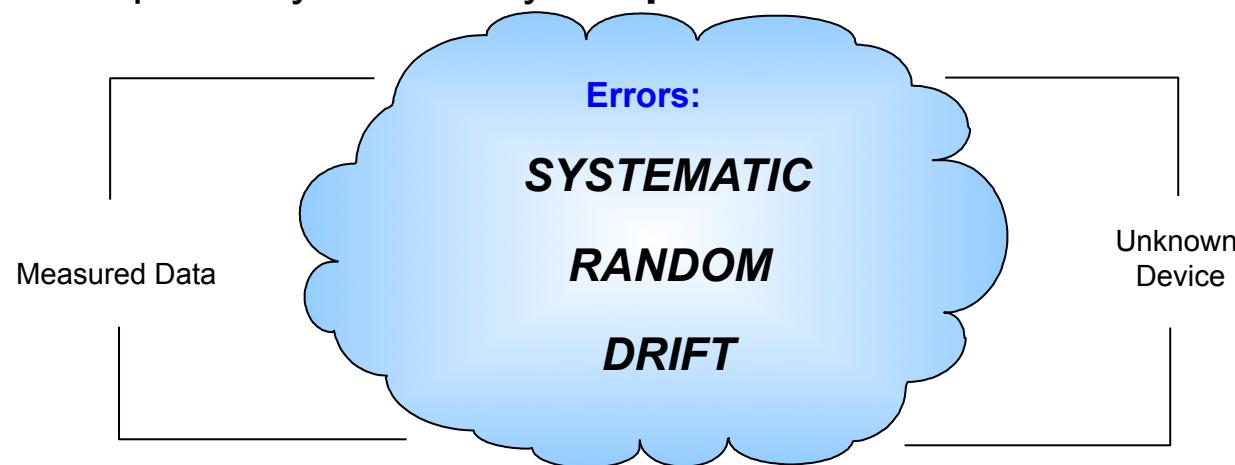
## *Random errors*

- **vary** with time in random fashion (unpredictable)
- main contributors: instrument **noise**, switch and connector **repeatability**

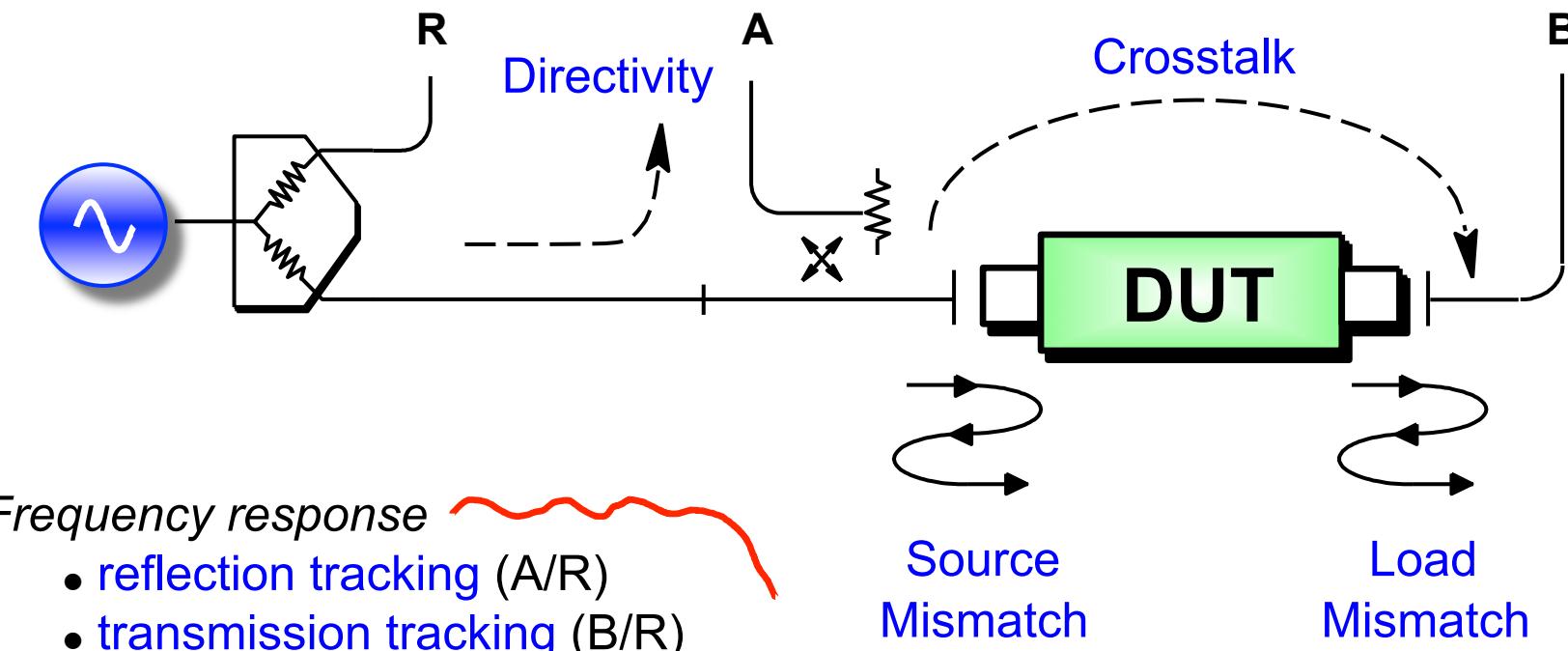


## *Drift errors*

- due to system performance changing **after** a calibration has been done
- primarily caused by **temperature variation**



# Systematic Measurement Errors

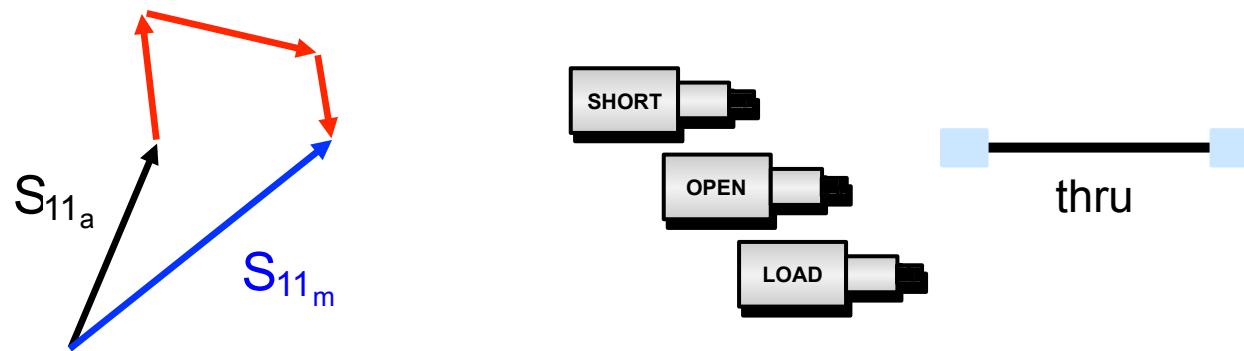


**Six forward and six reverse error terms yields 12 error terms for two-port devices**



# Types of Error Correction

- **response (normalization)**
  - simple to perform
  - only corrects for tracking errors
  - stores reference trace in memory,      thru
  - then does data divided by memory
- **vector**
  - requires more standards
  - requires an analyzer that can measure phase
  - accounts for all major sources of systematic error

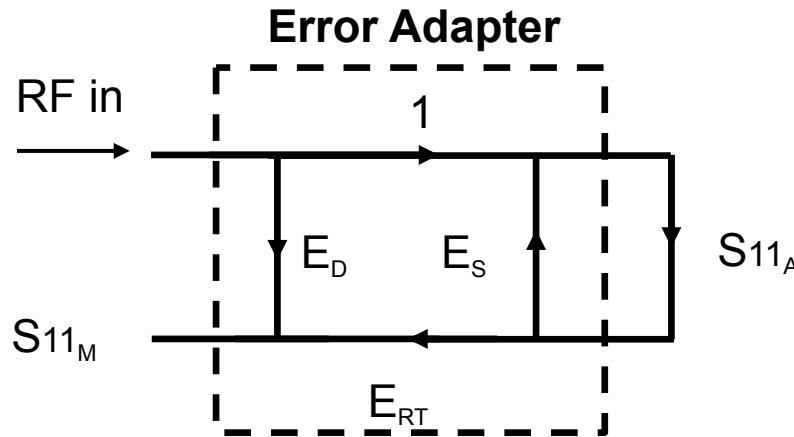
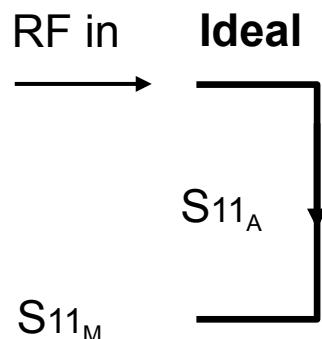


# What is Vector-Error Correction?

- Process of characterizing systematic error terms
  - measure **known standards**
  - remove effects from subsequent measurements
- **1-port calibration** (*reflection measurements*)
  - only 3 systematic error terms measured
  - directivity, source match, and reflection tracking
- **Full 2-port calibration** (*reflection and transmission measurements*)
  - 12 systematic error terms measured
  - usually requires 12 measurements on four known standards (SOLT)
- Standards defined in **cal kit definition** file
  - network analyzer contains standard cal kit definitions
  - **CAL KIT DEFINITION MUST MATCH ACTUAL CAL KIT USED!**
  - User-built standards must be characterized and entered into user cal-kit



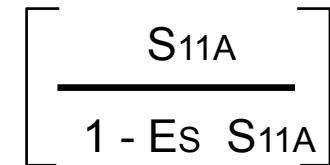
# Reflection: One-Port Model



E<sub>D</sub> = Directivity  
E<sub>RT</sub> = Reflection tracking  
E<sub>S</sub> = Source Match  
S<sub>11M</sub> = Measured  
S<sub>11A</sub> = Actual

To solve for error terms,  
we measure 3 standards to  
generate 3 equations and  
3 unknowns

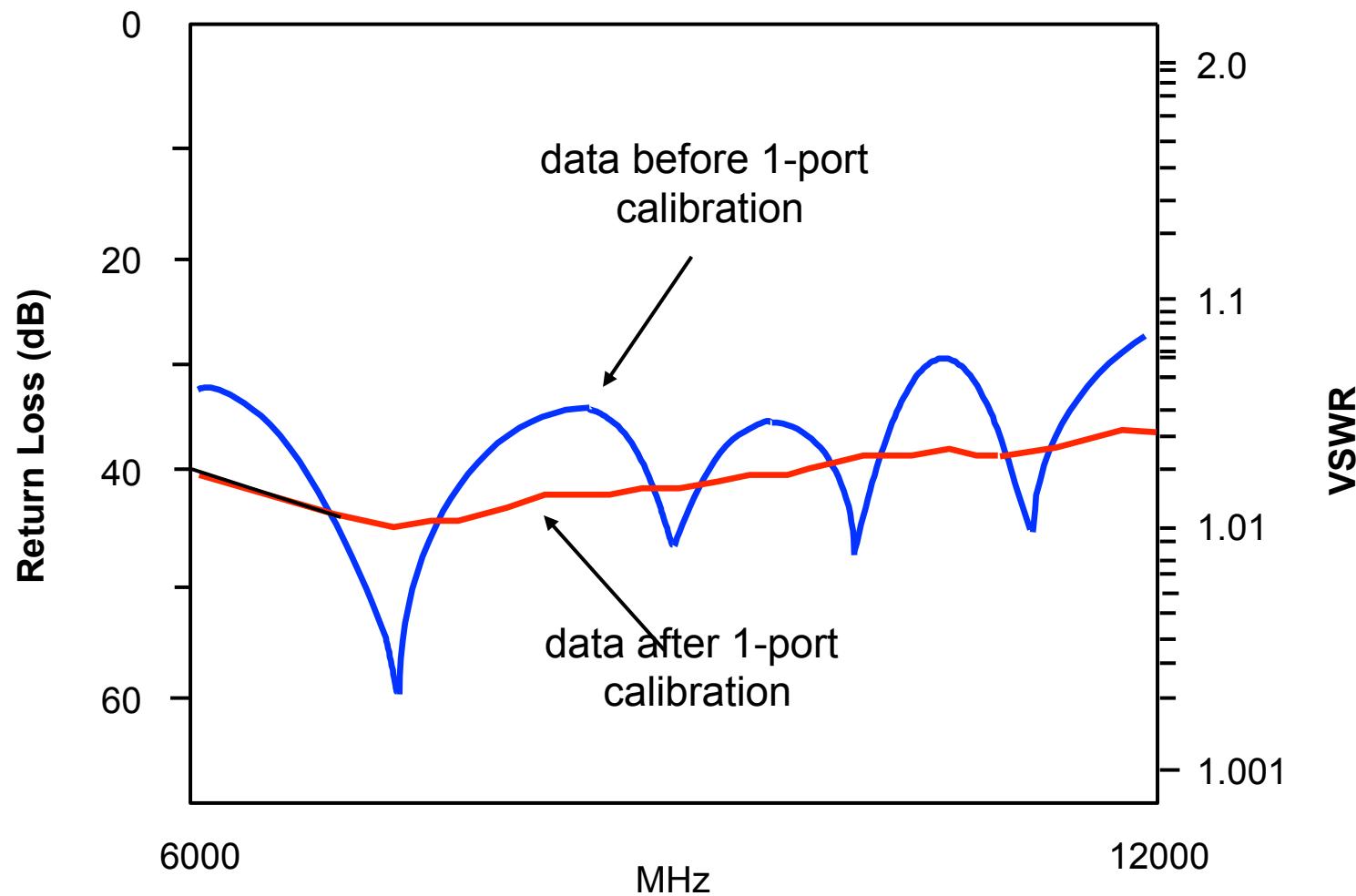
$$S_{11M} = E_D + E_{RT}$$



- Assumes good termination at port two if testing two-port devices
- If using port 2 of NA and DUT reverse isolation is low (e.g., filter passband):
  - assumption of good termination is not valid
  - two-port error correction yields better results

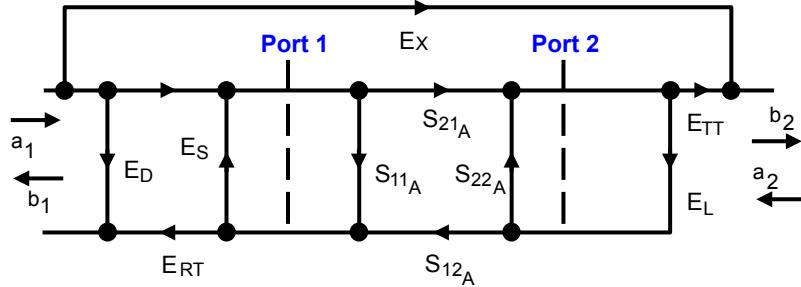


# Before and After One-Port Calibration



# Two-Port Error Correction

Forward model



$E_D$  = fwd directivity

$E_S$  = fwd source match

$E_{RT}$  = fwd reflection tracking

$E_{D'}$  = rev directivity

$E_{S'}$  = rev source match

$E_{RT'}$  = rev reflection tracking

$E_L$  = fwd load match

$E_{TT}$  = fwd transmission tracking

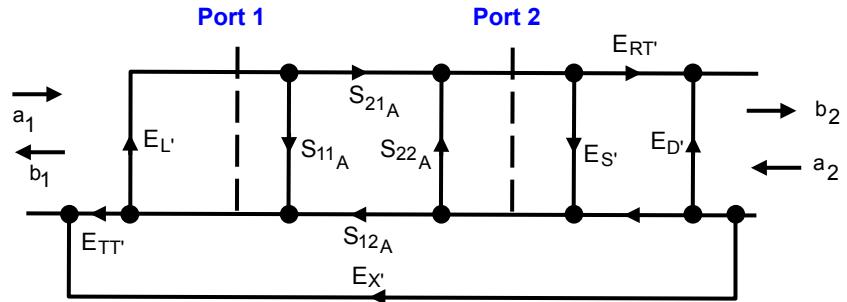
$E_X$  = fwd isolation

$E_{L'}$  = rev load match

$E_{TT'}$  = rev transmission tracking

$E_X'$  = rev isolation

Reverse model



- Each actual S-parameter is a function of all four measured S-parameters
- Analyzer must make forward *and* reverse sweep to update any one S-parameter
- Luckily, you don't need to know these equations to **use** network analyzers!!!

$$S_{11a} = \frac{(\frac{S_{11m} - E_D}{E_{RT}})(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}) - E_L (\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_{X'}}{E_{TT'}})}{(1 + \frac{S_{11m} - E_{D'}}{E_{RT}} E_S)(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}) - E_L'E_L (\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_{X'}}{E_{TT'}})}$$

$$S_{21a} = \frac{(\frac{S_{21m} - E_X}{E_{TT}})(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} (E_{S'} - E_L))}{(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S)(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}) - E_L'E_L (\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_{X'}}{E_{TT'}})}$$

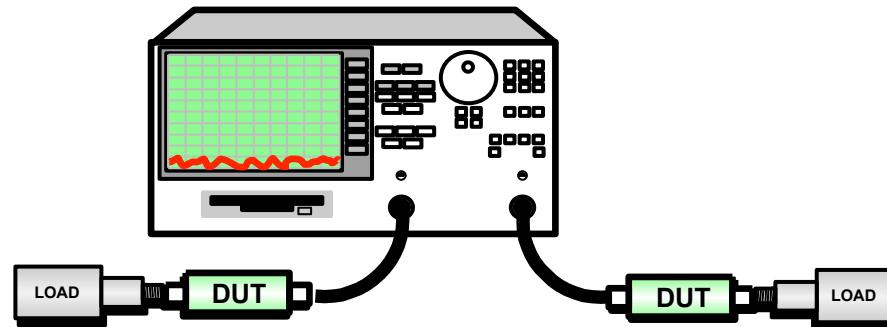
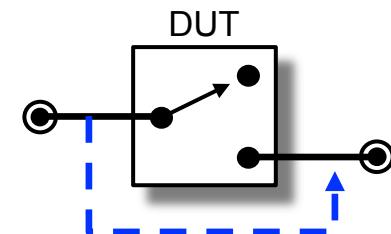
$$S_{12a} = \frac{(\frac{S_{12m} - E_{X'}}{E_{TT'}})(1 + \frac{S_{11m} - E_D}{E_{RT}} (E_S - E_{L'}))}{(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S)(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}) - E_L'E_L (\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_{X'}}{E_{TT'}})}$$

$$S_{22a} = \frac{(\frac{S_{22m} - E_{D'}}{E_{RT'}})(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S) - E_L' (\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_{X'}}{E_{TT'}})}{(1 + \frac{S_{11m} - E_D}{E_{RT}} E_S)(1 + \frac{S_{22m} - E_{D'}}{E_{RT'}} E_{S'}) - E_L'E_L (\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_{X'}}{E_{TT'}})}$$



# Crosstalk: Signal Leakage Between Test Ports During Transmission

- Can be a problem with:
  - high-isolation devices (e.g., switch in open position)
  - high-dynamic range devices (some filter stopbands)
- Isolation calibration
  - adds noise to error model (measuring near noise floor of system)
  - only perform if really needed (use averaging if necessary)
  - if crosstalk is **independent** of DUT match, use two terminations
  - if **dependent** on DUT match, use DUT with termination on output



# Errors and Calibration Standards

## UNCORRECTED FULL 2-PORT



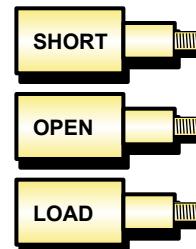
- Convenient
- Generally not accurate
- No errors removed



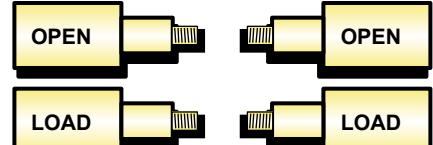
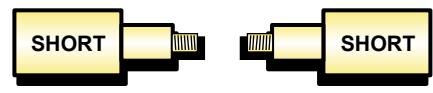
## RESPONSE



- Easy to perform
- Use when highest accuracy is not required
- Removes frequency response error



## 1-PORT



## ENHANCED-RESPONSE

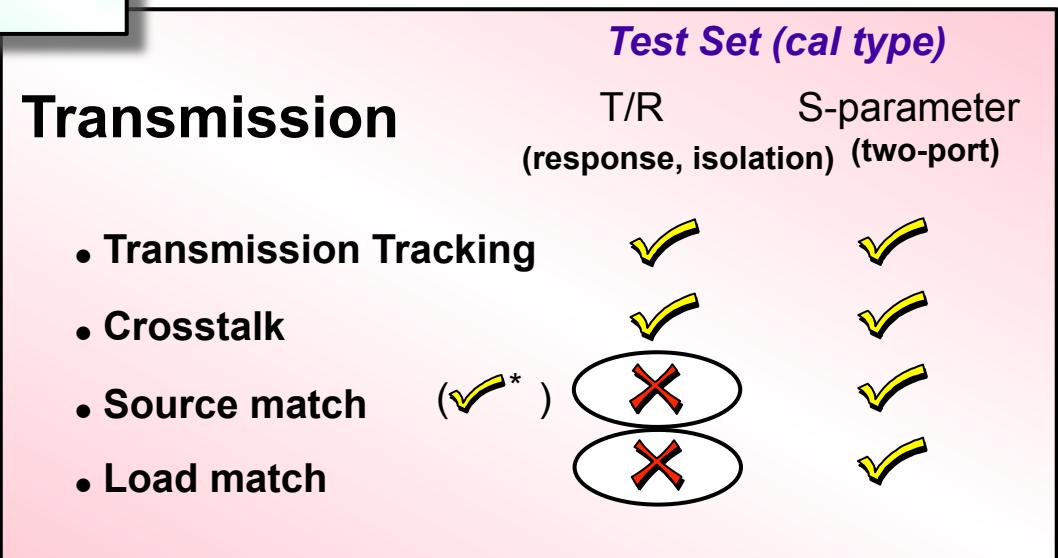
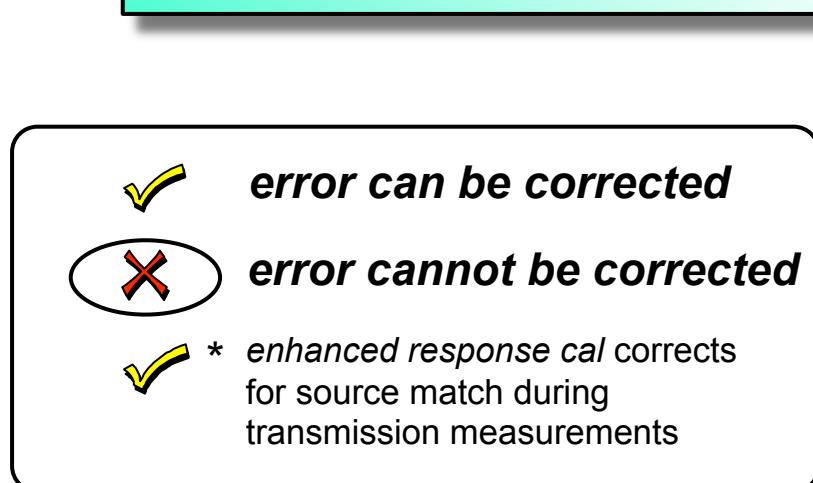
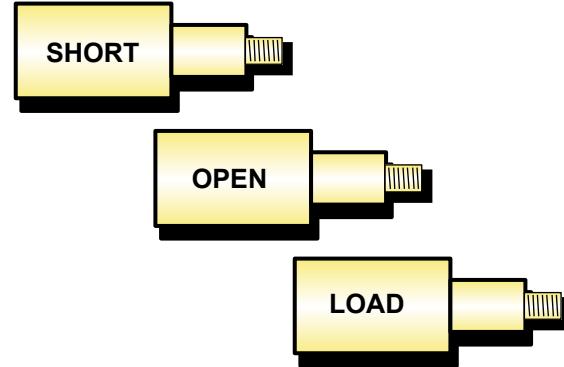
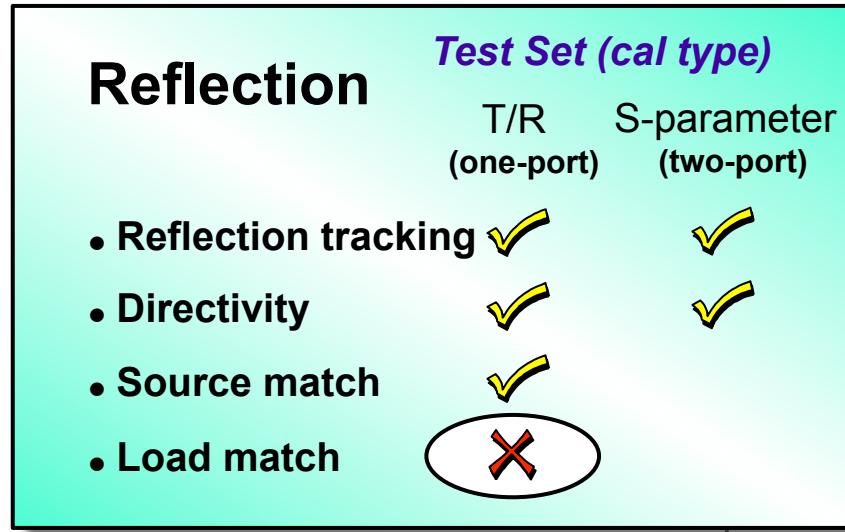
- Combines response and 1-port
- Corrects source match for transmission measurements

- For reflection measurements
- Need good termination for high accuracy with two-port devices
- Removes these errors:
  - Directivity
  - Source match
  - Reflection tracking

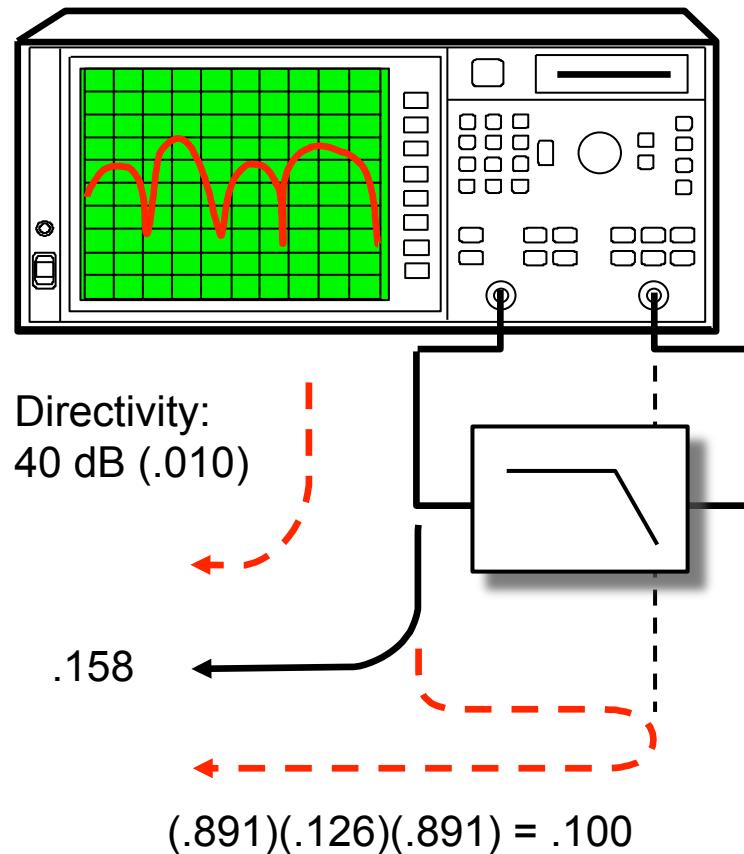
- Highest accuracy
- Removes these errors:
  - Directivity
  - Source, load match
  - Reflection tracking
  - Transmission tracking
  - Crosstalk



# Calibration Summary



# Reflection Example Using a One-Port Cal



Load match:  
18 dB (.126)

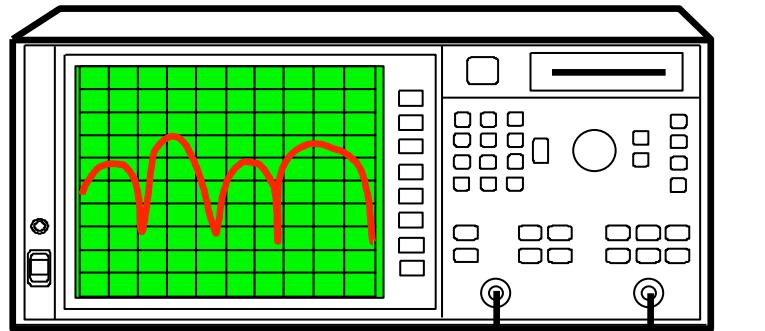
**DUT**  
16 dB RL (.158)  
1 dB loss (.891)

*Remember: convert all dB values to linear for uncertainty calculations!*

$$\rho \text{ or loss}_{(\text{linear})} = 10^{\frac{(-\text{dB})}{20}}$$

**Measurement uncertainty:**  
 $-20 * \log (.158 + .100 + .010)$   
**= 11.4 dB (-4.6dB)**  
 $-20 * \log (.158 - .100 - .010)$   
**= 26.4 dB (+10.4 dB)**

# Using a One-Port Cal + Attenuator



Directivity:  
40 dB (.010)

.158

$$(.891)(.316)(.126)(.316)(.891) = .010$$
$$(.891)(.024)(.891) = .019$$

Load match:  
18 dB (.126)

10 dB attenuator (.316)  
SWR = 1.05 (.024)

## DUT

16 dB RL (.158)  
1 dB loss (.891)

***Low-loss bi-directional devices  
generally require two-port  
calibration  
for low measurement uncertainty***

Worst-case error = .010 + .010 + .019 = .039

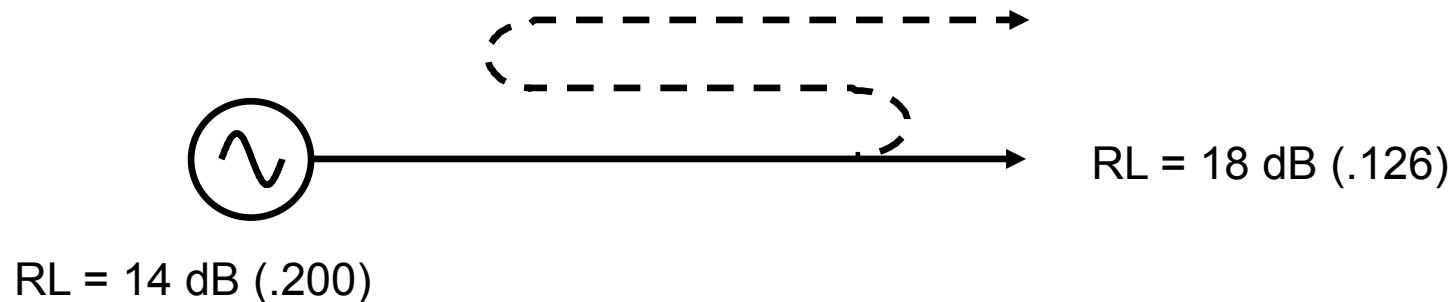


## Measurement uncertainty:

$$-20 * \log (.158 + .039) = 14.1 \text{ dB } (-1.9 \text{ dB})$$

$$-20 * \log (.158 - .039) = 18.5 \text{ dB } (+2.5 \text{ dB})$$

# Transmission Example Using Response Cal



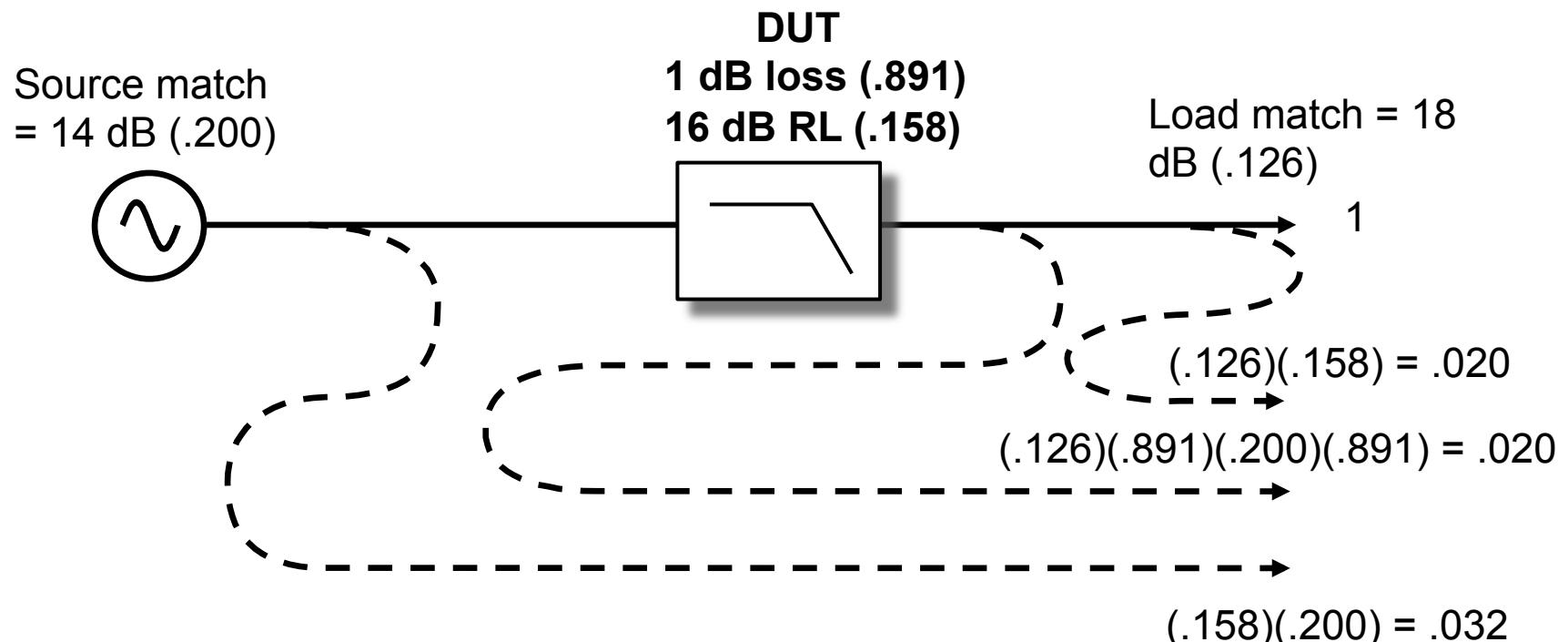
Thru calibration (normalization) builds error into measurement due to source and load match interaction

**Calibration Uncertainty**

$$\begin{aligned} &= (1 \pm \rho_s \rho_L) \\ &= (1 \pm (.200)(.126)) \\ &= \pm 0.22 \text{ dB} \end{aligned}$$



# Filter Measurement with Response Cal



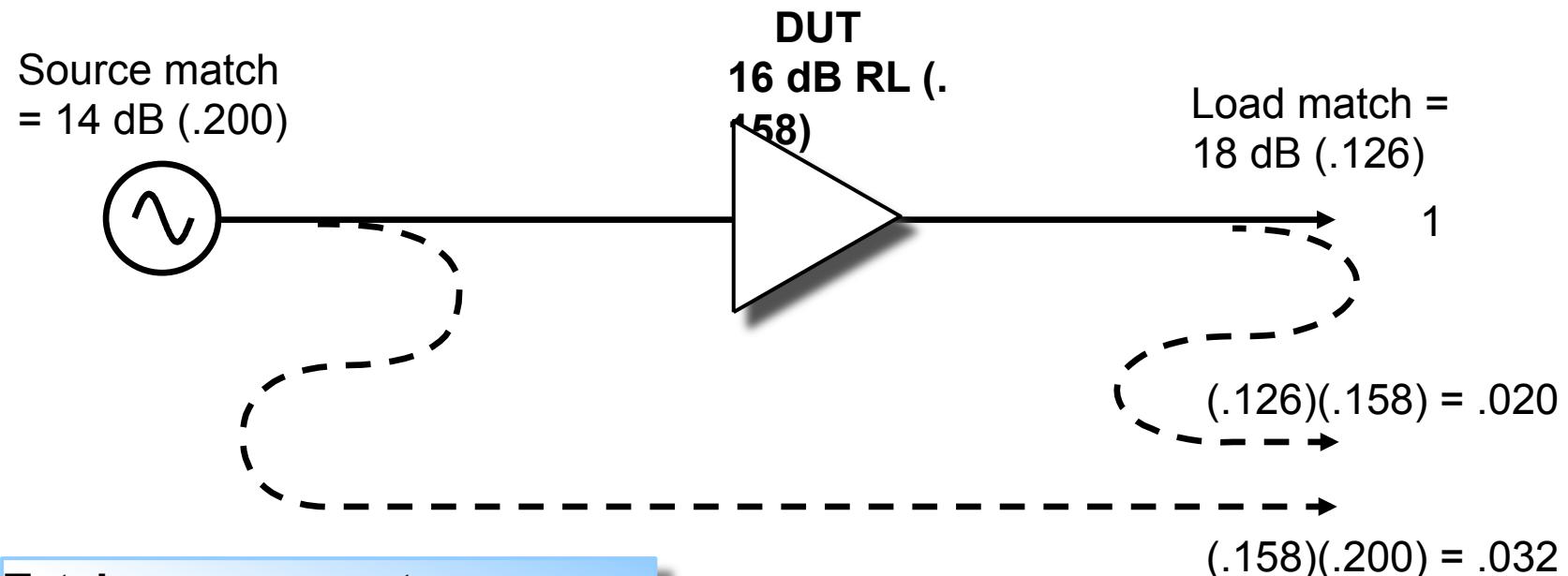
**Total measurement uncertainty:**

$$\begin{aligned} +0.60 + 0.22 &= + 0.82 \text{ dB} \\ -0.65 - 0.22 &= - 0.87 \text{ dB} \end{aligned}$$

Measurement uncertainty  
 $= 1 \pm (.020+.020+.032)$   
 $= 1 \pm .072$   
 $= + 0.60 \text{ dB}$   
 $- 0.65 \text{ dB}$



# Measuring Amplifiers with a Response Cal



Total measurement uncertainty:

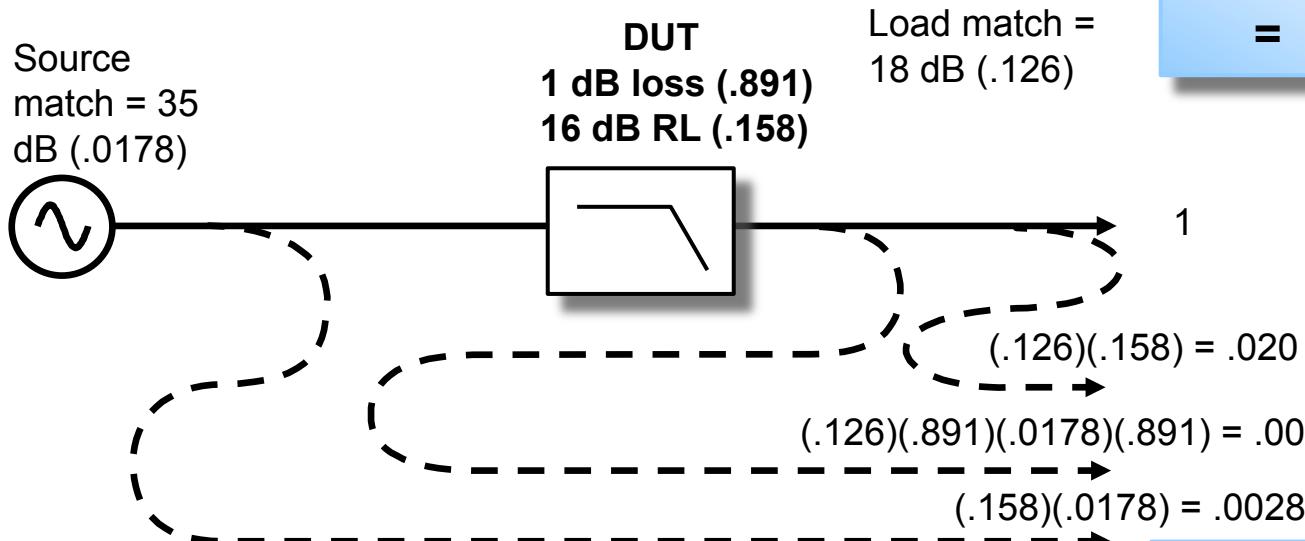
$$\begin{aligned} +0.44 + 0.22 &= + 0.66 \text{ dB} \\ -0.46 - 0.22 &= - 0.68 \text{ dB} \end{aligned}$$

$$\begin{aligned} \text{Measurement uncertainty} &= 1 \pm (.020+.032) \\ &= 1 \pm .052 \\ &= + 0.44 \text{ dB} \\ &- 0.46 \text{ dB} \end{aligned}$$



# Filter Measurements using the *Enhanced Response* Calibration

**Effective source match = 35 dB!**



$$\begin{aligned}\text{Calibration Uncertainty} &= (1 \pm \rho_S \rho_L) \\ &= (1 \pm (.0178)(.126)) \\ &= \pm .02 \text{ dB}\end{aligned}$$

$$\begin{aligned}1 &\quad \text{Measurement uncertainty} \\ &= 1 \pm (.020+.0018+.0028) \\ &= 1 \pm .0246 \\ &= + 0.211 \text{ dB} \\ &\quad - 0.216 \text{ dB} \\ &\quad (.126)(.158) = .020 \\ &\quad (.126)(.891)(.0178)(.891) = .0018 \\ &\quad (.158)(.0178) = .0028\end{aligned}$$

$$\begin{aligned}\text{Total measurement uncertainty:} \\ 0.22 + .02 = \pm 0.24 \text{ dB}\end{aligned}$$



# Using the *Enhanced Response* Calibration Plus an Attenuator

10 dB attenuator (.316)

SWR = 1.05 (.024 linear or 32.4 dB)

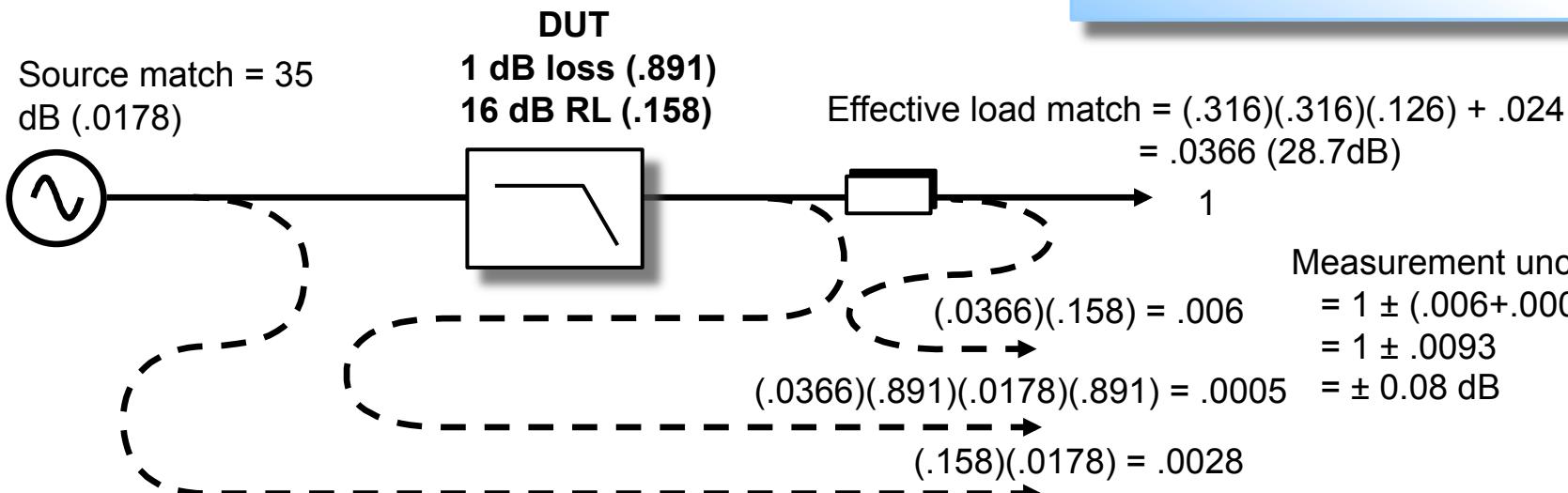
Analyzer load match = 18 dB (.126)

**Calibration Uncertainty**

$$= (1 \pm \rho_s \rho_L)$$

$$= (1 \pm (.0178)(.0366))$$

$$= \pm .01 \text{ dB}$$



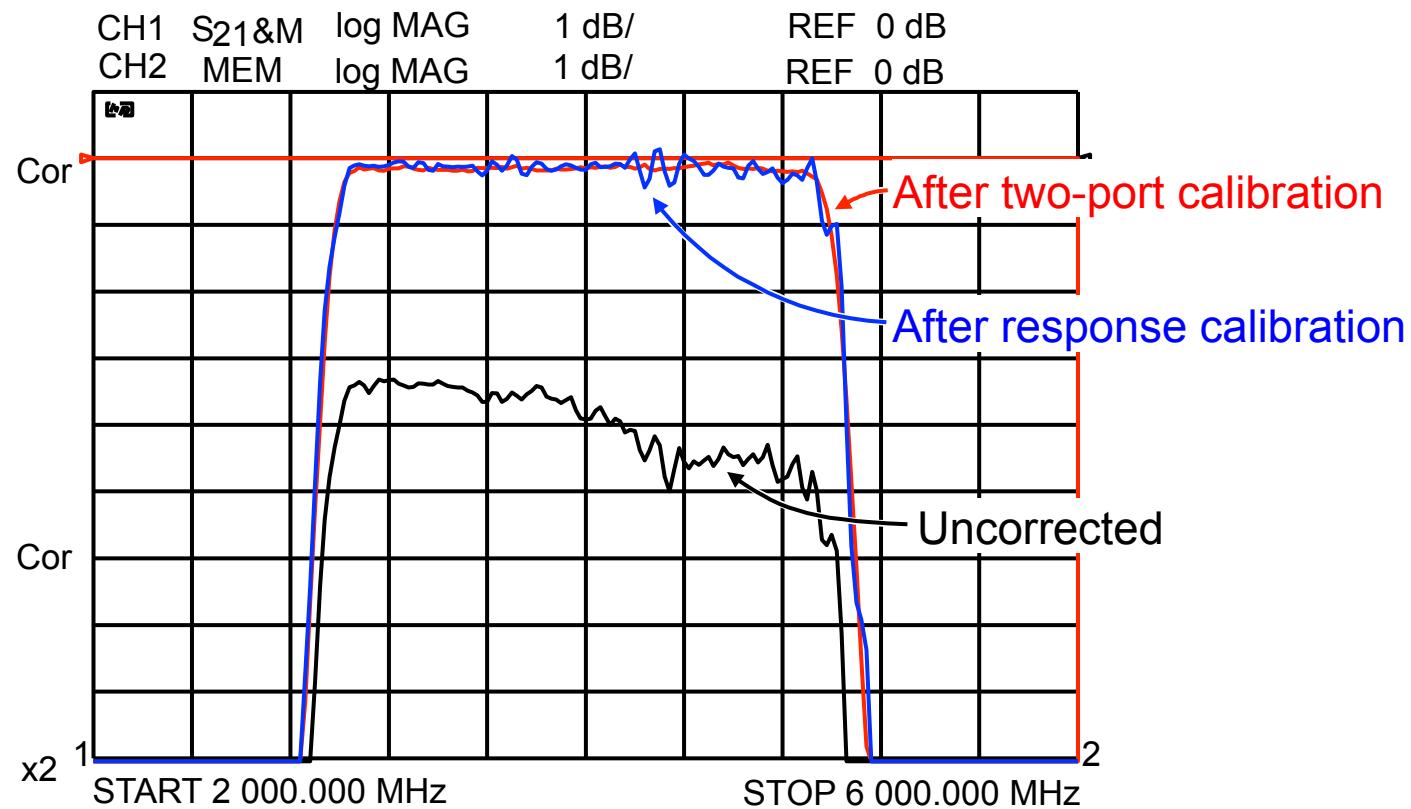
Measurement uncertainty  
 $= 1 \pm (.006 + .0005 + .0028)$   
 $= 1 \pm .0093$   
 $= \pm 0.08 \text{ dB}$

**Total measurement uncertainty:**  
 $0.01 + .08 = \pm 0.09 \text{ dB}$



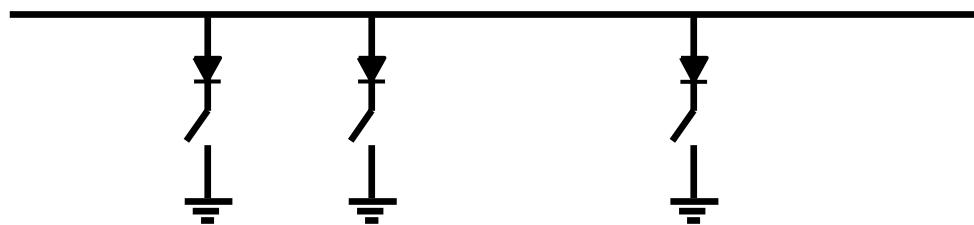
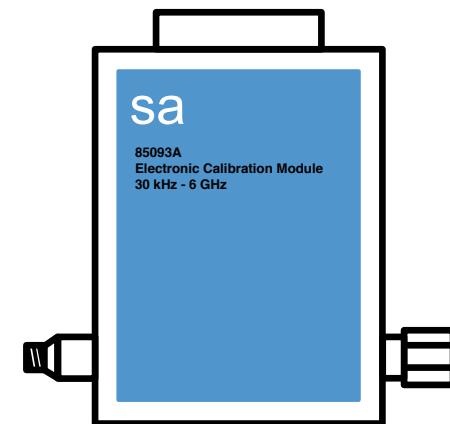
# Response versus Two-Port Calibration

## Measuring filter insertion loss



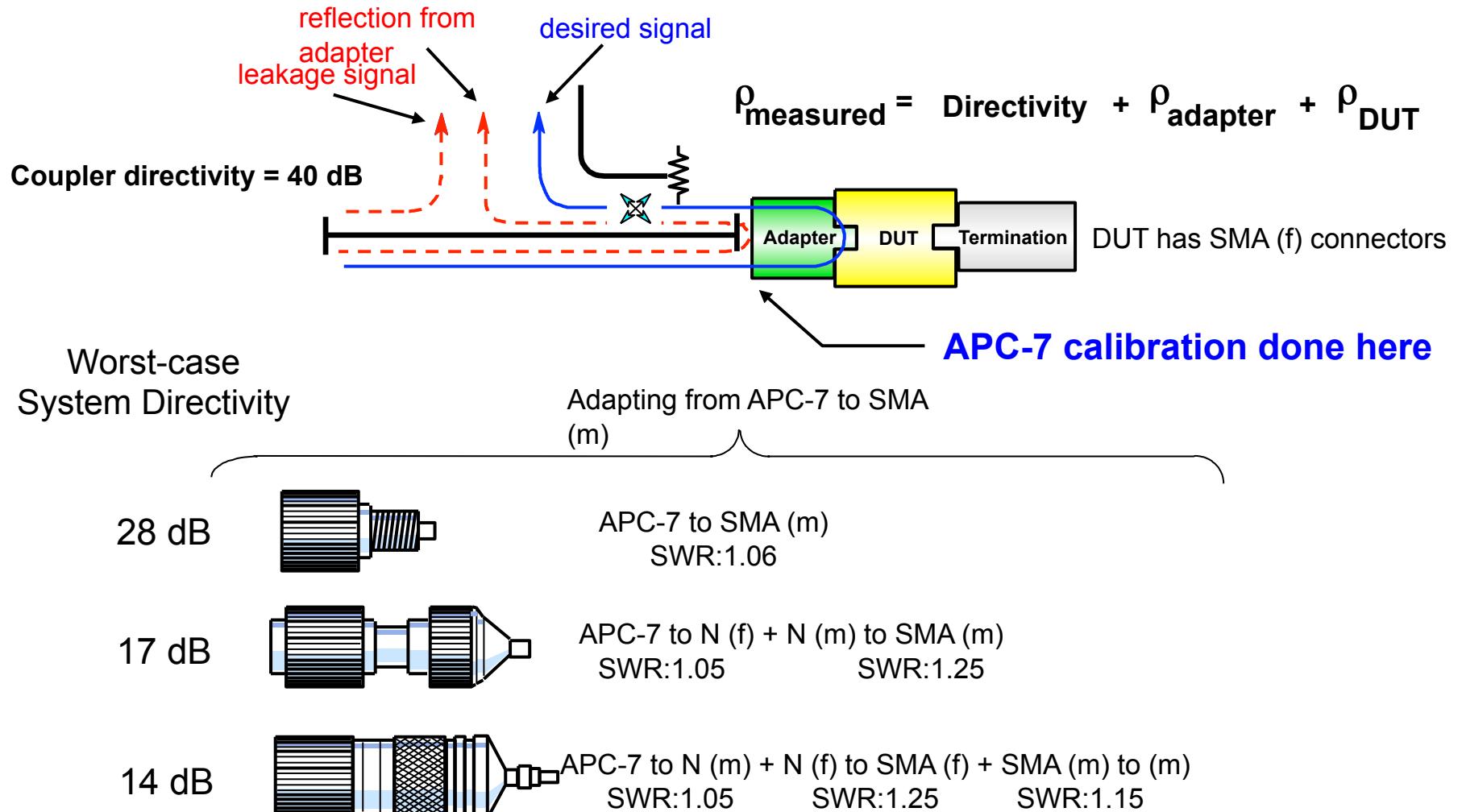
# ECal: Electronic Calibration (85060/90 series)

- . Variety of modules cover 30 kHz to 26.5 GHz
- . Six connector types available ( $50\ \Omega$  and  $75\ \Omega$ )
- . Single-connection
  - reduces calibration time
  - makes calibrations easy to perform
  - minimizes wear on cables and standards
  - eliminates operator errors
- . Highly repeatable temperature-compensated terminations provide excellent accuracy



*Microwave modules use a transmission line shunted by PIN-diode switches in various combinations*

# Adapter Considerations



# Calibrating Non-Insertable Devices

**When doing a through cal, normally test ports mate directly**

- cables can be connected directly without an adapter
- result is a zero-length through

**What is an insertable device?**



- has same type of connector, but different sex on each port
- has same type of sexless connector on each port (e.g. APC-7)

**What is a non-insertable device?**

- one that cannot be inserted in place of a zero-length through
- has same connectors on each port (type and sex)
- has different type of connector on each port  
(e.g., waveguide on one port, coaxial on the other)

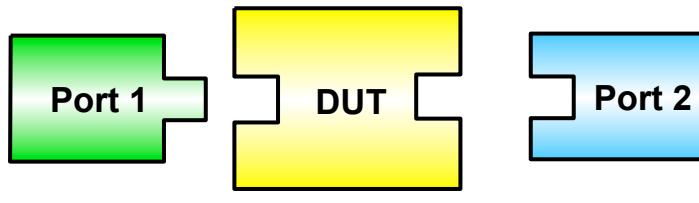


**What calibration choices do I have for non-insertable devices?**

- use an *uncharacterized* through adapter
- use a *characterized* through adapter (modify cal-kit definition)
- swap equal adapters
- adapter removal



# Swap Equal Adapters Method



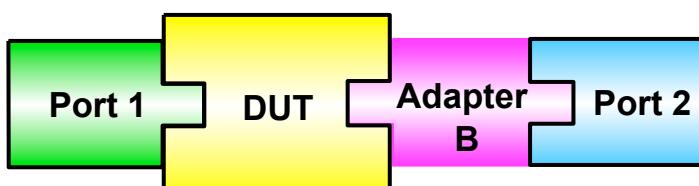
***Accuracy depends on how well the adapters are matched - loss, electrical length, match and impedance should all be equal***



1. Transmission cal using adapter A.



2. Reflection cal using adapter B.



3. Measure DUT using adapter B.

# Adapter Removal Calibration

- Calibration is very accurate and traceable
- In firmware of 8753, 8720 and 8510 series
- Also accomplished with ECal modules (85060/90)
- Uses adapter with same connectors as DUT
- Must specify electrical length of adapter to within 1/4 wavelength of highest frequency (to avoid phase ambiguity)



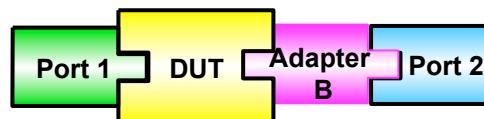
1. Perform 2-port cal with adapter on port 2.  
Save in cal set 1.



2. Perform 2-port cal with adapter on port 1.  
Save in cal set 2.

[CAL] [MORE] [MODIFY CAL SET]  
[ADAPTER REMOVAL]

3. Use ADAPTER REMOVAL  
to generate new cal set.



4. Measure DUT without cal adapter.

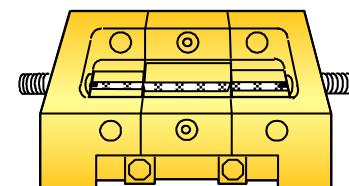
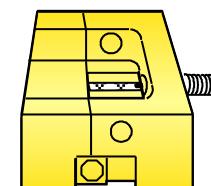
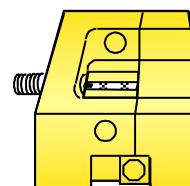
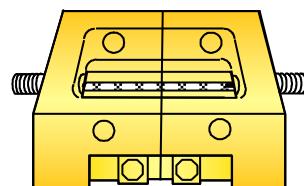
# Thru-Reflect-Line (TRL) Calibration

We know about Short-Open-Load-Thru (SOLT) calibration...

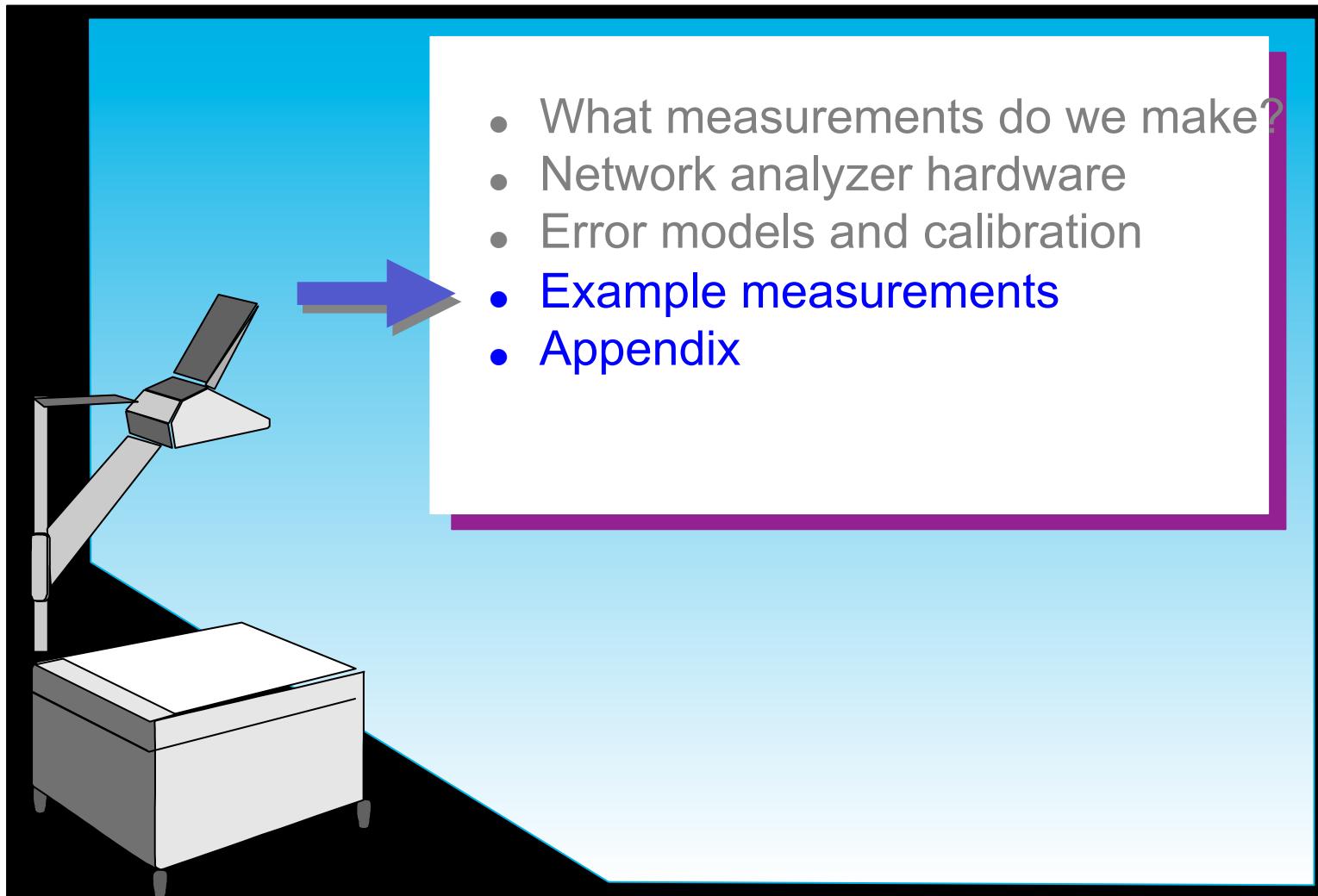
What is TRL?

- A two-port calibration technique
- Good for noncoaxial environments (waveguide, fixtures, wafer probing)
- Uses the same 12-term error model as the more common SOLT cal
- Uses practical calibration standards that are easily fabricated and characterized
- Two variations: TRL (requires 4 receivers) and TRL\* (only three receivers needed)
- Other variations: Line-Reflect-Match (LRM), Thru-Reflect-Match (TRM), plus many others

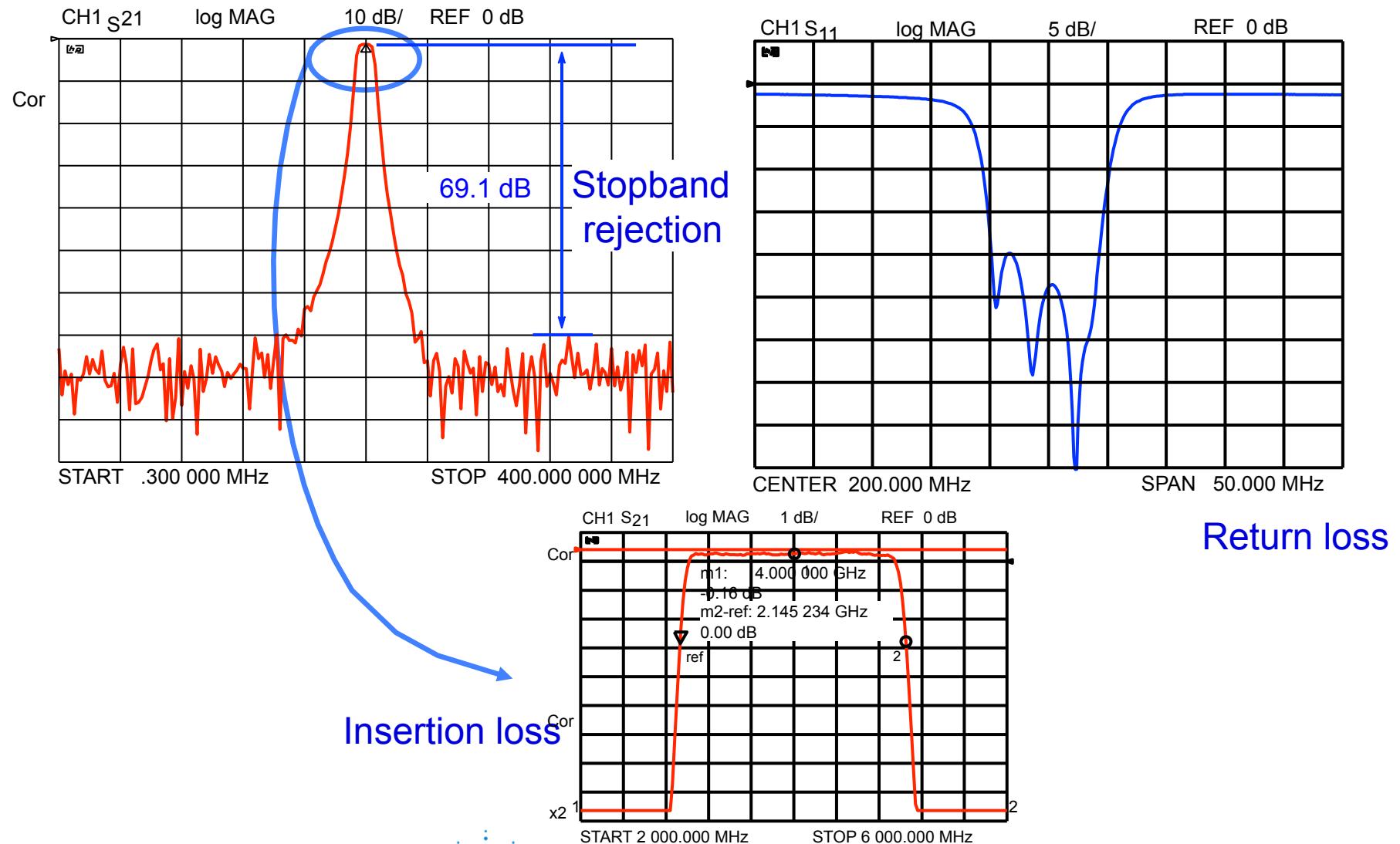
*TRL was developed for  
**non-coaxial microwave**  
measurements*



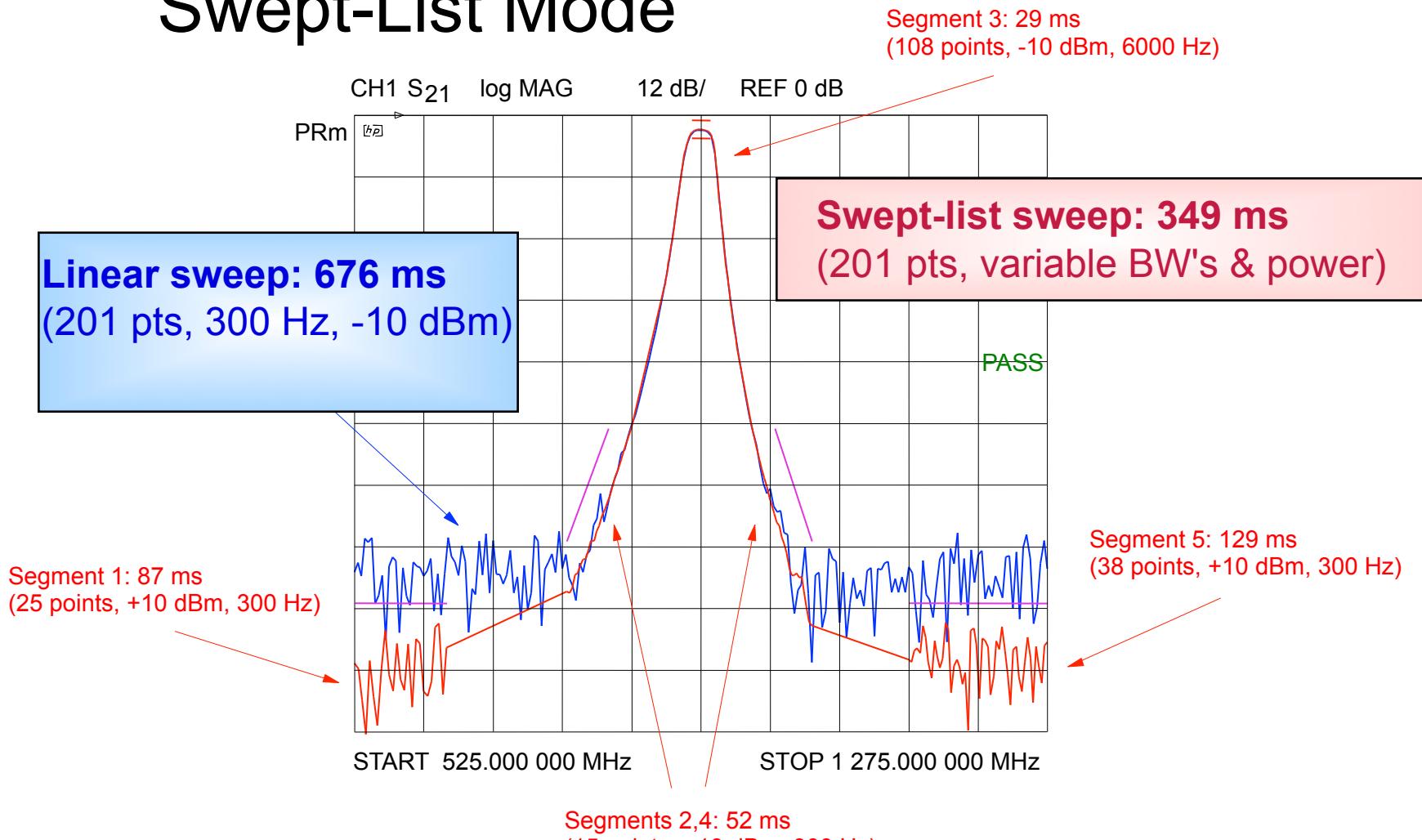
# Agenda



# Frequency Sweep - Filter Test



# Optimize Filter Measurements with Swept-List Mode



# Transfer function Schottky Signals Narrow Band

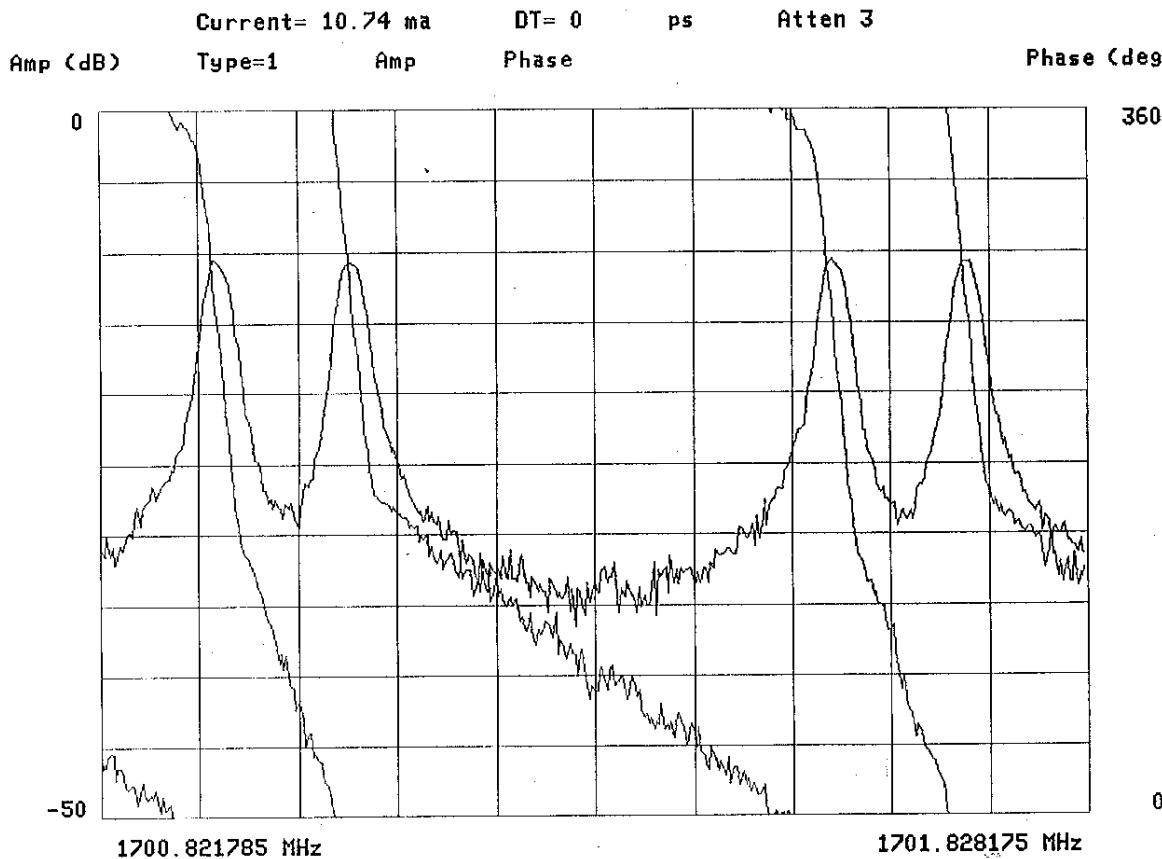
File number = 5  
Core 2-4 GHz Vert. NB H=2705

07/01/97 2149

Console Location 43,  
Network Analyzer Measurement

27-OCT-1998 10:42

14:56



# Transfer function Schottky Signals Wide Band

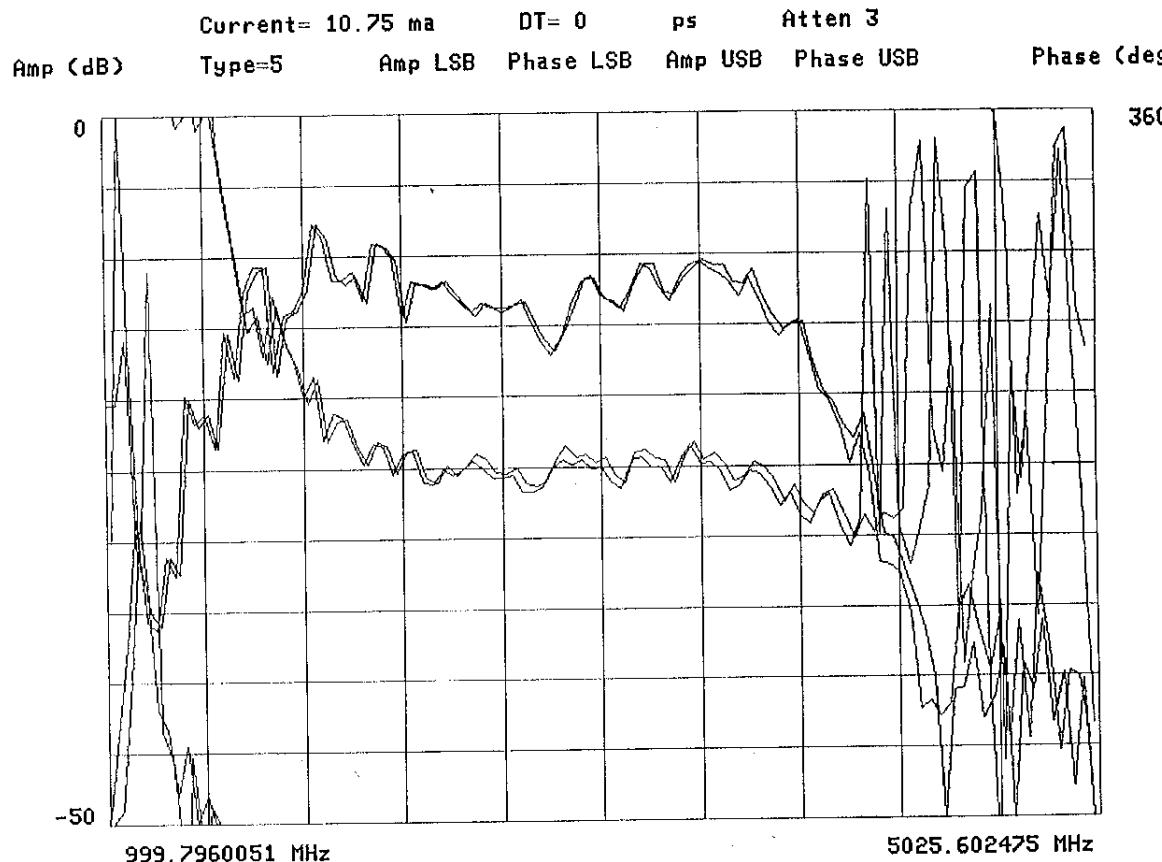
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Core 2-4 GHz Vert. WB ATTEN = 3

07/01/97 2117

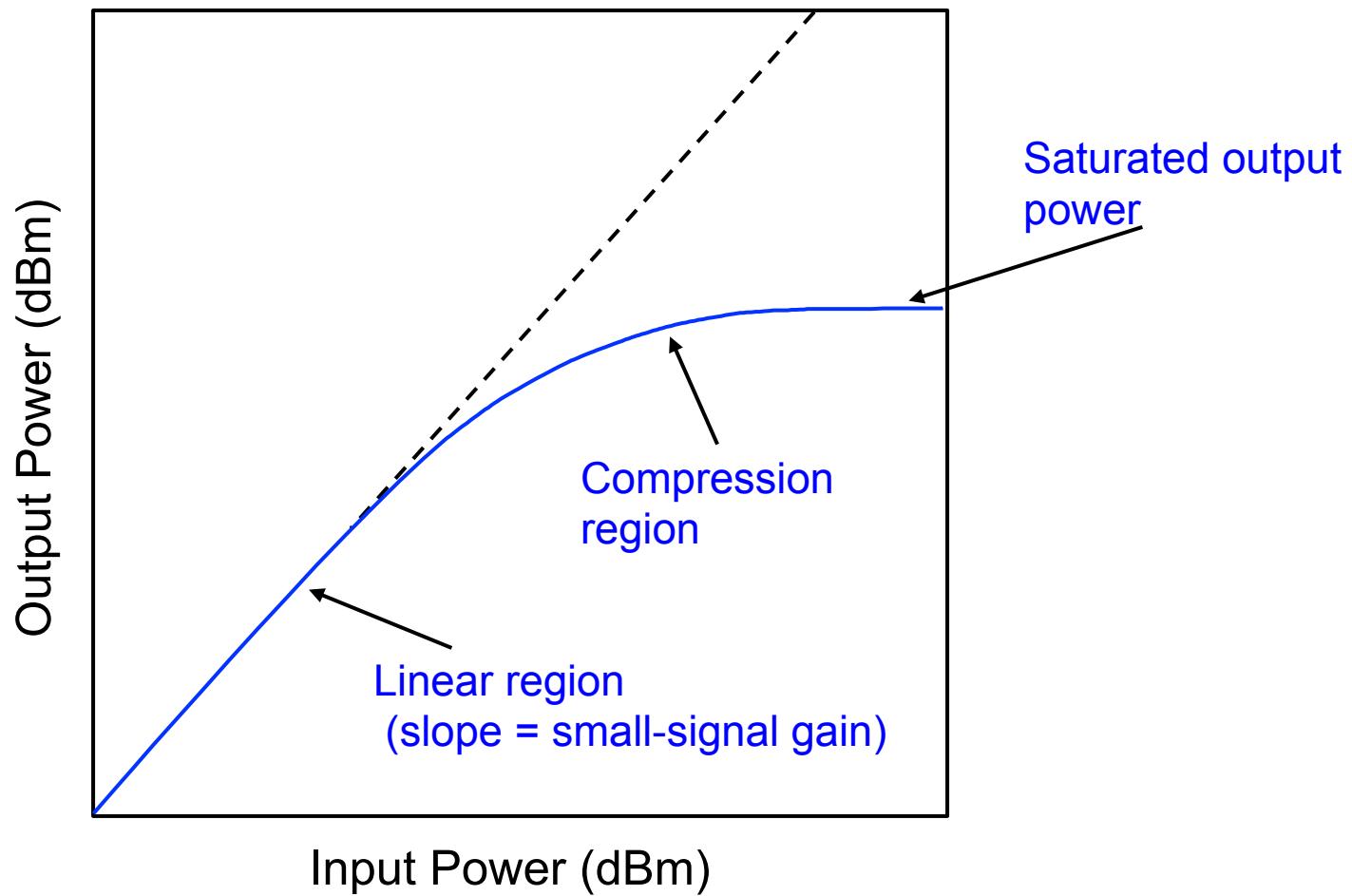
Console location 43,  
Network Analyzer Measurement

27-OCT-1998 10:42

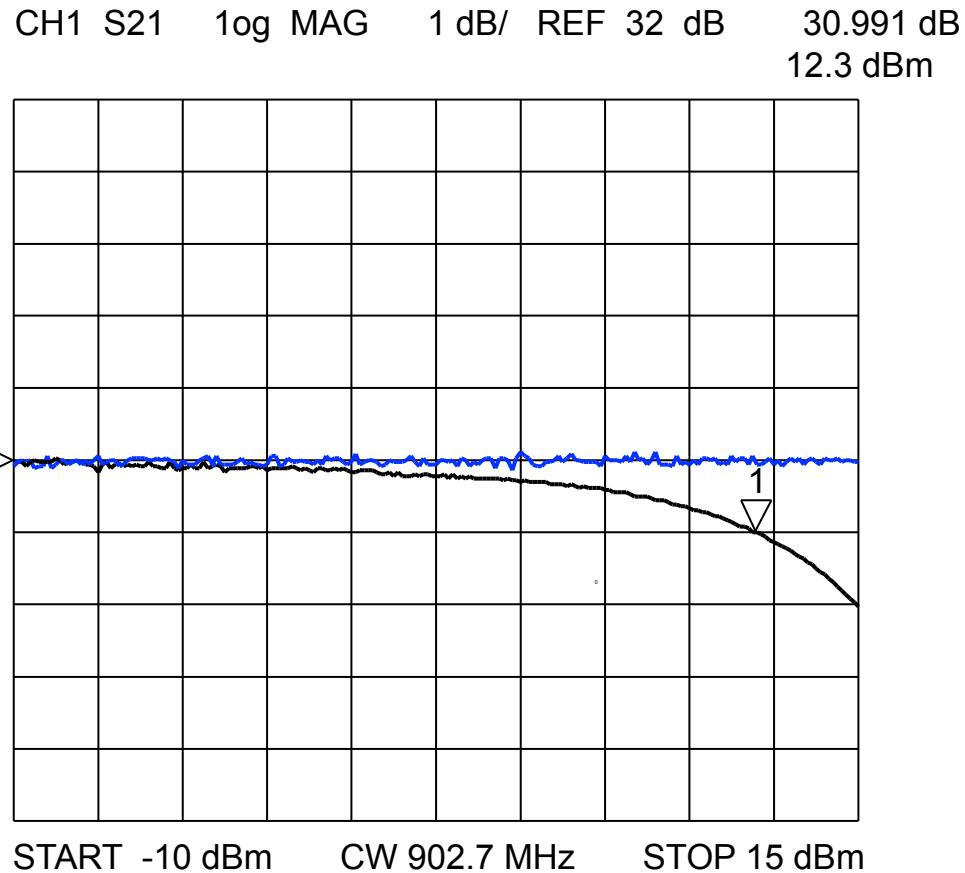
14.47



# Power Sweeps - Compression



# Power Sweep - Gain Compression

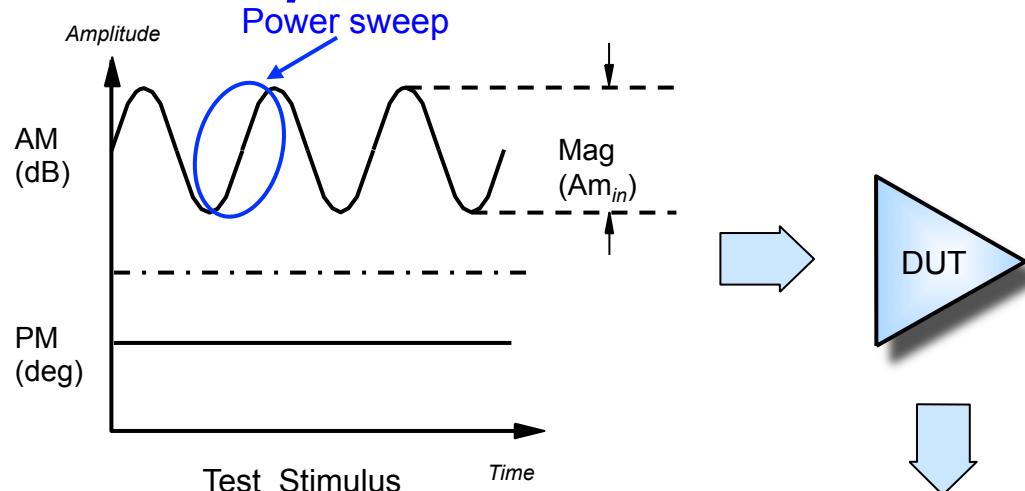


**1 dB  
compression:**  
input power  
resulting in 1 dB  
*drop in gain*

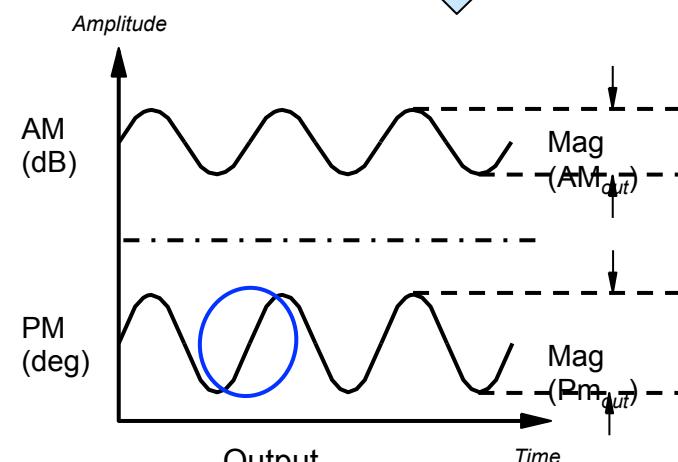


# AM to PM Conversion

*Measure of phase deviation caused by amplitude variations*



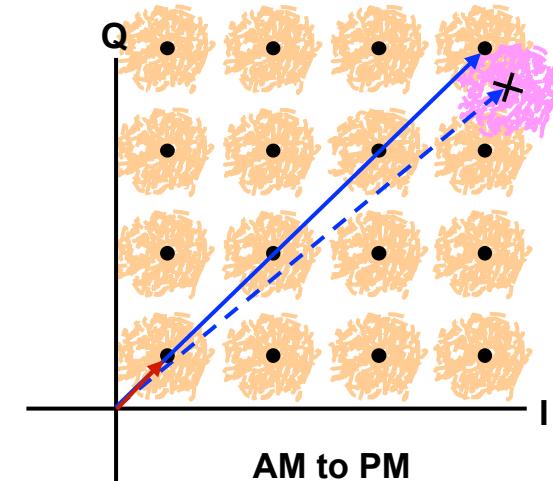
$$\text{AM - PM Conversion} = \frac{\text{Mag } (Pm_{out})}{\text{Mag } (Am_{in})} \text{ (deg/dB)}$$



Network Analyzer Basics



Agilent Technologies

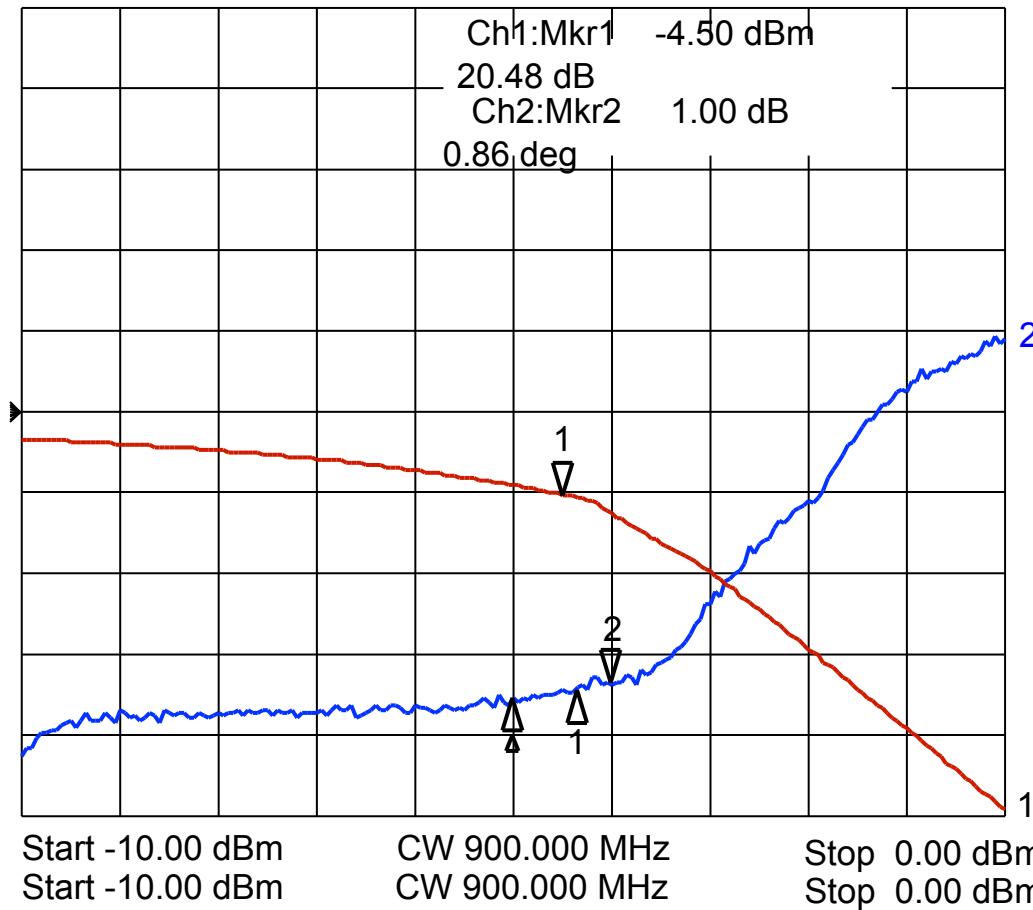


AM to PM  
conversion can  
cause bit errors

Copyright  
2000

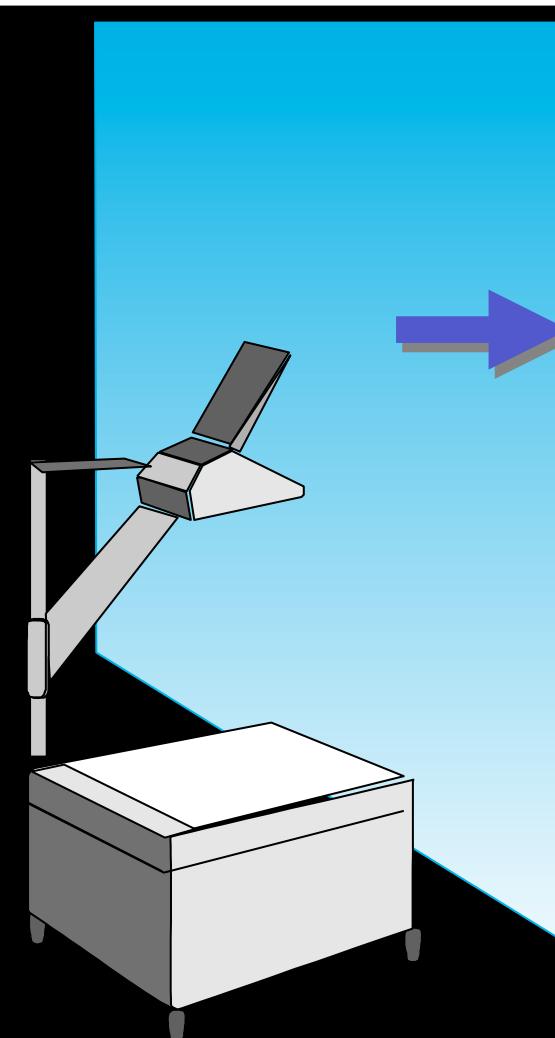
# Measuring AM to PM Conversion

▷ 1:Transmission Log Mag 1.0 dB/  
▷ 2:Transmission /M Phase 5.0 deg/ Ref 21.50 dB  
Ref -115.7 deg



- Use transmission setup with a power sweep
- Display phase of S21
- $\text{AM} - \text{PM} = 0.86 \text{ deg/dB}$

# Agenda

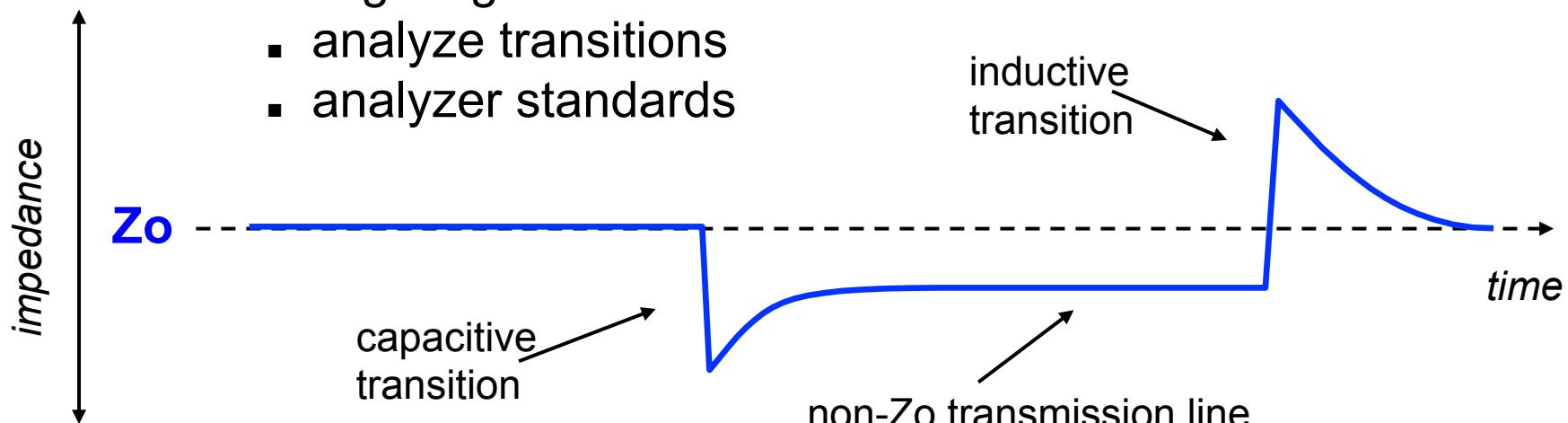


- What measurements do we make?
- Network analyzer hardware
- Error models and calibration
- Example measurements
- **Appendix**
  - Advanced Topics
    - time domain
    - frequency-translating devices
    - high-power amplifiers
    - extended dynamic range
    - multiport devices
    - in-fixture measurements
    - crystal resonators
    - balanced/differential
  - Inside the network analyzer
  - Challenge quiz!



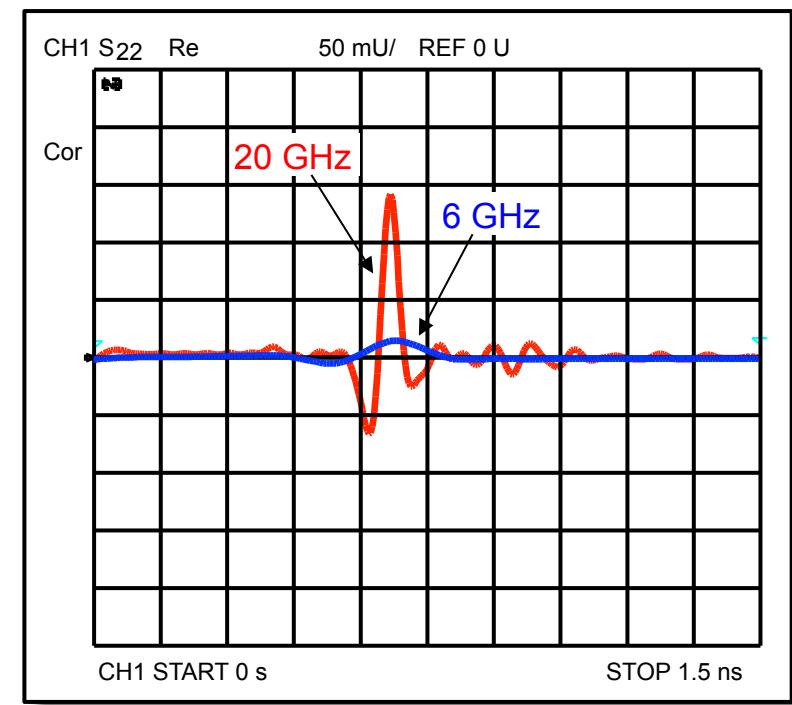
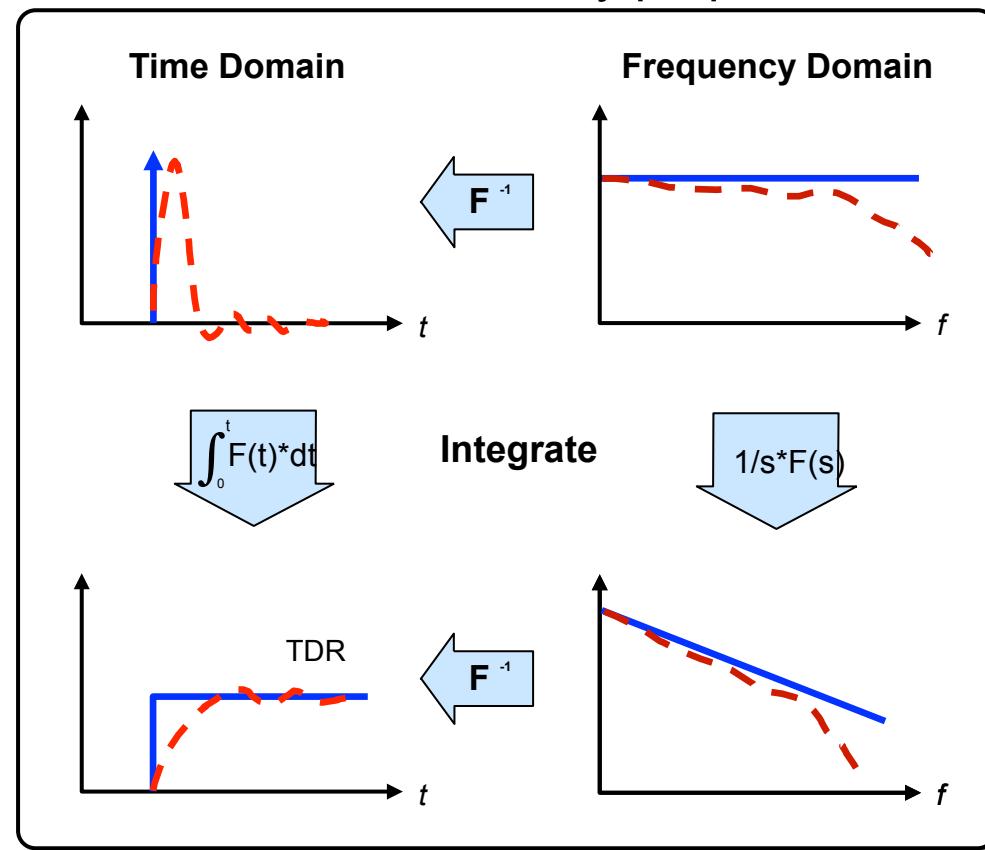
# Time-Domain Reflectometry (TDR)

- What is TDR?
  - time-domain reflectometry
  - analyze impedance versus time
  - distinguish between inductive and capacitive transitions
- With gating:
  - analyze transitions
  - analyzer standards



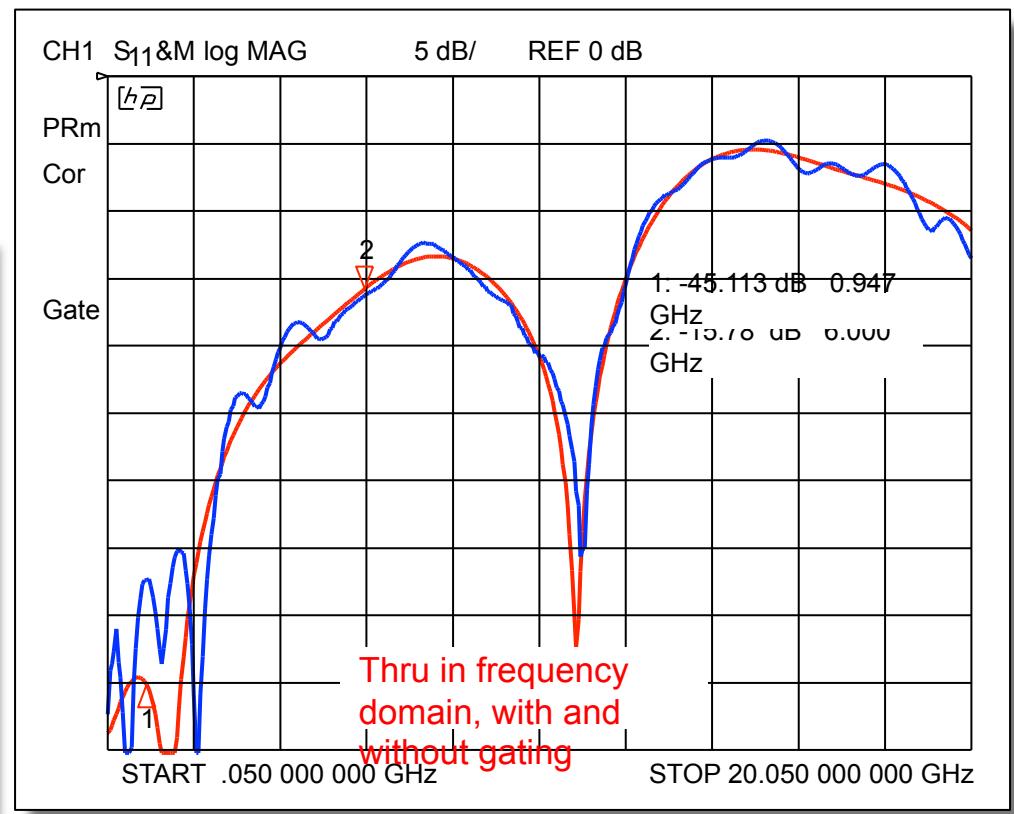
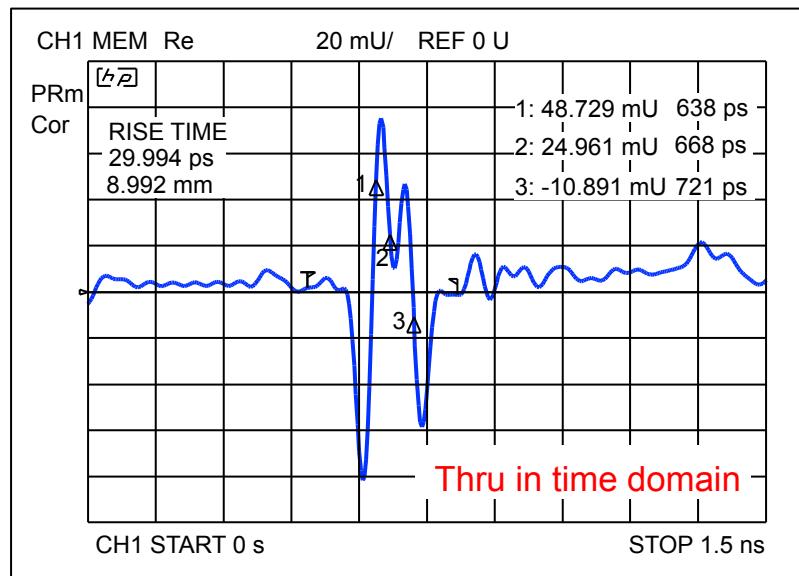
# TDR Basics Using a Network Analyzer

- start with broadband frequency sweep (often requires microwave VNA)
- use inverse-Fourier transform to compute time-domain
- resolution inversely proportionate to frequency span



# Time-Domain Gating

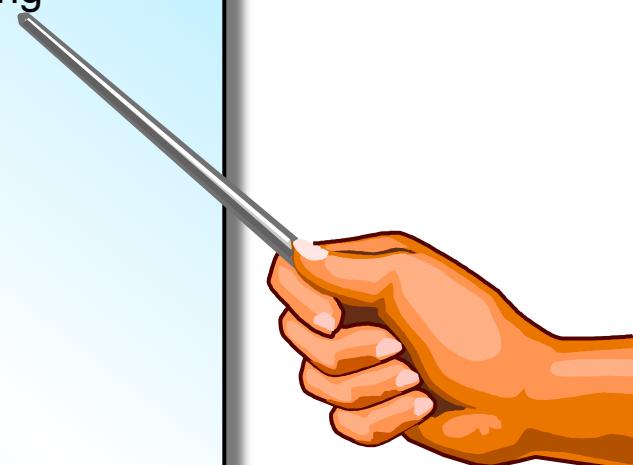
- TDR and gating can **remove** undesired reflections (a form of error correction)
- Only useful for **broadband** devices (a load or thru for example)
- Define **gate** to only include DUT
- Use two-port calibration



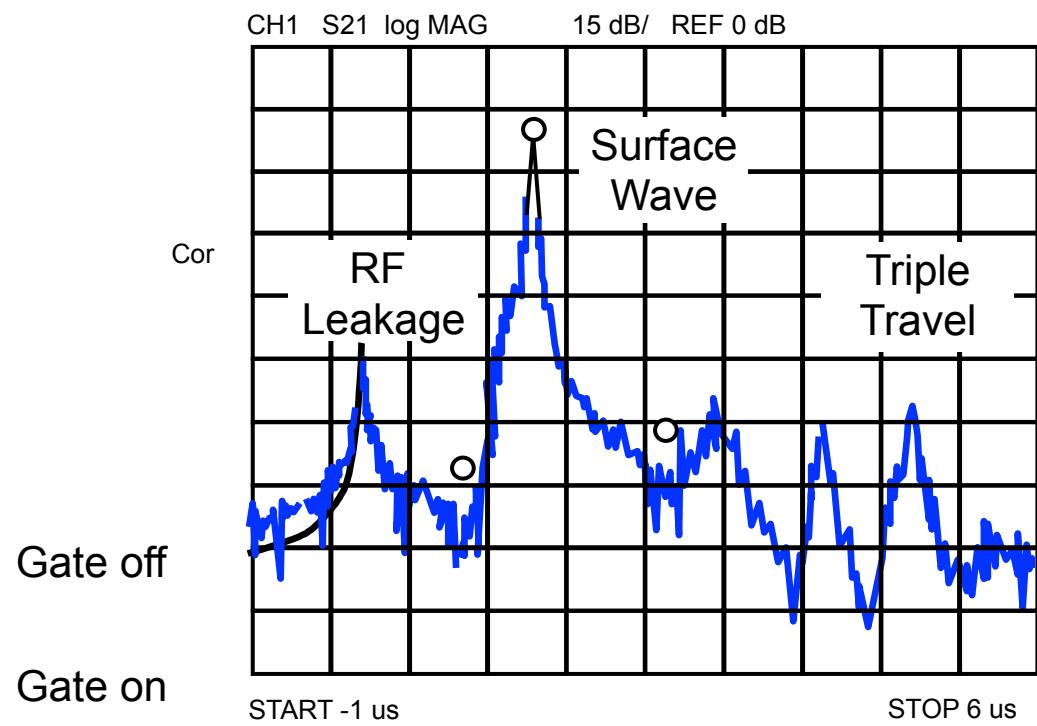
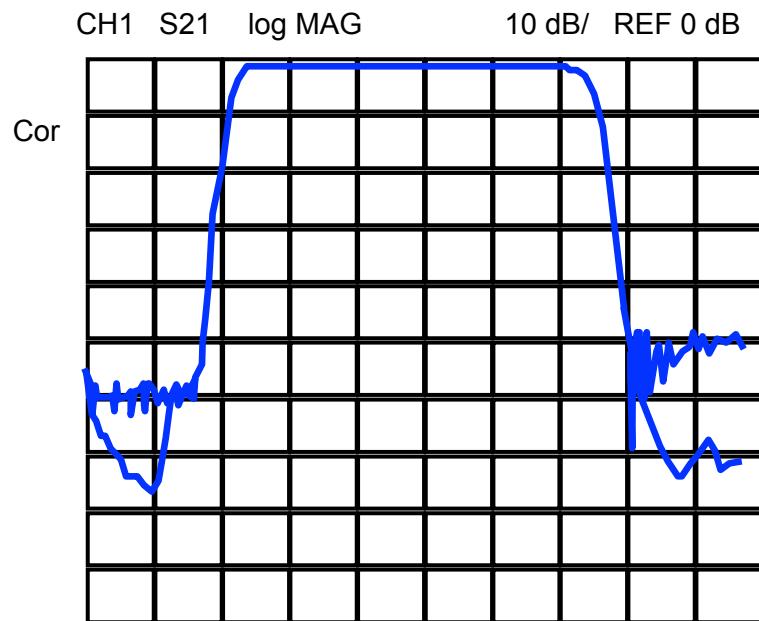
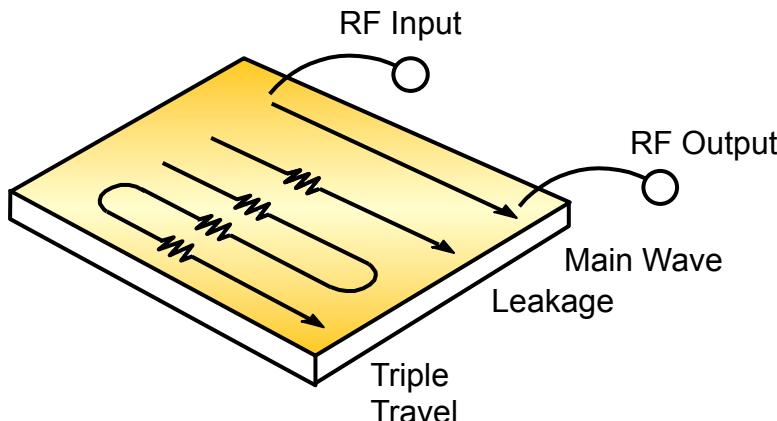
# Ten Steps for Performing TDR

1. Set up desired frequency range (need wide span for good spatial resolution)
2. Under SYSTEM, transform menu, press "set freq low pass"
3. Perform one- or two-port calibration
4. Select S11 measurement \*
5. Turn on transform (low pass step) \*
6. Set format to real \*
7. Adjust transform window to trade off rise time with ringing and overshoot \*
8. Adjust start and stop times if desired
9. For gating:
  - set start and stop frequencies for gate
  - turn gating on \*
  - adjust gate shape to trade off resolution with ripple \*
10. To display gated response in frequency domain
  - turn transform off (leave gating on) \*
  - change format to log-magnitude \*

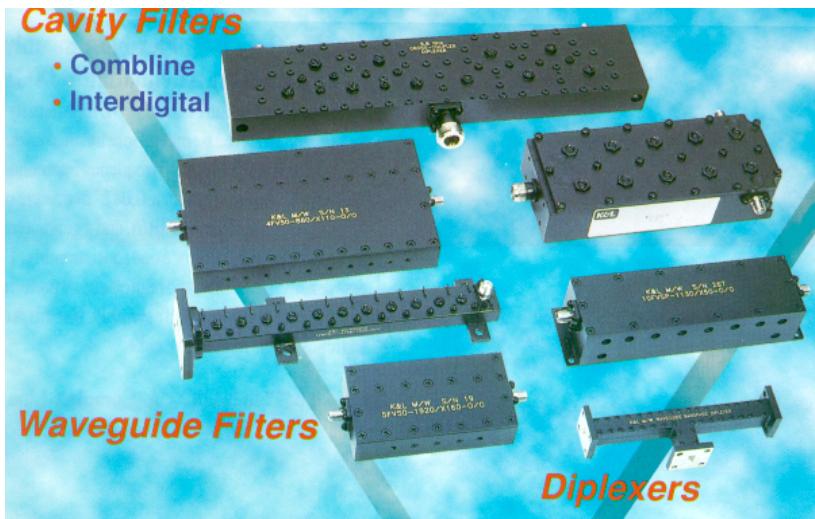
\* If using two channels (even if coupled), these parameters must be set independently for second channel



# Time-Domain Transmission

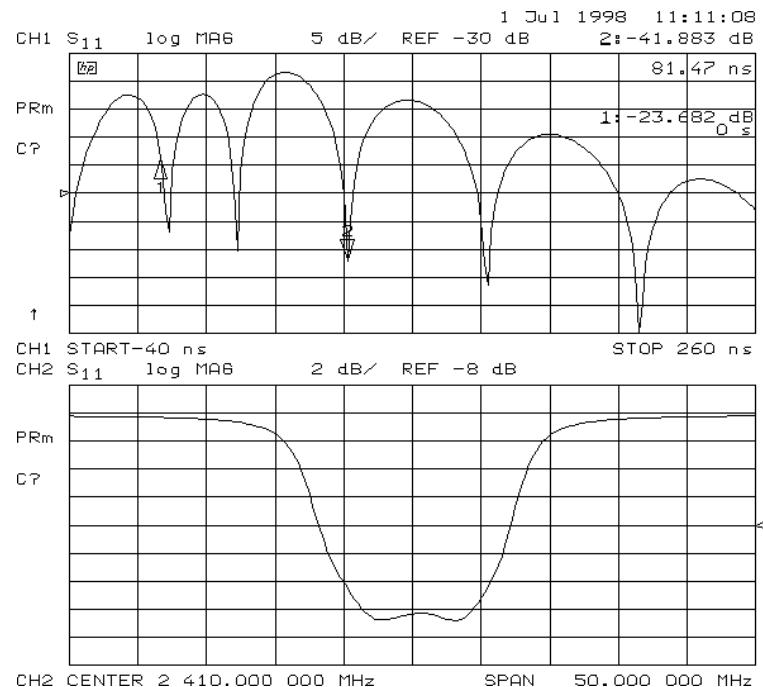


# Time-Domain Filter Tuning



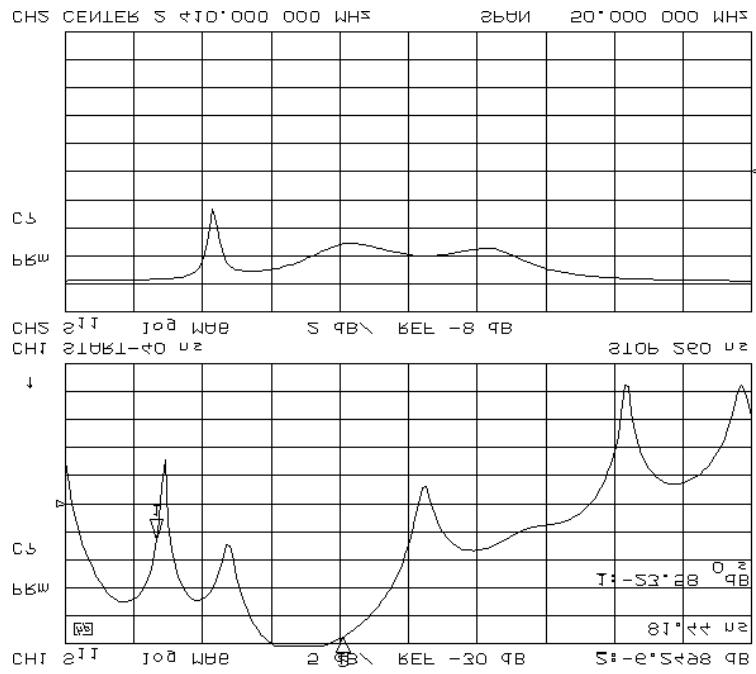
- Deterministic method used for tuning cavity-resonator filters
- Traditional frequency-domain tuning is very difficult:
  - lots of training needed
  - may take 20 to 90 minutes to tune a single filter
- Need VNA with fast sweep speeds and fast time-domain processing

# Filter Reflection in Time Domain



- Set analyzer's center frequency  
= center frequency of the filter
- Measure S<sub>11</sub> or S<sub>22</sub> in the time domain
- Nulls in the time-domain response correspond to individual resonators in filter

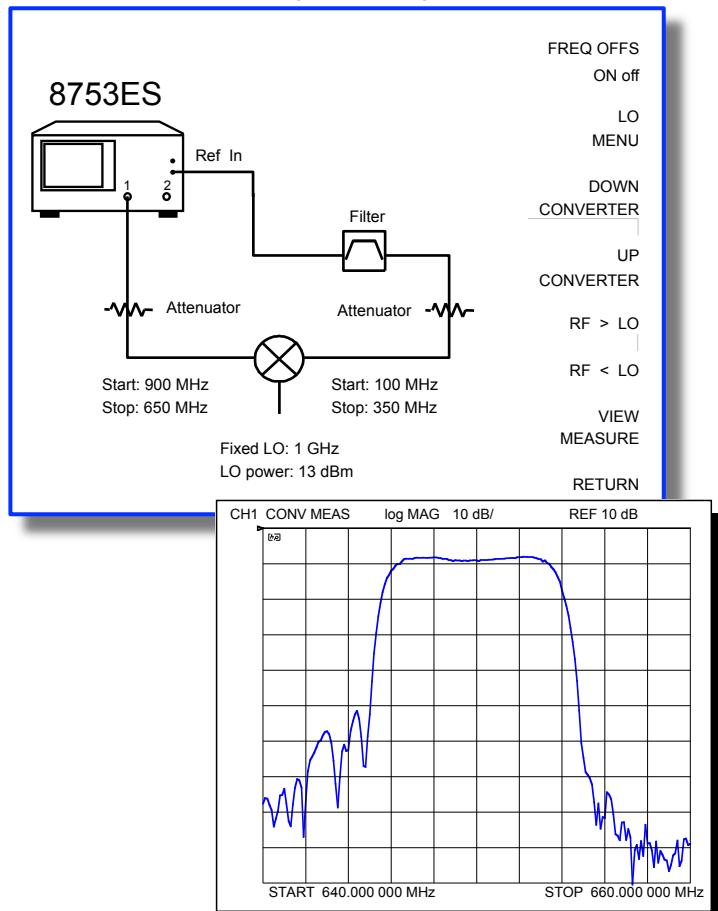
# Tuning Resonator #3



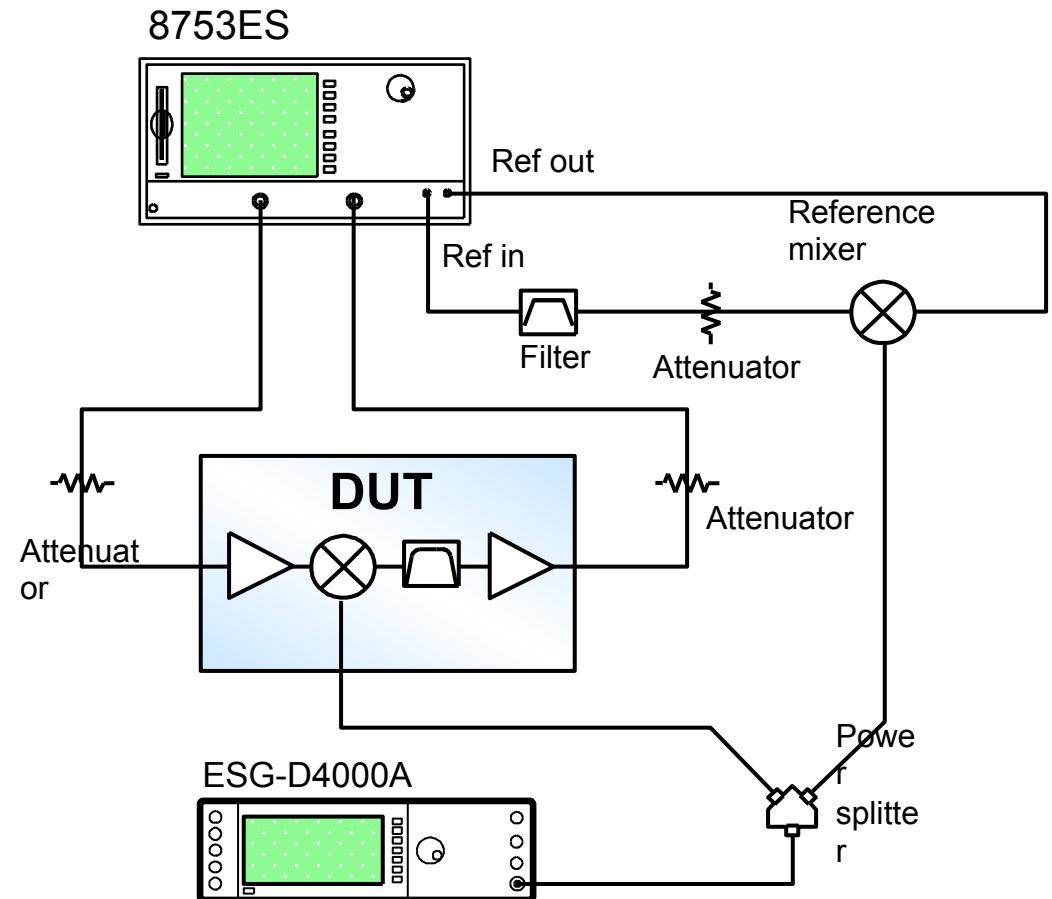
- Easier to identify mistuned resonator in time-domain: null #3 is missing
- Hard to tell which resonator is mistuned from frequency-domain response
- Adjust resonators by minimizing null
- Adjust coupling apertures using the peaks in-between the dips

# Frequency-Translating Devices

Medium-dynamic range  
measurements (35 dB)



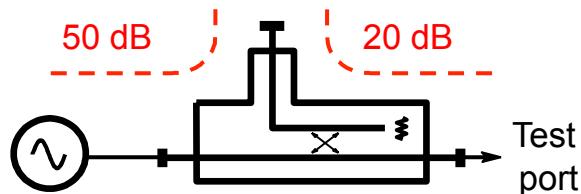
High-dynamic range measurements  
(100 dB)



# Directional Coupler *Directivity*

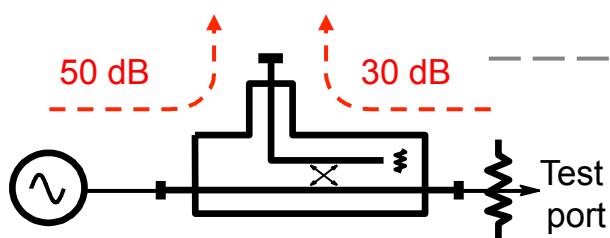
$$\text{Directivity} = \frac{\text{Coupling Factor (fwd)} \times \text{Loss (through arm)}}{\text{Isolation (rev)}}$$

$$\text{Directivity (dB)} = \text{Isolation (dB)} - \text{Coupling Factor (dB)} - \text{Loss (dB)}$$

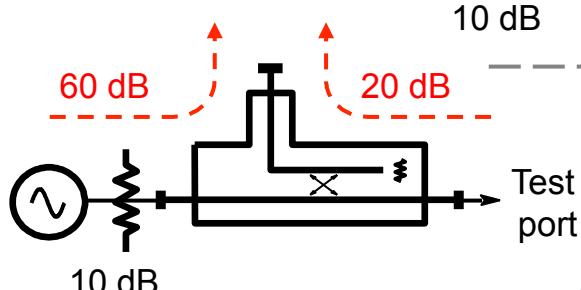


**Examples:**

$$\text{Directivity} = 50 \text{ dB} - 20 \text{ dB} = 30 \text{ dB}$$



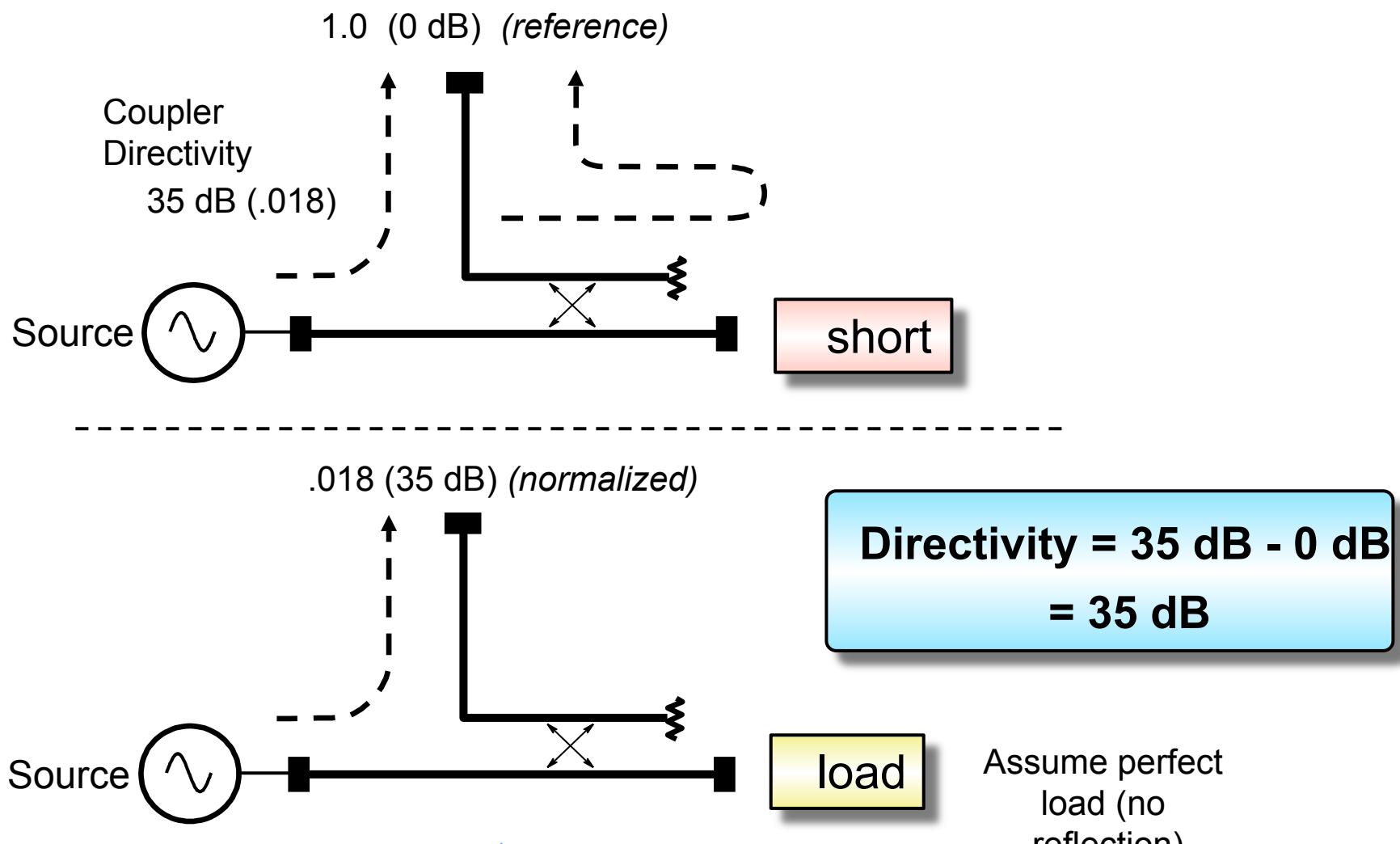
$$\text{Directivity} = 50 \text{ dB} - 30 \text{ dB} - 10 \text{ dB} = 10 \text{ dB}$$



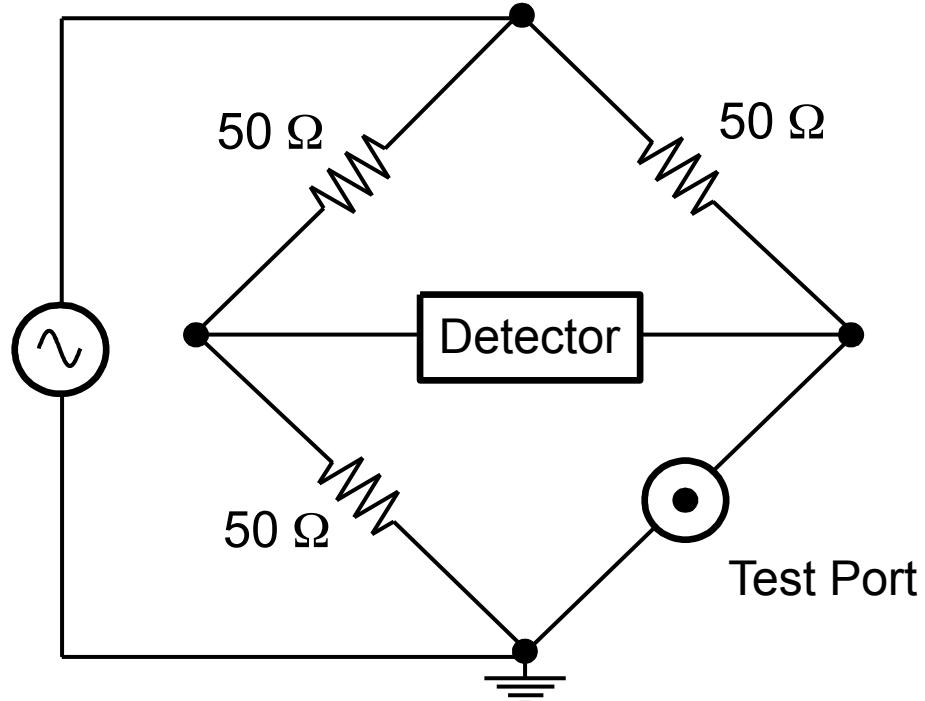
$$\text{Directivity} = 60 \text{ dB} - 20 \text{ dB} - 10 \text{ dB} = 30 \text{ dB}$$



# One Method of Measuring Coupler Directivity

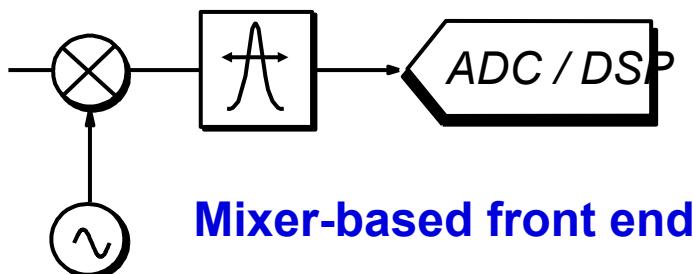
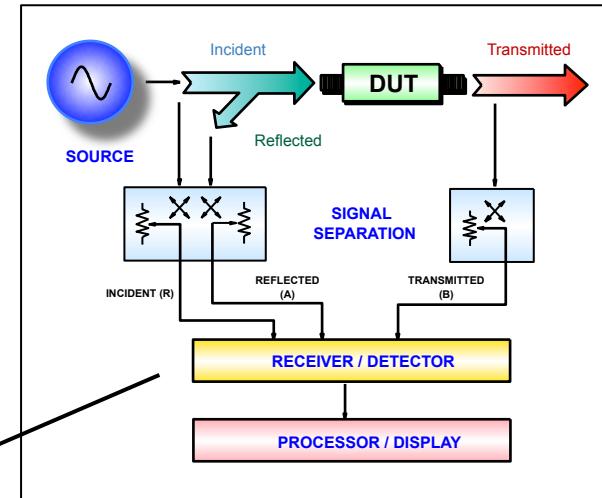


# Directional Bridge



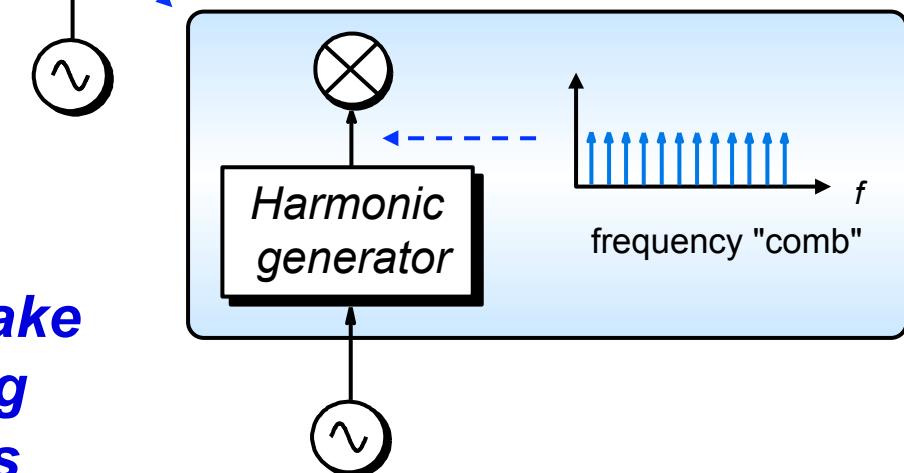
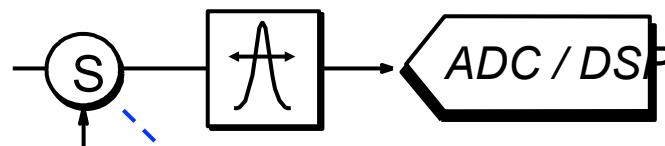
- 50-ohm load at test port balances the bridge -- detector reads zero
- Non-50-ohm load imbalances bridge
- Measuring magnitude and phase of imbalance gives complex impedance
- "Directivity" is difference between maximum and minimum balance

# NA Hardware: Front Ends, Mixers Versus Samplers



Mixer-based front end

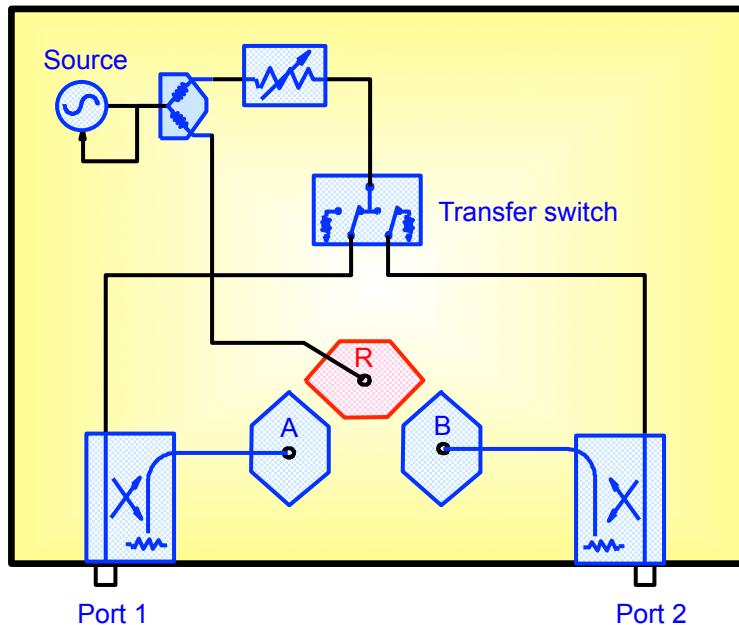
Sampler-based front end



*It is cheaper and easier to make broadband front ends using samplers instead of mixers*

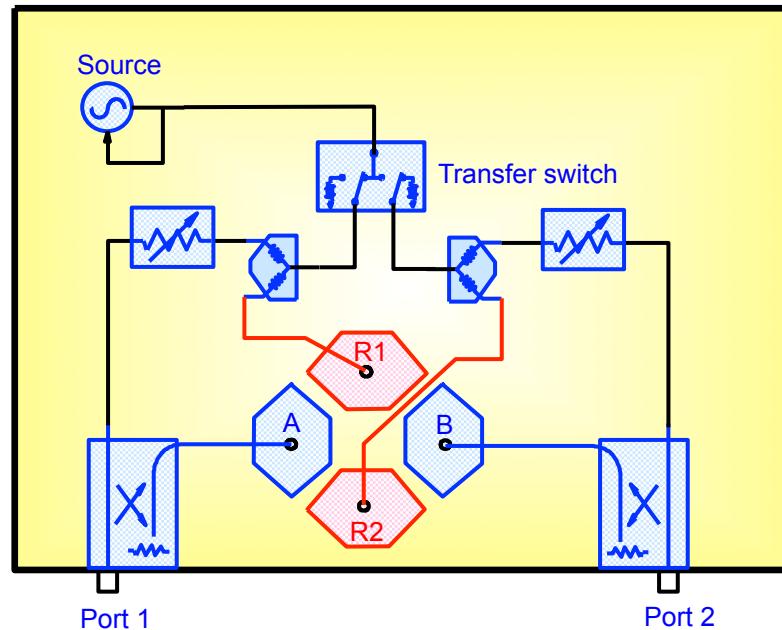


# Three Versus Four-Receiver Analyzers



## 3 receivers

- more economical
- TRL\*, LRM\* cals only
- includes:
  - 8753ES
  - 8720ES (standard)

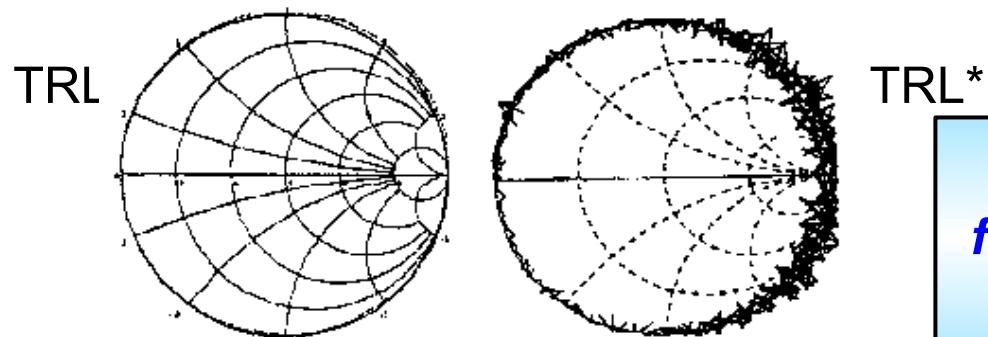


## 4 receivers

- more expensive
- true TRL, LRM cals
- includes:
  - 8720ES (option 400)
  - 8510C



# Why Are Four Receivers Better Than Three?



**8720ES Option 400 adds  
fourth sampler, allowing full  
TRL calibration**

- **TRL\***
  - assumes the **source and load match** of a test port are **equal** (port symmetry between forward and reverse measurements)
    - this is only a fair assumption for three-receiver network analyzers
- **TRL**
  - four receivers are necessary to make the required measurements
    - TRL and TRL\* use identical calibration standards
- **In noncoaxial applications**, TRL achieves **better source and load match correction** than TRL\*
- **What about coaxial applications?**
  - **SOLT is usually the preferred calibration method**
  - coaxial TRL can be more accurate than SOLT, but not commonly used



# Challenge Quiz

**1. Can filters cause distortion in communications systems?**

- A. Yes, due to impairment of phase and magnitude response
- B. Yes, due to nonlinear components such as ferrite inductors
- C. No, only active devices can cause distortion
- D. No, filters only cause linear phase shifts
- E. Both A and B above

**2. Which statement about transmission lines is false?**

- A. Useful for efficient transmission of RF power
- B. Requires termination in characteristic impedance for low VSWR
- C. Envelope voltage of RF signal is independent of position along line
- D. Used when wavelength of signal is small compared to length of line
- E. Can be realized in a variety of forms such as coaxial, waveguide, microstrip

**3. Which statement about narrowband detection is false?**

- A. Is generally the cheapest way to detect microwave signals
- B. Provides much greater dynamic range than diode detection
- C. Uses variable-bandwidth IF filters to set analyzer noise floor
- D. Provides rejection of harmonic and spurious signals
- E. Uses mixers or samplers as downconverters



# Challenge Quiz (continued)

- 4. Maximum dynamic range with narrowband detection is defined as:**
- A. Maximum receiver input power minus the stopband of the device under test
  - B. Maximum receiver input power minus the receiver's noise floor
  - C. Detector 1-dB-compression point minus the harmonic level of the source
  - D. Receiver damage level plus the maximum source output power
  - E. Maximum source output power minus the receiver's noise floor
- 5. With a T/R analyzer, the following error terms can be corrected:**
- A. Source match, load match, transmission tracking
  - B. Load match, reflection tracking, transmission tracking
  - C. Source match, reflection tracking, transmission tracking
  - D. Directivity, source match, load match
  - E. Directivity, reflection tracking, load match
- 6. Calibration(s) can remove which of the following types of measurement error?**
- A. Systematic and drift
  - B. Systematic and random
  - C. Random and drift
  - D. Repeatability and systematic
  - E. Repeatability and drift



# Challenge Quiz (continued)

**7. Which statement about TRL calibration is false?**

- A. Is a type of two-port error correction
- B. Uses easily fabricated and characterized standards
- C. Most commonly used in noncoaxial environments
- D. Is not available on the 8720ES family of microwave network analyzers
- E. Has a special version for three-sampler network analyzers

**8. For which component is it hardest to get accurate transmission and reflection measurements when using a T/R network analyzer?**

- A. Amplifiers because output power causes receiver compression
- B. Cables because load match cannot be corrected
- C. Filter stopbands because of lack of dynamic range
- D. Mixers because of lack of broadband detectors
- E. Attenuators because source match cannot be corrected

**9. Power sweeps are good for which measurements?**

- A. Gain compression
- B. AM to PM conversion
- C. Saturated output power
- D. Power linearity
- E. All of the above



# Answers to Challenge Quiz

1. E
2. C
3. A
4. B
5. C
6. A
7. D
8. B
9. E

